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IMPULSE BREAKDOWN CHARACTERISTICS FOR ROD-PLANE GAPS IN MIXTURES OF SULPHUR HEXAFLUORIDE AND NITROGEN.

by Angelo Yializis

A Dissertation

Submitted to the Faculty of Graduate Studies through the Department of Electrical Engineering in Partial Fulfillment of the Requirements for the Degree of Doctor of Philosophy at the University of Windsor

Windsor, Ontario, Canada 1978

C). ** Angelo Yializis

ABSTRACT

Experimental results on negative and positive impulse breakdown characteristics of rod-plane gaps in $\widehat{SF_6}$, N_2 and $\widehat{SF_6}/N_2$ mixtures are presented, together with theoretical computations of streamer onset voltages in these gases.

The experimental results show that in positive rod-plane gaps, the impulse breakdown voltage of nitrogen increases approximately by a factor of two, with the addition of 0.1% to 0.2% SF6 at a total pressure of about 2 bar. Also, at a total pressure of 1 bar the breakdown voltage of SF6/N2 mixtures with 80% SF6 rises 30% above that of SF6. An attempt is made to explain this anomalous breakdown behaviour on the basis of the breakdown voltage measurements, and temporal and spatial information on the growth of ionization provided by photomultiplier and still photography results.

In the streamer onset calculations a new method was developed for the computation of electric fields, based on application of optimization techniques to the charge simulation method. The potential distribution of a rod-plane gap is obtained; and consideration is given to the solution of field configurations with non-axial symmetry. The new optimized approach proves to be more efficient, minimizing the time required to set up and implement a problem of this kind.

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CHAPTER 1

INTRODUCTION

recent years sulphur hexafluoride (SF6) has found a number of applications as a dielectric insulating medium in a variety of high voltage apparatus. The high increase in power demand together with problems of land availability due to economical and environmental factors have recently accelerated research and development on gas insulated cables. SF6 for example, has a number of advantages over more conventional oil or solid insulation systems. These advantages include good voltage insulation, high current capacity due to low charging current, low dielectric losses and superior cooling capacity. re-evaluation of some of its insulating properties show that the dielectric strength of SF₆, unlike that of air, is highly sensitive to strong local fields which might be present in the cable due to dirt or metallic particles (1,2). In addition, a number of other limitations are also introduced due to the liquefaction of SFG at low temperatures.

These problems have recently provided a strong incentive for the study of mixtures of SF₆ and other gases such as Hydrogen, Nitrogen, Helium and Air (3-6). The use of a mixture of SF₆ and a cheap inert gas would eliminate some of the problems and also reduce the cost, provided that the electric strength and other properties of the mixture are not inferior to those of the individual constituents.

The investigation undertaken by the author, had as an objective, the study of the deelectric behaviour of mixtures of sulfur hexaflouride and Nitrogen (SF_6/N_2) under certain controlled conditions. These conditions are designed to represent part of a more realistic system, so that quantitative data produced can be of use to future studies and related applications.

A literature survey on the subject indicated that very little was known about the properties of SF_6 / N_2 mixtures in non-uniform fields subjected to impulse voltages. An experiment was then designed where the effect of a number of variables such as total pressure, ratio of the partial pressures of the two gases and gap length of a rod-plane gap were studied under the application of standard impulse voltages. The hemispherically capped rod-plane geometry provides excellent conditions for the study of the effect of non-uniformities in gas insulated systems. Most observations leading to the knowledge of such mechanisms as burst pulses, Trichel pulses and streamers, have been conducted in rod-plane gaps, because they provide localization of ionization (which improves observation), minimum interference of the plane electrode, convenience of fabrication and accuracy of adjustment.

The experimental investigation was mainly directed towards understanding the impulse breakdown behaviour of the SF $_6/N_2$ mixtures. Impulse breakdown measurements of both polarities were conducted for SF $_6$, N_2 and various mixtures of the two gases containing 0.01% to 100.0% SF $_6$, over a pressure range extending from 300 torr to 5 bar, and gap lengths ranging from 5 to 50 mm (52).

Previous work conducted in this laboratory (7,8) involved experimental studies of DC and Impulse breakdown of SF6 . and methods of determining the field distribution and corona onset This work, led to a good understanding of in rod-plane gaps. corona onset computations in SF6 and simultaneously indicated the need of a simpler and more efficient method for calculation As a result of this, of field distributions in rod-plane gaps. along with the experimental work in SF_6/N_2 mixtures, the author undertook the task of developing or utilizing a more efficient method for the calculation of the field distribution in a rod-This involved the development of an improved techplane gap. nique (53) for the calculation of electrostatic fields and súb sequent application to the rod-plane geometry for computation of corona onset and breakdown voltage in SF_6 and SF_6/N_2 mixtures.

CHAPTER ~2

IONIZATION AND BREAKDOWN MECHANISMS IN N_2 , SF_6 AND SF_6/N_2 MIXTURES.

2.1 Introduction

In this chapter a brief discussion of the mechanisms of ionization and breakdown will be presented for SF_6 , N_2 and SF_6 , N_2 mixtures. The purpose of this is to familiarize the reader with previous work in this area, and so, facilitate the comprehension of conclusions and mechanisms presented in later chapters relating to the present investigations.

The discussion of breakdown phenomena in SF_6 and N_2 is kept short due to the availability of several review publications and previous work conducted in this laboratory (7,9). However, due to the lack of substantial information regarding the ionization processes in SF_6/N_2 mixtures, reference is made to some work involving breakdown of N_2 contaminated by small traces of O_2 . The N_2/O_2 ionization phenomena have been studied extensively over the years and one can benefit by correlating them with results from SF_6/N_2 mixtures, which exhibit a certain degree of similarity due to the electronegative nature of O_2 and SF_6 .

Information on ionization and attachment coefficients is presented together with reactions leading to the formation of positive and negative ions in the two gases. The significance of these ions is discussed with reference to their effect in avalanche formation and spark onset.

2.2 Ionization phenomena in N2.

In uniform field distributions the voltage-current characteristics of N_2 follow Townsend's self-sustained discharge mechanism (10). The breakdown is a natural development of the prebreakdown ionization currents where the current I is given by

$$I = \frac{I_0 \exp(\alpha d)}{1 - \chi(\exp(\alpha d) - 1)} \qquad (2.1)$$

where \propto = ionization coefficient

 δ = photo-ionization coefficient

d = gap length

$$\frac{\propto}{p} = A \exp(-Bp/E.) \qquad (2.2)$$

where p = pressure

E = applied field

 $A = 5320 \text{ cm}^{-1} \text{ bar}^{-1}$

 $B = 208 \text{ KV cm}^{-1} \text{ bar}^{-1}$

Ionization of N_2 results in the formation of the N_2^+ ion via the reaction: $N_2^+ = -N_2^+ + 2e$. The ground state of N_2^+ has an appearance potential of 15.6 ev (13). A number of other positive ions such as N_3^+ , N_4^+ , and N^+ can be present in the discharge and concentrations will vary with experimental conditions. The most common of these is the N_4^+ produced by the reaction: $N_2^+ + N_2^- \longrightarrow (N_4^+)^* \longrightarrow N_4^+ + 0.5$ ev.

The concentration of N_{\perp}^{\dagger} varies with E/p and it prevails over N_{2}^{\dagger} at low E/p and higher pressures (14). The 0.5 ev energy is given out in the form of photon emission. The N_{2} molecule has a number of metastable and active states which can complicate the breakdown mechanism of SF₆/ N_{2} mixtures in non-uniform fields.

The mechanism of breakdown of N_2 in non-uniform field distributions will depend on the electrode geometry, polarity, and gas composition. The latter factor is very important due to the sensitivity of ionization phenomena in N_2 contaminated with other gas impurities.

Weissler (15) investigated the mechanism of breakdown of pure N_2 in a point-plane electrode arrangement under DC voltages. He reported that in the positive point-plane, unlike air where one observes a corona glow spread uniformly over the point, the corona in N_2 seemed to be a succession of electron avalanches that formed at the tip of the point in a form of a localized spot. As voltage increases the corona becomes a luminous glow that extends to the cathode region. At higher voltage corona streamers appeared superimposed on the continous glow and breakdown was initiated with further voltage increase, when the streamers reached a critical number and intensity.

Under negative point-plane conditions corona onset occured at a lower voltage than the positive corona and again it appeared to be concentrated at the front of the spherical tip. At higher voltages a glow discharge was observed with

Crooke's and Faraday's dark spaces, negative glow and positive column. Further increase of the voltage resulted in a constriction of the glow, sudden increase in the current and transition to breakdown.

Weissler's results showed that no Trichel pulses or other irregularities were observed due to the chemical purity of the nitrogen. The addition of small ammounts of 0_2 into pure N_2 (0.1%) resulted in the generation of Trichel pulses(15). The choking effect of the space charge associated with these pulses caused a decrease in the corona current to about one-half of its magnitude in pure N_2 . Similarly, in positive-plane corona, addition of less than 0.1% of 0_2 into pure N_2 produced heavy corona streamers and burst pulses, but the magnitude of the corona current remained the same. The presence of 0_2 also helped to spread the corona glow over the tip of the point by increasing the efficiency of photoionization (15).

A number of investigations have been conducted in N_2 containing small traces of O_2 (0.1-1.0%)(16). Secondary electron coefficients have been calculated for a number of different electrode materials, in order to determine the origin of anomalous breakdown phenomena occurring in the mixture of the two gases. In contrast, very little data is available on the ionization parameters of SF_6/N_2 mixtures and this is expected to make difficult the interpretation of the experimental results.

2.3 Ionization and Breakdown Mechanisms in SF6.

Among many electronegative gases having high dielectric strength, SF₆ has the most favourable properties that qualify it for high voltage insulation. Some of these properties are: chemically inert, non-flammable, incombustible, non-toxic and good heat conductor.

Experimental investigations in non-uniform fields have shown that the positive voltage-pressure characteristics exhibit a pronounced maximum at a pressure $p_{ ext{max}}$ in the range of 1 to 3 bar, depending on the electrode configuration. At a pressure P_{min} (slightly higher than P_{max}) the breakdown voltage drops suddenly to a considerably lower level and then it increases again as the pressure increases (17). The most widely accepted explanation to date for the mechanism of breakdown in the region prior to p_{min} (known as the corona stabilised region), is given by Foord (18). and later supported by Works and Dakin (19) and Howard (55). In the corona stabilized region, streamer onsit is observed to occur at a voltage considerably lower than spark onset. The corona streamers are generated in the high field region close to the anode and move towards the cathode leaving behind them a positive space charge. With the help of photoionization the positive charge spreads around the tip of the anode, producing in this manner a positive charge sheath which chokes further growth of The spark initiates when the avalanche activity ionization. in the cathode region is producing negative ions at a rate sufficiently high to neutralize the positive charge, allowing streamers to reach the cathode. As the pressure increases, photon

absorption of SF₆ also increases reducing photoionization in the anode area and thus weakening the positive sheath. This brings the breakdown voltage closer to corona onset and above p_{\min} , spark onset and corona onset occur at the same voltage level.

In general, the high dielectric strength of SF6 is the result of the electronegative character of the gas. That is, its electrophylic nature promotes the formation of negative ions by the capture of free electrons, before the electron energies become high enough to produce ionization.

Experimental data shows that the electron attachment in SF_6 leads to the formation of a number of negative ions, with SF_6 and SF_5 as the principal species (21 - 24). SF_6 and SF_5 are produced by the following resonance capture reactions of near-zero-energy electrons.

$$SF_6 + e \longrightarrow (SF_6^-)^*$$
 (1)

$$(SF_6^-)^* + SF_6 \longrightarrow SF_6 + SF_6^-$$
 (2)

$$(sF_6^-)^* \longrightarrow sF_5^- + F \tag{3}$$

Reaction (1) requires electrons with energy of less than 0.1ex and the width of the peak of the resonance is approximately 0.05 ev. $(SF_6^-)^*$ is a vibrationally excited ion which can stabilize through reaction (2), or with any other background gas. Once stabilized, the life time of SF_6^- against autodetachment has been found to be of the order of tens of microseconds (25,27).

Reaction (3) is the result of a dissociative attachment process that can occur before the $(SF_6^-)^*$ stabilizes. The activation energy for the production of SF_5^- has been found to be 0.43ev by some authors (25) or less than 0.1ev by others (21). The most abundant of the ions is the SF_6^- (28.30). However, it was been shown that the relative concentrations of SF_6^- and SF_5^- vary with E/p (79). High concentrations of SF_6^- occur at: $E/p < 60 \, \text{Vcm}^{-1}$ torr⁻¹ and of SF_5^- at: $E/p > 80 \, \text{vcm}^{-1}$ torr⁻¹.

In the positive ion spectrum of SF_6 , SF_5^+ is the most dominant ion. Dibler and Mohler found the first appearance potential of SF_5^+ to be $15.9\pm$ 0.2ev (31). This value is in agreement with the results of Ta-Kong Liu et-al (32) who measured the absorption spectrum of SF_6 in the vacuum ultraviolet region, and found a strong continous absorption beginning fairly sharply at $802A^0$ (15.5ev), and continuing to shorter wavelengths. The reaction involved, is a secondary capture process followed by dissociation.

$$SF_6 + e - (SF_6^+)^* + 2e$$
 (4)

$$(SF_6^+)^* + 2e \longrightarrow SF_5^+ + F + 2e$$
 (5)

$$SF_6 + e - (SF_6)^* + e$$
 (6)

$$(SF_6)^* + : e \longrightarrow SF_5^+ + F_1^- + e$$
 (7)

This suggests that the ionization potential of SF $_6$ lies higher that the dissociation energy of SF $_6$ into SF $_5^+$ and F $^-$.

The appearance of the SF_5^+ indicates the beginning of ionization in the gas, which will be governed by the values of the ionization and attachment coefficients (α and α respectively). Both of these coefficients are a function of the field strength E and

the pressure p. Geballe and Harrison (30) and Bhalla and Graggs (31) have measured α/p and η/p as functions of E/p, and $(\alpha-n)/p$ can be approximated by the linear relation

$$(\alpha - \eta)/p = C(E/p - (E/p)_{cr})$$
 (2.4)

where $C = 27 \text{ KV cm}^{-1}$

$$(E/p)_{cr} = 89 \text{ KV cm}^{-1} \text{ bar}^{-1}$$

Ionization by electron collision will therefore take place in the gap region where the ionization coefficient is equal or greater than the attachment coefficient.

2.4. Ionization and Breakdown Phenomena in SF_6/N_2 Mixtures.

was that of Foord (32). Using a positive point to plane gap under DC voltages Foord observed that the addition of nitrogen to SF₆ increased the corona current in a manner proportional to the partial pressure of nitrogen. In addition, by keeping the partial pressure of SF₆ constant and varying the total pressure, it was shown that the voltage-pressure characteristics of the mixtures exhibited a negative slope similar to that of pure SF₆. The overall indication was that the addition of nitrogen in SF₆ reduced the dielectric strength of the mixture and a speculative explanation referred to a probable reduction, or modification of the relative importance of the negative ion-forming mechanism.

Howard (20) examined and compared the electrical insulation properties of a number of electronegative gases and their mixtures with nitrogen, under quasi-uniform and non-uniform field conditions. In quasi-uniform fields with AC voltages, the dielectric strength of a mixture at constant total pressure decreased as the partial pressure of nitrogen increased. As shown in Figure 2.1a the voltage - mixture ratio characteristics exhibit a considerable change in their slope at about 10% of SF₆ content. In non-uniform fields as shown in Figure 2.1b, it can be seen that the addition of 20-40% of N₂ in SF₆ resulted in an increase of the dielectric strength of the mixture, which becomes more pronounced as the gap length increases. These curves provided probably the first illustration of the

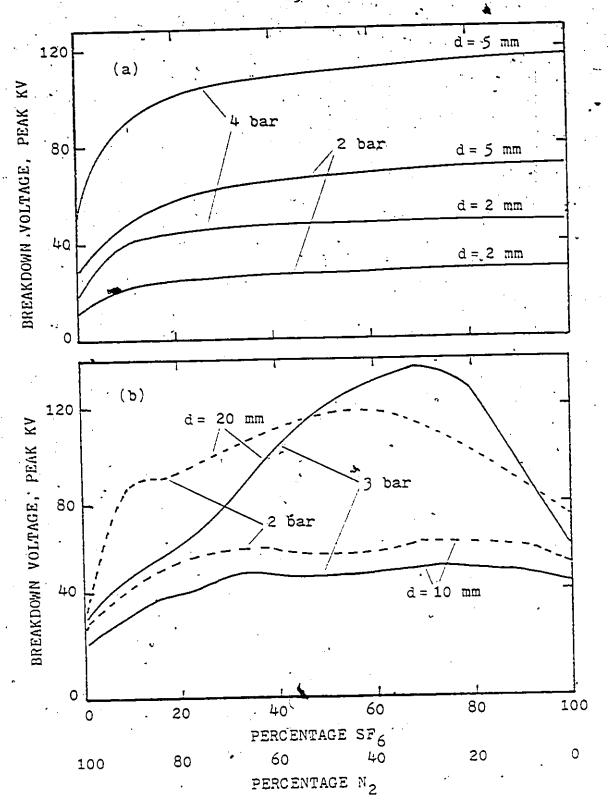


Figure 2.1 AC breakdown characteristics of SF_6/N_2 mixtures (20). (a) 50 mm diameter sphere-sphere gap. (b) point-sphere gap.

possible advantages of the $\rm SF_6/N_2$ mixtures as an insulating medium. However, while Howard's publication received wide recognition for information contained on the properties of various electronegative gases, it did not generate noticeable interest in the area of gas mixtures.

A number of publications on mixtures of $\rm SF_6/N_2$, and $\rm SF_6/air$ followed(33-38). Most investigations were conducted in uniform or near-uniform fields and very few dealt with mixtures of $\rm SF_6/N_2$ with less than 10% of $\rm SF_6$ content.

Davidson et-al(39) conducted an investigation of corona and breakdown of SF_6/N_2 mixtures in a positive pointplane gap under static and flowing gas conditions. of the corona streamers showed that their amplitude decreased as % SF $_{\mathsf{K}}$ content increased, and the streamers were highly localized around the anode tip and did not cross the gap before spark The amplitude of the streamers increased as the % of SF₆ content was reduced below 0.1%. The breakdown voltage also increased by increasing the partial pressure of SF_6 and was found to be 2.5 times that of pure $\rm N_2$ with 1% of $\rm SF_6$ content. Gas flow resulted in an increase of the breakdown voltage in mixtures containing 1% or less SF_6 , and a slight increase for This was explained as the result of a \cdot higher SF₆ contents. redistribution of the negative ion charge that had an effect on the shielding produced by the corona space-charge in the anode region.

Similar results were reported on impulse breakdown of mixtures of SF $_6$ and H $_2$ in positive rod-plane gaps by Farish et-al. (3). They found that impulse breakdown of H $_2$ is extremely

sensitive to the addition of small traces of SF_6 . For pressures up to 2 bar the breakdown voltage of SF_6/H_2 with 0.2% of SF_6 was found to be 2.0 times greater than that of pure H_2 . Impulse measurements in SF_6/N_2 mixtures conducted by Baumgartner (41) did not show any similar behaviour. The reason for this is that Baumgartner did not investigate SF_6/N_2 mixtures with low SF_6 content, and he conducted the experiments in a quasi-uniform coaxial-cylinder electrode geometry. Earlier work of Baumgartner (42) in rod-plane gaps indicated that the AC breakdown voltage increased 10% above that of pure SF_6 with 80% SF_6 content. Also, it was observed that the maximum in the breakdown voltagemixture ratio characteristics moved towards lower concentrations of SF_6 as the total pressure of the mixture increased.

More recently Watanabe and Takuma (5) examined the dielectric behaviour of mixtures of SF_6/N_2 and SF_6/air in long rod-plane gaps (30-50 cm) under impulse voltages. Their findings show that addition of small percentages of SF_6 into nitrogen does not increase the breakdown voltage of the mixture above that of pure N_2 . However, in SF_6/air mixtures with 0.8% of SF_6 content the breakdown voltage increased by about 80% higher than that of pure SF_6 . One limitation in their experiment was that the pressure was kept constant at 1 bar, hence, any pressure effects in the behaviour of the mixtures could not have been observed. It is also interesting to note that for all gaps examined, the impulse breakdown voltage of SF_6 was lower than that of N_2 and air.

A considerable amount of attention has also been exhibited in the use of $\rm SF_6/N_2$ mixtures in circuit interrupters, where the

gas mixture is tested for its thermal conductivity and arc quenching capacity. Garson (41) and Grant et al.(6) have shown that mixtures of SF_6/N_2 with 50% SF_6 content have superior arc interruption capability when compared to pure SF_6 . Garson tested the recovery voltage capability of a synchronous interrupter over the pressure range of 15 to 19 bar and found that the rate of rise of recovery voltage increased by 1.4 times when a 50% SF_6/N_2 mixture was used instead of pure SF_6 .

The mechanism of breakdown in the SF_6/N_2 mixtures is still at the speculation stage and there is no published data on measurements of the effective ionization coefficient of the different mixtures. However, breakdown results in uniform and quasi-uniform fields such as the ones presented in Fig. 2.1(a), do not show any irregularities and semi-empirical relations for streamer onset have been developed that are in agreement with experiments.

Takuma et-al.(37) proposed a simple equation that relates the breakdown voltage of the mixture under uniform field conditions with those of the individual gases.

$$V_m = V_2 + \frac{K}{K + C(1-K)} (V_1 - V_2)$$
 (2.4)

where V = breakdown voltage of the mixture

 v_1 , v_2 = breakdown voltage of the two component gases

K = partial pressure ratio of gas 1

C = constant, depending on gas mixture and experimental
 system.

Takuma showed that for C=0.08 there is good agreement between equation (2.4) and Howards experimental results of Figure 2.1a.

Although the agreement with the experimental results is good, the use of equation (2.4) is considered to be a rather impractical approach for prediction of breakdown voltage in SF_6/N_2 mixtures, because, it requires advance knowledge of voltages V_1 and V_2 for a particular electrode arrangement.

Wieland (35), developed an improved relation for the calculation of V_m in uniform fields, by showing that the ionization and attachment coefficients in a mixture, are a function of the total pressure, and the coefficients of the individual components added in a manner proportional to their partial pressures. Baumgartner (38) postulating Wieland's assumption derived an expression for the calculation of corona onset in quasi-uniform fields, using streamer mechanism theory which will be discussed in a later chapter. The effective ionization coefficient for the SF₆/N₂ mixtures as derived by Baumgartner is given by the relation

$$\frac{\kappa_{\text{eff}}}{p} = \frac{1}{k_1 + 1} K(E/p - (E/p)_{cr}) + \frac{k_1 A}{k_1 + 1} \exp(-Ep/E)$$
 (2.5)

where α_{eff} = effective coefficient of ionization

p = total pressure

 $k_1 = (partial pressure of N_2)/(partial pressure of SF_6)$

 $K = 27 \text{ KV}^{-1}$

 $A = 5320 \text{ cm}^{-1} \text{ bar}^{-1}$

 $B = 208 \text{ KV cm}^{-1} \text{ bar}^{-1}$

 $(E/p)_{cr} = 89 \text{ KV cm}^{-1} \text{ bar}^{-1}$

The above relation has not been validated as yet by direct measurement of the $\alpha_{\mbox{eff}}$. However, Weilands and Baumgartner's experimental results show good agreement with Townsend's and

streamer breakdown mechanisms that make use of equation (2.5). Similary, Crichton et-al.(43.44) have used the above expression, in their calculations of breakdown voltage in SF_6/N_2 mixtures in uniform fields perturbed by a projection and coaxial cylinder electrodes having a specified surface roughness. Their analysis shows a good agreement with experiments and this indicates that equation (2.5) can in fact lead to meaningful results if used within certain constraints imposed by factors such as pressure, gap length and field uniformity.

In general, the existing information on the dielectric properties of the ${\rm SF}_6/{\rm N}_2$ mixtures indicates that certain properties of the mixtures are superior to those of pure ${\rm SF}_6$ and nitrogen. This fact justifies the undertaking of systematic studies such as the one presented in this work, which will help to identify and understand the dielectric behaviour of the mixtures, especially with respect to basic and applied aspects such as, the theoretical prediction and the measurement of their breakdown voltage characteristics under various experimental conditions.

CHAPTER 3

ELECTROSTATIC FIELD CALCULATIONS

3.1 Introduction.

In calculating electric field distributions, analytical solution of Laplace's equation can only be obtained for a limited number of electrode configurations with practical significance. Field distributions of some of the geometries used in high voltage apparatus, such as the hemispherically capped cylindrical point-plane gap, cannot be generated by such simple charge distributions and therefore, cannot be expressed in simple analytical terms.

As an alternative to purely analytical techniques, numerical methods are often used to solve such problems. These include the Finite Difference method, the Finite Element method, and the Charge Simulation technique. In the application of the finite-difference method, the field region is usually covered with a rectangular grid. In the finite-element method, the whole region is subdivided into a large number of triangular elements, each being defined by three nodes. Within each element the electrostatic potential is a function of the potentials at the nodes, or vertices, of the triangle. It is difficult to see which one of these methods is more economical and reliable due to their basic similarities. In addition, solution for . . potential or field values in unbounded regions (regions that are not surrounded by electrode surfaces) becomes intricate and difficult to implement.

The charge-simulation method is basically a numerical

method but it results in an analytical expression for the field quantities of interest, expressed in terms of a number of fictitious charges or finite charge distributions.

These charges are placed outside the region where the field is to be calculated (that is, usually inside the volume occupied by the electrodes), and their exact positions and values are found so that the boundary conditions of the particular configuration are satisfied to an acceptable degree of accuracy.

Usually the method of solution used is a direct one which involves a priori assumptions about the location of the equivalent charge distribution, which are made on the basis of experience, and may be different for various researchers. The assumptions determine the degree of accuracy in the result.

The work described here makes use of the charge simulation technique to calculate the potential and field distribution in a rod-plane electrode arrangement. The limitations of the technique at the present state of the artare examined and analyzed for possible improvement. A new optimized version of the charge simulation technique is developed, which, with the use of optimization techniques eliminates the need for assumptions concerning the position of the charges and the points where the boundary conditions are applied. The optimized version has the advantage of minimizing reliance on personal experience and makes the achievable accuracy optimally related to the computing resources of the worker.

3.2 Charge Simulation Technique.

For a given charge distribution the potential $\emptyset(r,z)$ is a summation of the potentials resulting from the individual charges.

where n: number of charges in the system

m: number of points at which the potential is specified P_{ji} : potential coefficients which are also written as

$$P_{ji} = P(r_j, z_j, r_i, z_i)$$
 (3.2)

where (r_j,z_j) are the coordinates of a point on the electrode boundary and (r_i',z_i') are the coordinates of the source point charge Q_i .

For a set of m points selected on a surface at potential $v^{(1)}$, equation (3.1), when written in a matrix form becomes

$$\begin{bmatrix} P_{11} & P_{12} & \cdots & P_{1n} \\ P_{21} & P_{22} & & & \\ \vdots & & & & \\ P_{n1} & & P_{nn} \end{bmatrix} \begin{bmatrix} Q_1 \\ Q_2 \\ \vdots \\ Q_n^F \end{bmatrix} = \begin{bmatrix} v^{(1)} \\ v^{(1)} \\ \vdots \\ v^{(1)} \end{bmatrix}$$

$$(3.3)$$

Ordinarily, the number of boundary points m is equal to the number of charges n. Given a particular configuration the coefficients P_{ji} will be determined by the boundary conditions. Hence, equation (3.3) can then be solved for the charges Q_{ji} .

3.2.1 Application to a Rod-Plane Gap.

One of the first applications of the charge simulation technique in high voltage problems was in the calculation of the field distribution of rod-plane gaps. As shown in Figure 3.1, there are a number of ways that A solution involvone can simulate this distribution. ing the charge distribution of Figure 3.1(a) was presented by Abou-Seada (46) and earlier by Leob (47). one point charge and nine semi-infinite line charges. The solution yielded an equipotential surface with an error of $\pm 3\%$ in the neighbourhood of the spherical tip(46). However the error increased substantially for values of the gap-length to point-radius ratio less than fifty (G/R 50). This error was found to be due to a system equation slightly different from the present equation (3.3) (40,45). Thus, using part of the information given by Loeb and Seada on the positions (r_i^i, z_i^i) and (r_i, z_i) and then forming the matrix equation (3.3), the accuracy of the simulated potential for values of G/R down to G/R = 1 was greatly improved.

The solution of equation (3.3) proceeds as follows. The plane is assumed to be infinite at zero potential and the electrode semi-infinite with potential $V^{(1)}$ set to one volt. Therefore, on the cylindrical part we have ..

$$\emptyset(\mathbf{r}, \mathbf{z}) = \emptyset(\mathbf{R}, \mathbf{z}) \qquad \mathbf{z} \geqslant \mathbf{G} + \mathbf{R} \qquad (3.4)$$

On the spherical part, transforming the variables as shown in Figure 3.5 we have

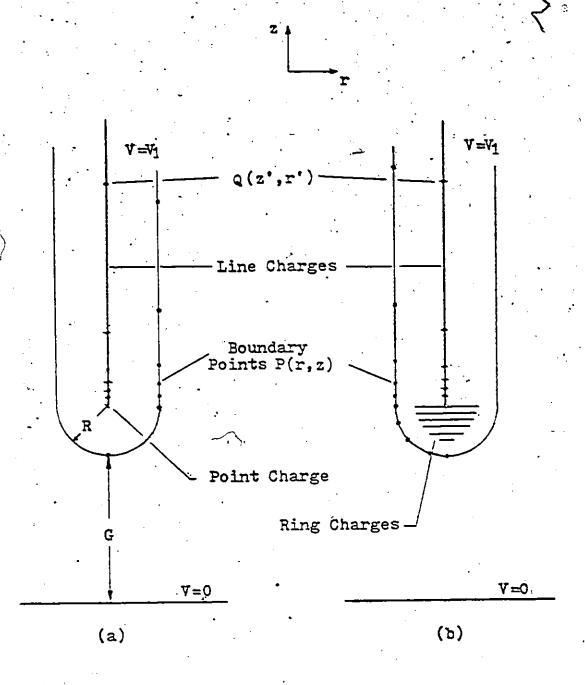


Figure 3.1 Simulation of the field distribution of a

Rod-Plane gap. (a) Using one point charge and
several line charges. (b) Using a number of
ring charges, and a number of semi-infinite or
segmented line charges.

$$(r,z) = (\sin\theta, G+R-\cos\theta)$$
 (3.5)

The analytic expression for the potential $\emptyset(r,z)$ of the nine semi-infinite lines and one point charge with their corresponding image charges, is

$$\phi(\mathbf{r}, \mathbf{z}) = \sum_{i=1}^{9} Q_{i} \ln \left[\frac{z_{i}^{1} + z + (\mathbf{r}^{2} + (z_{i}^{2} + z)^{2})^{\frac{1}{2}}}{z_{i}^{1} - z + (\mathbf{r}^{2} + (z_{i}^{2} - z)^{2})^{\frac{1}{2}}} \right]$$

$$+ Q_{10} \left[\frac{1}{(\mathbf{r}^{2} + (z_{10}^{2} - z)^{2})^{\frac{1}{2}}} - \frac{1}{(\mathbf{r}^{2} + (z_{10}^{2} + z)^{2})^{\frac{1}{2}}} \right]$$
(3.6)

By convention the radius R is set to unity so that the gap-length G is also equal to the ratio G/R, which relates to the uniformity of the gap field along the axis of symmetry.

Equations (3.4),(3.5) and (3.6) were used to generate the matrix equation (3.3). A computer program was written (in Fortran) for the generation and solution of equation (3.3). Comments and a computed example are included in Appendix 1. Having solved for the charges Q_i , equation (3.6) can now be used to calculate the potential $\emptyset(r,z)$ at any point in the inter-electrode area, provided that the simulated potential $\emptyset(r,z)$ on the boundary of the electrode is equal to one volt.

In order to check the accuracy of the simulated potential distribution, the percent error

((Yapplied - Vsimul.) / Vapplied x 100 (3.6(a)) is calculated for points along the boundary of the electrode. The results are shown in Figures 3.2 and 3.3. In Figure 3.2 the percent error for various gap-lengths is plotted versus distance along the cylindrical part of the electrode from the point

G+R = G+1 to G+1+50 that is, 50 radius units away from the tip the percent error along the spherical part of the electrode is shown in Figure 3.3. Here the position on the spherical boundary is given by the radial distance from the z-axis through equation (3.5). Figures 3.2 and 3.3 show that the percent error of the simulated potential along the cylindrical boundary is small, when compared with uncertainty in experimental measurements or other numerical techniques, and trivial along the spherical part which represents the region of interest (since most breakdown criteria involve calculations along the axis of highest field stress).

3.3 <u>Limitations of the Conventional Charge Simulation</u> <u>Technique</u>

In applying the charge simulation method to calculate field distributions, the main task is to find the proper positions (r_i, z_i) and (r_j, z_j) . In order to gauge the amount of effort required to solve the rod-plane configuration, a number of calculations were made disregarding previous information on the positions (r_j, z_j) . Different sets of (r_i, z_i) and (r_i, z_i) were carefully selected by considering the distribution of each of these locations with respect to each other, and to the electrode boundary. The results showed that even after the first few adjustments, the error in the neighbourhood of the spherical tip was larger than 10%.

A solution of the field distribution for the case of Figure 3.1(b) was attempted using ten ring charges and five

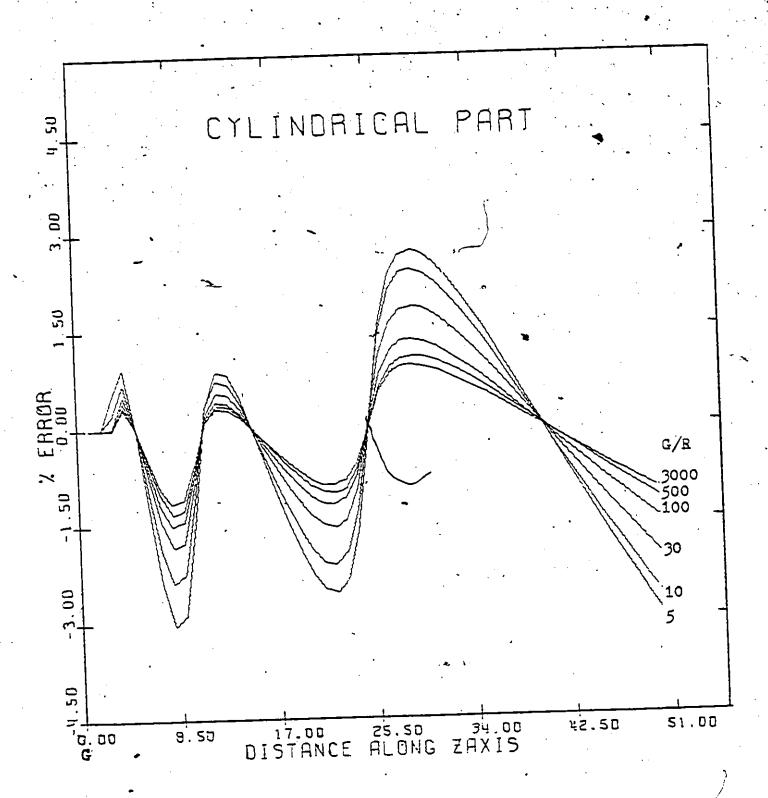


Figure 3.2 Percentage error of the simulated potential on cylindrical part of the electrode, for different gap lengths.

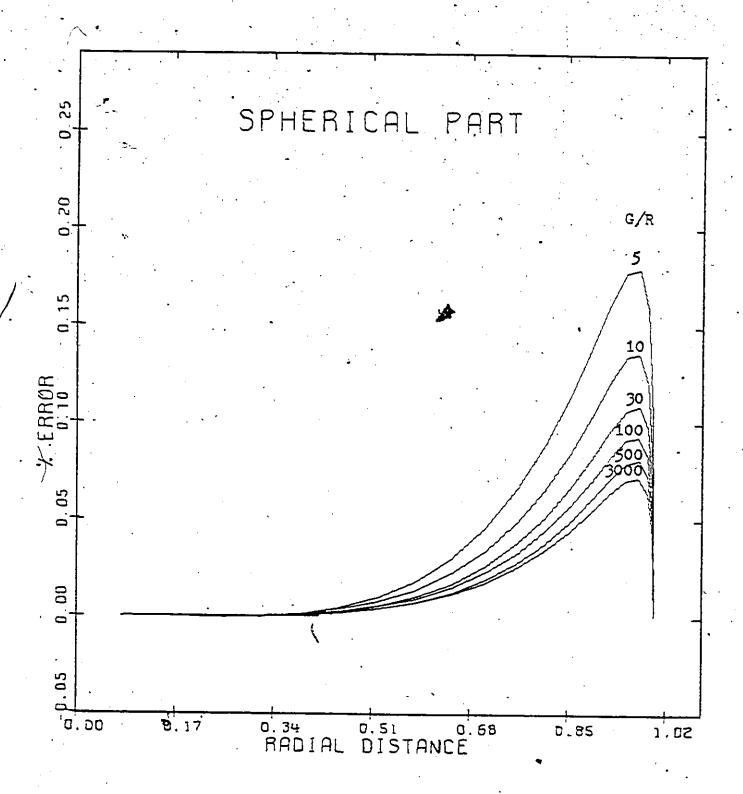


Figure 3.3 Percentage error of the simulated potential on spherical part of the electrode, for different gap lengths.

semi-infinite line charges. Again the results indicated that a considerable amount of time would have to be spent in finding a good combination of points (r_i, z_i) and (r_j, z_j) in order to produce a uniformly equipotential surface.

The difficulty increases when one attempts to solve for more complicated field distributions. Figure 3.4 shows two geometries that are frequently used in high voltage apparatus. The solution of these configurations with the use of the charge simulation technique, and especially the one with no axial symmetry (Figure 3.4a), would have to involve line and ring charges of variable density (45). As will be shown later, this requires a thorough knowledge of electrostatics, and perhaps a large amount of educated guess work. Hence, many experimenters might dismiss the technique in favour of other methods.

However, the charge simulation technique has a very important property; that is, given the positions and the values characterizing the charge distribution, the field at any point can be calculated analytically. This is important because it eliminates the need of a grid node at that point, and in addition, if a space charge is included in the calculations, the field at any point will be given by the summation of the field components due to the individual charges constituting the whole system.

Hence, in view of this advantage and the task of constructing a three-dimensional grid if one of the discretization methods is chosen, an attempt is made here to simplify the conventional approach using optimization techniques.

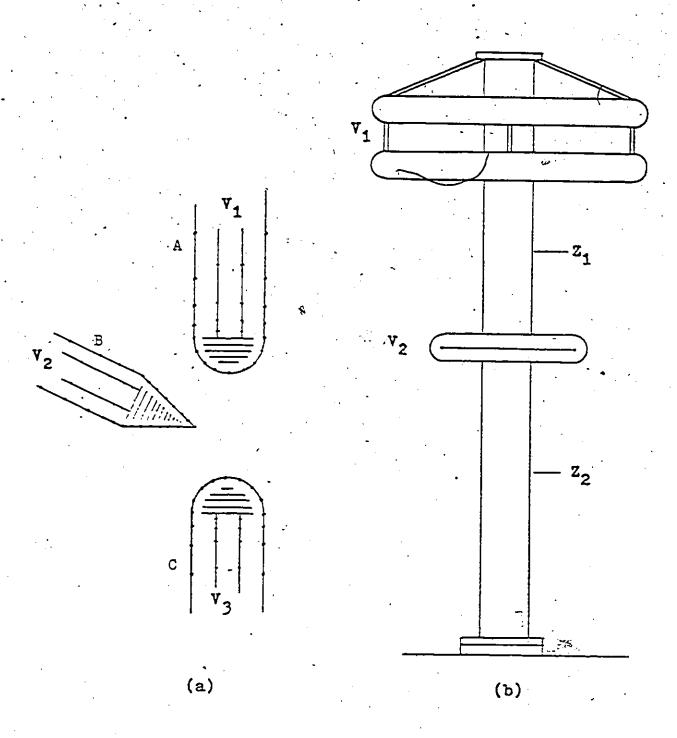


Figure 3.4 (a) A trigatron, with non-axial field ditribution.

(b) A high voltage divider, with field controlling electrodes.

3.4 Optimized Charge Simulation Technique.

One of the most important parameters in the optimization of any design or processes, is the choice of the optimization criterion or objective function. This usually varies according to the nature of the problem. The objective function used here is the cumulative squared error, which is very simple to apply and is represented by

$$U = \sum_{j=1}^{m} (V - \emptyset_{j}(r,z))^{2}$$
or
$$U = \int_{s} (V - \emptyset_{j}(r,z))^{2} ds$$
(3.7)

where V: is the value of the potential at the physical conductor positions,

 $\emptyset_{i}(r,z)$: the value of the simulated potential,

m: the number of points (r_j, z_j) on the electrode boundary,

and S: represents the electrode surface.

The variables of optimization which primarily are the position of the charges and their values, are subject to the following equality and inequality constraints.

$$f(x_i) = A; f(x_i) \ge B; f(x_i) \le C; D \le f(x_i) \le E$$
 (3.8)

where $f(x_i)$ can be any one of the variables x_i , or, a linear or non-linear expression involving a number of variables (e.g., $x_1+x_2+5x_3=F$). A.B.C.D. and F are constants related to the physical system.

The final consideration is the choice of the optimization.

technique or algorithm. The technique must be capable of handling highly nonlinear objective functions, equality and inequality constraints, and constraints that are described by linear or non-linear functions of the variables. Furthermore, it should be possible to change the constraints or the objective function without modifying the optimization algorithm.

The availability of the first and second derivatives of the objective function U, will determine whether or not gradient techniques that require these derivatives will be used. A number of optimization subroutines are available in the FORTRAN and WATFIV scientific subroutine manuals. Rosen - brock's method (48) is one of the earlier and most reliable techniques, but with a relatively slow rate of convergence. One of the fast-converging techniques is Davidson's method as modified by Fletcher and Powell (50), combined with the Created Response Surface Technique of Carroll (49).

3.4.1 Application to a Rod-Plane Gap.

In demonstrating the principle and for comparison purposes, the potential distribution of Figure 3.1(a) is simulated with one point charge and nine semi-infinite line charges. For simplicity the potential on the surface of the electrode is assumed to be equal to one volt. Then for any point (r_j, z_j) on the electrode surface the values of Q_i and positions (r_i, z_i) must be such that the resulting potential $\emptyset(r_j, z_j)=1$. Thus the values of the charges Q_i and their positions (r_i, z_i) are asigned to be the variables of optimization and as an objective function we take the cumulative square error, as follows.

$$U = \sum_{j=1}^{m} (1 - \emptyset_{j}^{i}(r,z))^{2}$$
 (3.9)

where $\emptyset(\mathbf{r},z)$ is given by equation (3.6) and m is the number of points at which the potential $\emptyset(\mathbf{r},z)$ is calculated. Therefore, by choosing several points (\mathbf{r},z) along the boundary of the electrode and minimizing the function U, the required \mathbf{Q}_i and (\mathbf{r}_i,z_i) are found for which the potential at the points (\mathbf{r},z) is equal to the applied potential (1 volt). A value of m=65 was arbitrarily chosen. This corresponds to fifteen points (\mathbf{r},z) on the hemi-spherical part of the electrode and fifty on the cylindrical part from G+R to G+R+48R (or with R=1 from G+1 to G+1+48).

The problem was solved for two separate sets of constraints. In one set of constraints the positions of the charges are constrained on the basis of previous information (47), between G+1 and G+1+250 as shown in table 3.1. In another set, the positions of the charges are arbitrarily constrained between G+1 and G+1+48, as shown in table 3.2. In this manner, one can test of the uniqueness of the positions (r_i, z_i) .

The initial values of the optimization variables (r_i, z_i) and q_i , were selected arbitrarily within their corresponding constraints.

Rosenbrock's optimization technique (48,51) is used for the minimization of the objective function, modified accordingly to account for equality and inequality constraints.

The results for two different gap lengths G are shown in Figures 3.5, 3.6 and 3.7 where the percentage error of the simulated potential is plotted versus position on the surface of the electrode. $\emptyset_j(r,z)$ is calculated for a number of points other than the original (r_j,z_j) to check for possible non-uniformities of the simulated potential. The resulting values of the positions (r_j,z_j) are shown in Tables 3.3 and 3.4. Equipotential plots for the two different gap lengths are presented in Figures 3.8 and 3.9. Similarly, Figure 3.10 shows the potential distribution along the axis of highest field strength for a number of G/R ratios.*

In general the results indicate that the error for both sets of constraints is of the same order of magnitude and that there is no unique set of positions for the line changes. Their position depends on the ratio G/R and the imposed constraints. Figure 3.6 and 3.7 show that unlike the results of Figure 3.3 the error along the cylindrical part approaches zero as the distance from the spherical tip increases. This could be due to the fact that the position and the value of the charges is an optimum for the given set of constraints.

No further attempt was made to refine the model since the results obtained were of acceptable accuracy. The degree of accuracy of the optimized approach at this introductory level helps to demonstrate the ease and efficiency of this method.

The objective function was in all cases minimized to $\label{eq:U} \text{$U\simeq 0.01$ for comparison purposes.} \quad \text{The computation time-depends}$

^{*} A computer program with a sample solution is given in Appendix 2.

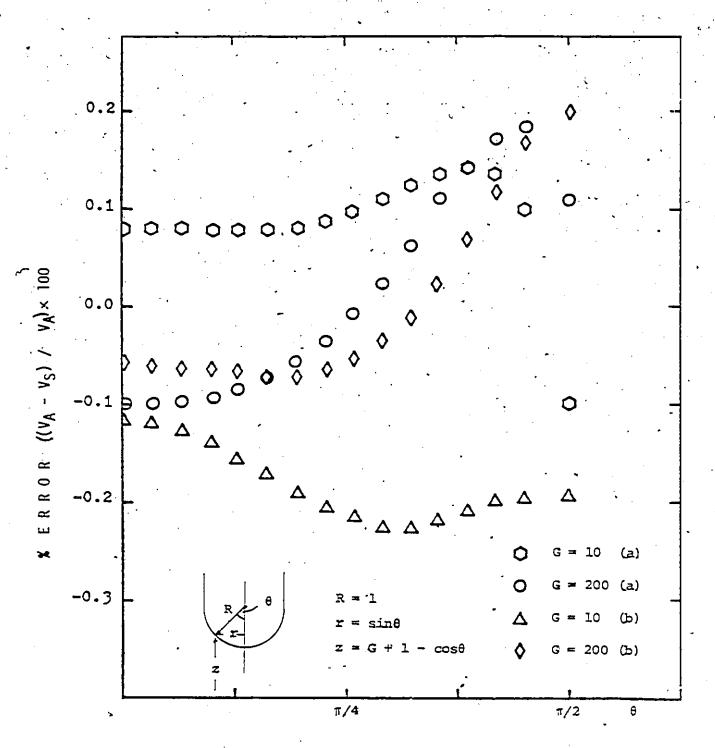


Figure 3.5 Percentage error of the simulated potential along the spherical part of the electrode. (a) Results obtained using the constraints of Table 3.1. (b) Results obtained using the constraints of Table 3.2.

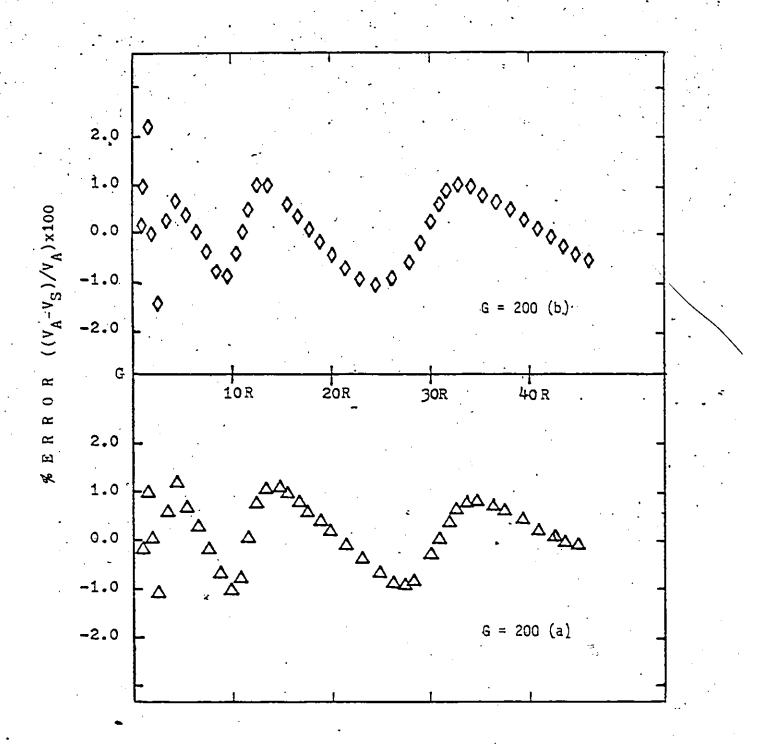


Figure 3.6 Percentage error of the simulated potential on the cylindrical part of the electrode. (a); and (b) correspond to constraints of Tables 3.1 and 3.2 respectively.

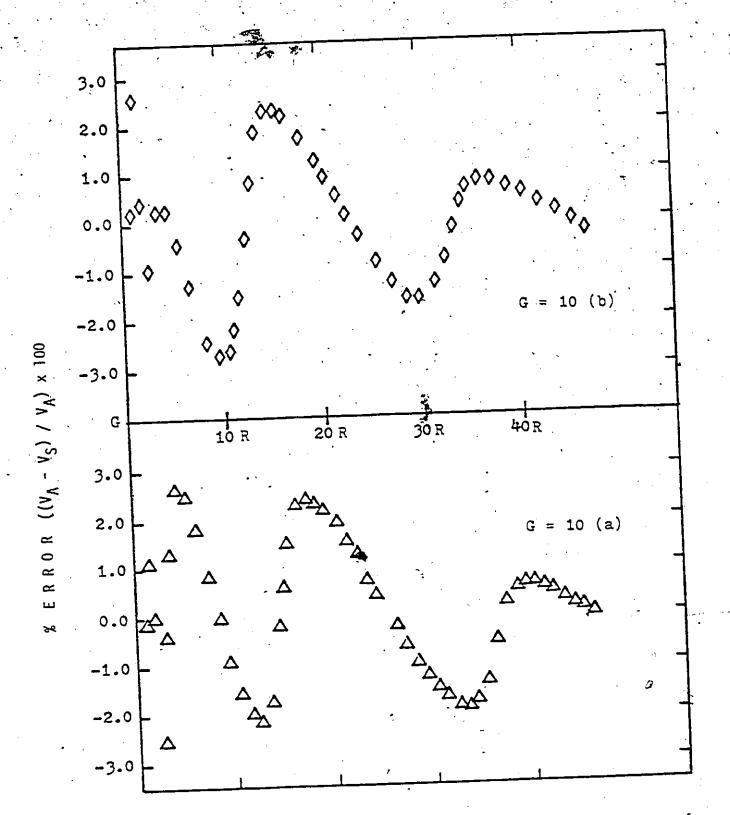


Figure 3.7 Percentage error of the simulated potential on the cylindrical part of the electrode. (a) and (b) correspond to constraints of Tables 3.1 and 3.2 respectively.

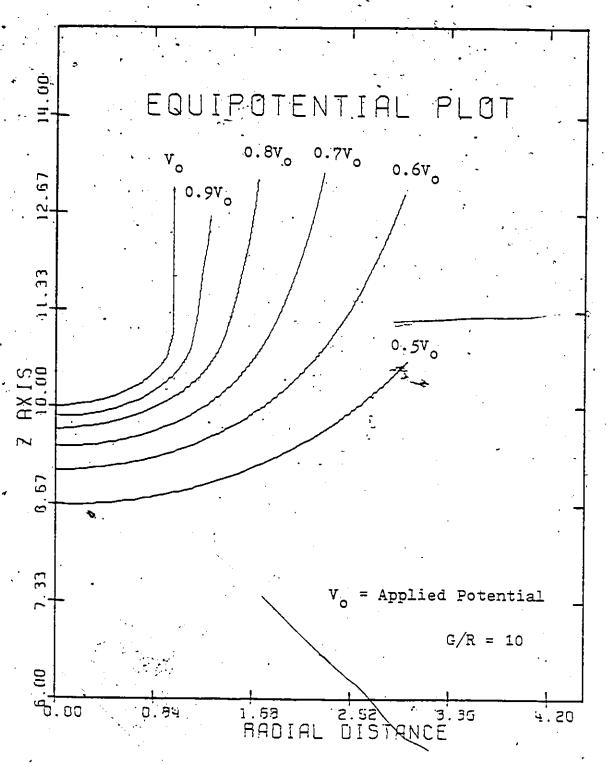


Figure 3.8 Equipotential plot of a rod-plane electrode configuration with a gap length to point radius ratio G/R = 10/1.

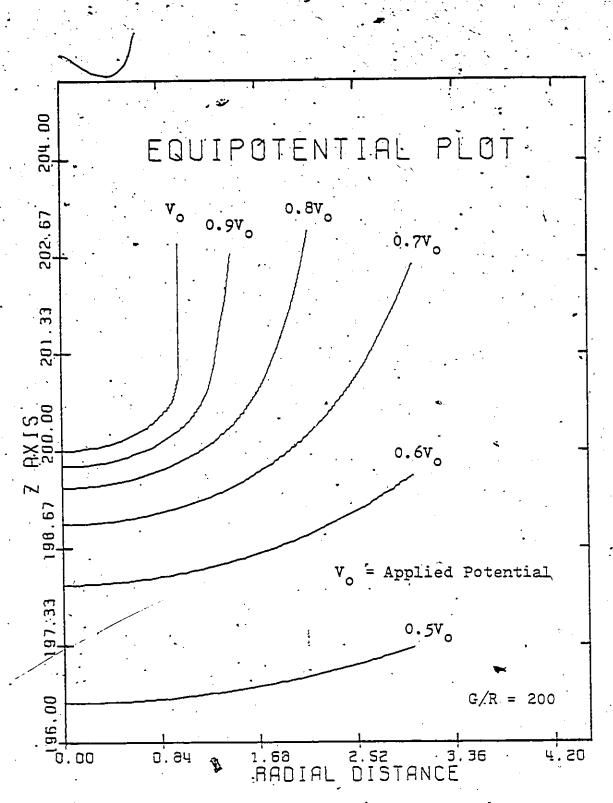
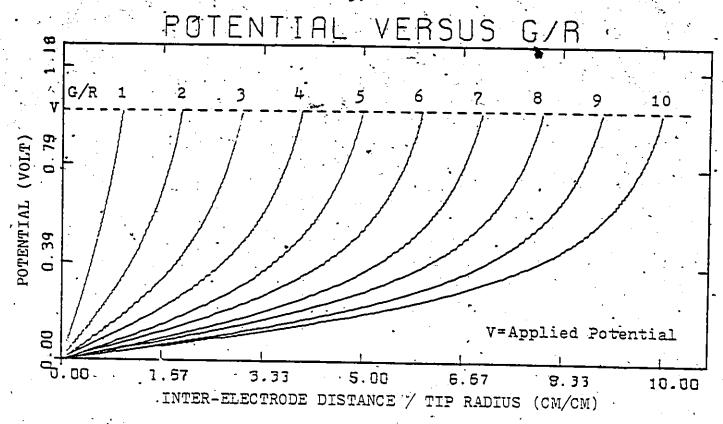


Figure 3.9 Equipotential plot of a rod-plane electrode configuration with a gap length to point radius ratio G/R = 200/1.



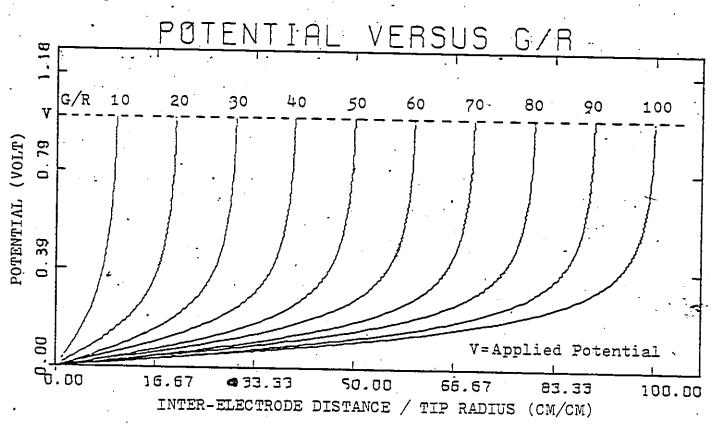


Figure 3.10 Potential distribution along the axis of a rod-plane gap for various gap ratios G/R.

Table 3.1. Constraints imposed on the variables of optimization

$$(0,z_1) = G+R$$
 $G+R \neq (0,z_2) \neq 1.5$
 $(0,z_3) \neq 0$
 $(0,z_3) \neq 0$
 $(0,z_3) \neq 0$
 $(0,z_4) \neq 0$
 $(0,z_5) \neq 0$

where B is a large positive number and A = -B

Table 3.2 Constraints imposed on the variables of optimization

$$(0,z_1^*) = G+R$$
 $G+R \neq (0.z_{1,2,...9}^*) \neq G+R+48.0$
 $(0,z_{10}^*) = G+R$
 $A \neq Q_1 \neq B$ $i=1,2...10$

Tables 3.3 and 3.4. Optimized positions (0,z;) as derived from the constraints of Tables 3.1 and 3.2 respectively.

Table 3.3 -			-	Table 3.4		
÷ 1	G=200	 G=10		_i_j	G=200 (G=10
1234567890	201.00 201.11 201.19 201.55 202.16 216.97 228.94 296.06 410.80 201.00	11.00 11.10 11.15 11.57 12.18 20.20 41.60 110.99 238.59 11.00		1234567890	201.00 201.11 201.15 201.35 201.45 202.03 212.29 231.12 201.00	11.00 11.10 11.11 11.38 11.49 12.22 23.55 46.30 58.81 11.00

mainly on the rate of convergence of the optimization method used to minimize the objective function. Rapidly converging techniques should be used if computer time is an important parameter. Other factors that could influence the computation time are initial values of the optimization variables and the effectiveness of the objective function. The latter factor is very important, since for more complex configurations it is possible that the minimum accumulated square error may not be an efficient criterion.

3.5 Application of the Optimized Charge Simulation Technique to Field Distributions with Non-Axial Symetry.

As mentioned earlier, charge simulation solutions of field distributions with non-axial symmetry are not favoured due to the introduction of variable density charges. Let us for example consider the trigatron case of Figure 3.4(a). Figures 3.11(a) and 3.11(b) show two cross-sections of electrode 'A', one at the spherical tip, and one at the cylindrical part respectively. The variable density rings of Fig. 3.11(a) are obtained by dividing the originally charged distribution into two parts, a constant part, and a variable part consisting of cosinusoidal harmonics with unknown peak values λ_{μ} . The charge distribution is a function of the angle α and is given by (45)

$$\lambda(\alpha) = \sum_{\mu=0}^{m_{1}} \lambda_{\mu} \cos(\mu\alpha)$$
 (3.10)

where, m_i is the number of points (r_i, z_i) on the circumference of the ring.

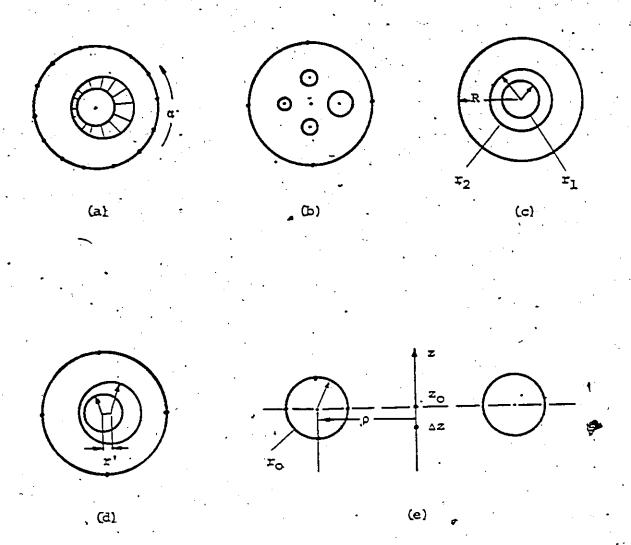


Figure 3.11 (a) Cross-section of the spherical part of the electrode V₁ of figure 3.4(a). (b) Cross-section of the cylindrical part of the same electrode. (c) and (d) represent similar cross-sections as that of (a), before and after the optimization of the system.

(e) Cross-section of electrode V₂ of figure 3.4(b).

In this way the ith ring contains m_i+1 number of charges. In order to determine the values of these charges, an equal number of boundary points (r_j, z_j) should be placed along the circumference of the electrode, and on the plane that contains the ith ring.

However, the problem can again be simplified with the proper choice of optimization parameters. The variable density ring charges can be obtained as shown in Figure 3.11(c) and 3.11(d). In this case the ring of radius r_1 is fixed, and the centre of ring r_2 is free to move on the plane of the page along the r-axis. This movement is constrained in a region r_x such that

$$r_{x} \le r_{2} - r_{1}$$
where $r_{1} < r_{2} << R$ (3.11)

Therefore, a variable density ring is simulated with the addition of only two variables, that is the charge of ring r_2 , and its position r' with respects to the z-axis.

It becomes apparent that a number of new optimization parameters can be introduced, the nature of which depends on the particular configuration.

As another example, we consider the potential divider of Figure 3.4(b). The field configuration of the doughnut shaped electrode at potential V_2 , can be simulated with one ring charge as shown in Figure 3.11(e). Assuming V_1 and V_2 to be positive potentials, the ring charge at V_2 will be slightly displaced from its original position in the torroid. However, since we do not know the exact position of the ring,

we can constrain its centre to move between z_0 -Az, where Az

The radius r_0 could also vary and therefore it will be set as an optimization parameter, since we suspect that if the ring moves down, it could change in diameter. Similar arguments will apply to the top electrode and the system will be solved simultaneously, considering the image charges with respect to ground.

Furthermore, one can proceed to simulate even more complicated field distributions by the use of non-linear constraints, which could force point charges to move on predetermined contours, and line charges to tilt, or, simply change size and position.

The field distribution of the rod-plane gap (as obtained by the charge simulation technique), was used in the calculation of streamer onset voltages in SF₆ and SF₆/N₂ mixtures, which will be presented in Chapter 6.

CHAPTER (4

EXPERIMENTAL TECHNIQUES AND PROCEDURES

4.1 Experimental Design.

The ability of high voltage power equipment to withstand lightning stroke and switching surges is usually evaluated with impulse or chopped impulse voltages. In this work, standard impulse voltage (1.5 μ s front, 50 μ s tail) was chosen to examine the dielectric behaviour of the SF₆/N₂ mixtures.

A rod-plane electrode arrangement was used, for as mentioned earlier, this configuration provides excellent conditions for simulation and observation of the effects produced by various non-uniformities.

The experimental variables were: the total pressure of the mixture, the partial pressure of the component gases (or % of SF₆ content in the mixture), and the gap length of the rod-plane gap. The number of variables was kept small so that a complete investigation of both positive and negative impulses could be made. This allowed continous monitoring of impulse voltage, discharge current, photomultiplier current, and photography of the various phenomena under both polarities.

In experiments of this nature there is usually a trade-off between the experimental variables and the parameters that one can monitor. Advance design and the use of factorial experiments can be useful; however, there are limitations in the design of an experiment, imposed mainly by the nature of the problem that is investigated. In the present case due to the limited information

on impulse breakdown measurements of SF_6/N_2 mixtures, the basic design involved impulse voltage and current measurements, and study of the temporal growth of ionization at different gap lengths and pressures. In addition, a good deal of effort was invested in the development of the data-acquisition system, which will be discussed in the following sections:

4.2 Test Chamber.

The measurements were carried out in a stainless steel pressure vessel 60cm high and 36cm in diameter, fitted with a high voltage bushing and four quartz windows. A cross section of the major components is shown in Figure 4.1.

The high voltage bushing is rated at 115 KVAC in an out-doors environment and was successfully tested indoors at 350 KV of impulse voltage.

The electrode adjustment was made with the use of a micrometer screw. Initially the vernier was located on the high voltage side through the HV bushing. This arrangement was found inefficient and a new vernier was constructed and fitted at the bottom plate of the chamber which is at ground potential.

The gap-length was adjusted by first lifting the plane until a contact with the rod electrode was detected with the ohm-meter and then lowered to the desired length. The zero adjustment was performed at the operating pressure due to small variations of the inter-electrode distance with pressure changes.

The photomultiplier was an EMI-9781R side window tube. The EMI-9781R has relatively high sensitivity in the blue region,

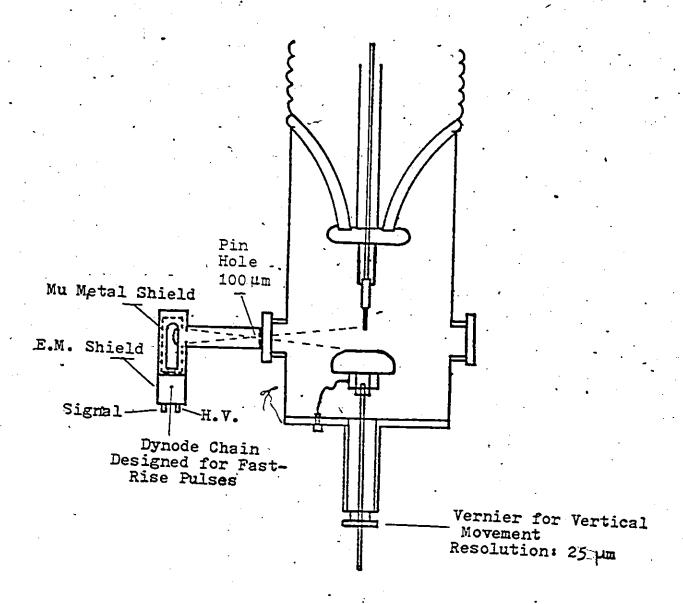


Figure 4.1 Test chamber. The photomultiplier is mounted in one of the chamber windows and it is optically aligned so that the full area of the PM cathode was illuminated.

low dark current, fast response time (2 nsec. pulse rise time) and high gain at low overall voltage (typically 750 V).

The photomultiplier was mounted in one of the windows of the chamber and was optically aligned so that the full area of the PM cathode was illuminated.

4.3 Electrode Arrangement.

Both electrodes were made of brass. The upper electrode consisted of a hemi-spherically capped rod of 0.8mm radius. The lower plane electrode was 12cm in diameter, machined to a 90° Rogowski profile, and was electrically isolated from the rest of the chamber which was permanently grounded. Before each series of measurements the electrodes were polished to a surface finish of about 1 micron.

A number of different polishing methods were employed in order to determine a convenient and practical way of polishing. At first polishing powders were used from grade 400 to grade 1000. Each grade was applied for a period of time until the surface showed a uniform roughness and then the electrode was cleaned thoroughly with methanol before the higher grade was used. This method while it gives good results, proved to be rather laborious. Great care must be taken to ensure that the surface is absolutely clean before a higher grade is used. The reason for this being that one powder grain from a lower grade can produce scratches on the surface that can be removed only by returning to that grade.

Chemical polishing was subsequently used. A solution of

three acids was used at elevated temperature.

Acid	% content
Phosphoric - H ₃ PO ₄	55
Acetic - CH3COOH	25 60° <t(80°< td=""></t(80°<>
Nitric # HNO3	20

The heating and chemical etching was conducted inside a fumehood. The results indicated that the surface finish depended
critically on the time that the electrode was imersed in the
solution. A typical time for a uniformly pitted electrode was

1.5 minutes. However, after the etching was completed the surface of the electrode contained discolourations from residual
oxides that were difficult to remove with a cleaning agent.

Thus, at times further polishing with a fine powder was neccessary.

Finally, it was decided that both of the above methods were too elaborate to be used after each series of experiments, considering that the pressure range and gap-length used, could involve a spark mechanism insensitive to the electrode surface. Instead, after each series of measurements the electrodes were uniformly polished with an abrasive compound (Brasso) with maximum grain size of 20µm and then with red rouge lapping compound of 0.5µm grain size. This process provided a polish compatible to the previous methods in a much shorter time, and was used through-out the experiments.

4.4 Gas Mixing Procedure.

The gases were mixed by adjusting the pressure ratio, and the final mixture was checked for accuracy using a gas analyzer.

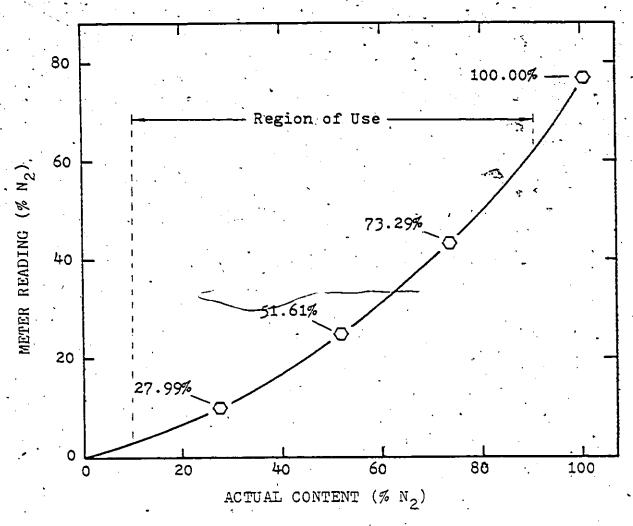


Figure 4.2. Calibration curve for the HF50 Gas Analyzer. The SF $_6/{\rm N}_2$ gas mixture was monitored for N $_2$ content in the above shown range.

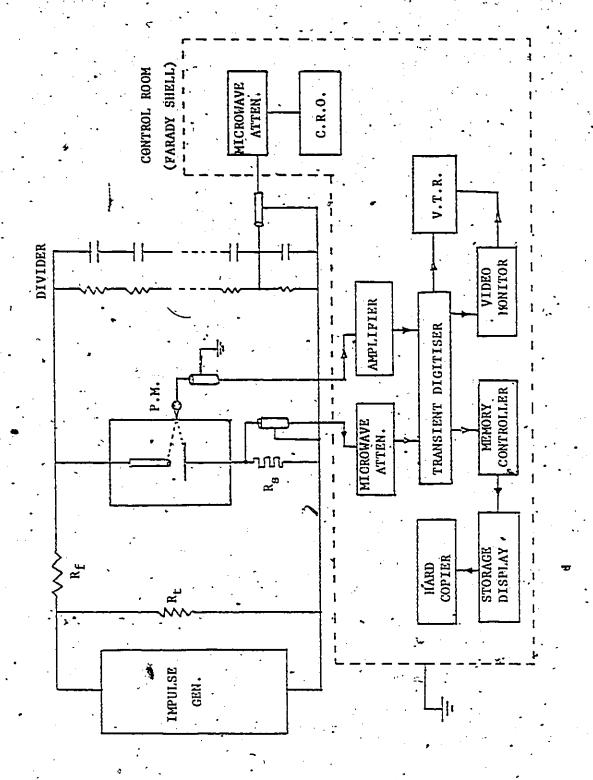
The gas analyzer was a HF50 $\rm H_2/N_2$ mixture monitor, calibrated for $\rm SF_6/N_2$ mixtures. The HF50 analyzer provides a reading of the % content of nitrogen by measuring the thermal conductivity of the mixture with a precision thermister. The instrument had to be recalibrated periodically and a typical calibration curve is shown in Figure 4.2. Three standard mixtures were used for the

calibration. For consecutive use, after the calibration curve was obtained the 0% N_2 point had to be reset each time before a reading was taken. The gas analyzer was used in the range of 10-90% of N_2 content and it provided a measurement of the mixture ratio with an accuracy better than $\pm 1\%$. Mixtures containing low percentage of one of the constituent gases were mixed under vacuum conditions. The chamber was first evacuated to 0.01 Torr and the lower constituent was admitted to a partial pressure corresponding to the desired mixture. The second constituent was then added to the predetermined total pressure. A thermocouple vacuum gauge was used to measure the low pressures rather than a mercury gauge to avoid any contamination of the test chamber with mercury vapour:

Measurements in nitrogen and SF₆-nitrogen mixtures were made after evacuating the chamber to 0.01 Torr, flushing it with nitrogen and subsequently by evacuating to 0.1 Torr. The nitrogen used was high purity while the SF₆ was commercial grade 99.8% pure. The gases were dried and filtered through 1 micron filter prior to admission into the chamber and in addition a small amount of activated alumina was placed at the base of the chamber to remove chemically active compounds produced by the discharge.

4.5 The Voltage Supply and the Data Acquisition System.

The schematic diagram of the voltage supply and the measuring system is shown in Figure 4.3. The impulse generator was adjusted to supply an impulse wave of 1.5/50µsec. The voltage was measured with an R.C. Haefely type divider. Additional voltage signal division inside the control room was obtained using



Schematic diagram of apparatus and data acquisition system

microwave attenuators whose performance was found superior to that of conventional dividers.

The 50% impulse breakdown voltage was obtained using the "up and down" method. For each breakdown value, at least 25 impulses were applied at a voltage close to breakdown.

The current shunt used for the measurement of breakdown current was a "squirrel cage" type (64) constructed of carbon resistors.

The photomultiplier and the current signals were fed into a R7912 Tektronix transient digitizer. The R7912 Transient. digitizer is a high speed signal acquisition instrument capable of operating in either the analog or digital mode. Acquired waveforms up to 500 MHZ (or 1 GHZ direct access) are converted to a more useful speed and format suitable for viewing on a standard Incoming signals can be viewed on a monitor video monitor. and simultaneously stored on video tape. The Memory Controller (or 1350 memory display unit) provides all the controls nece-It can then read data from the ssary to load the R7912 memory. memory and convert it to x-y analog data for driving non-raster The storage display (or 603 storage monitor) is displays. connected to the 1350 control unit and simultaneously interfaced with the 4631 hard copy unit, so incoming signals can be viewed on the display and subsequently stored in a hard copy form.

This type of arrangement is not only convenient, but it allows the storage of a large number of waveforms that can be used for statistical study, which is essential in most high voltage measurement.

4.6 Shielding of the Apparatus

The measurement of rapidly changing voltages and currents requires special measuring techniques and procedures. Operation of an impulse generator gives rise to electromagnetic interference caused by transient potentials and by strong electromagnetic fields associated with the charging and discharging of stray capacitances to ground. The stray capacitances are mainly distributed capacitances to ground along the Impulse generator, test chamber, and . interconnecting leads. Because of the high rate of voltage change, the charging and discharging currents may reach peak values of some Kiloamperes (65). Thus, electromagnetic interference will be generated either through the air or from transient potentials , caused by the return of these currents to the generators grounding. plate (or grounding rods) through the ground impedance. fairly low ground impedance, equalizing currents will be driven through the entire ground system and result in unwanted noise.

In order to reduce the noise input to the measuring system a number of precautions were taken,

- 1. A shielded room was built to try to prevent the electromagnetic fields from penetrating inadequately shielded instrument cabinets. The walls, floor, and ceiling of the shielded cage (12'x10'x10') were made of double copper mesh which was electrically connected to the ground plate of the impulse generator.
- 2. All measuring instruments were located inside the cage and were powered through an isolation transformer placed between the cage and the mains. However, it was found

that the over-all shielding was inefficient due to noise transmitted through the power lines. This conducted interference was suppressed by conventional RFI power-line filters. In order to achieve high quality wide-band attenuation, the filters were positioned in the power lines feeding the cage and in contact with the external wall of the cage.

3. Multiple grounding of the measuring circuit generates currents on the cable shields, which induce noise in the signal via capacitive coupling. This type of interference was attenuated to a large extent by reducing the grounding paths to a practical minimum. A copper strip (1m wide) was connected to the ground plate of the generator and extended to the base of the test object as shown in Figure 4.4. The cage was introduced to the ground circuit by a similar copper strip connected to its base and extending in the interior to provide earth-taps for the measuring equipment. The signal cables were triaxial and a typical ground connection is shown in Figure 4.4.

Since electromagnetic interference enters a measuring system in its radiated and conducted form, and because each of the above measures provides an attenuation rather than complete suppression, the performance of the present system can be claimed simply as "adequate" for the type of measurements involved.

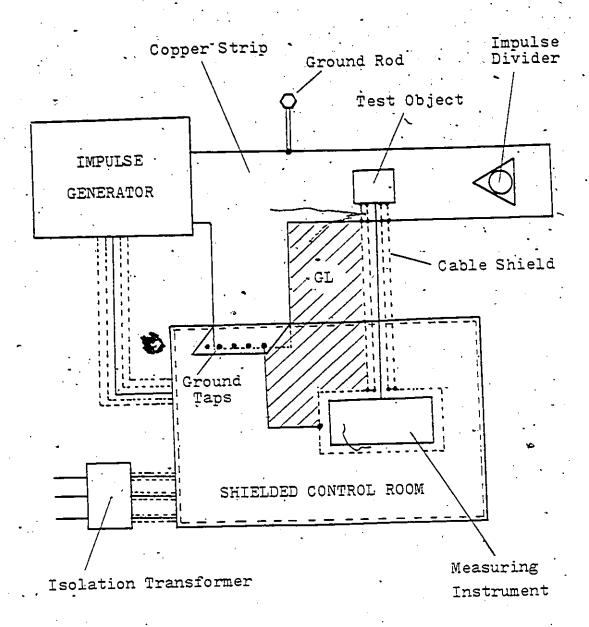


Figure 4.4. Schematic diagram of the grounding system of the impulse generator facility: Typical ground connections of a triax-cable and measuring instrument are shown, together with the generated ground loop GL.

4.7 Corona Onset Voltage Measurements.

The corona onset voltage measurements were performed under direct voltage conditions. The detection circuit consisted of a 10 kilo-ohm resistor in series with the test gap and an oscilloscope, that monitored the voltage drop across the resistor. A pair of fast responding diodes connected back to back were also included in the circuit, to protect the oscilloscope from overvoltages that could result from high breakdown currents.

The high voltage supply was a Deltaray HVDC generator with an output voltage of 0-1000KV, output current 0-2 miliamperes and a superimposed ripple within 0.01% of the output voltage.

The applied voltage was raised up to 90% of the onset value at a rate of 10 KV/sec and thereafter at a rate of 0.5.

KV/sec until the onset voltage was detected. The corona onset voltage is defined here as the voltage at which the first "voltage jump" is detected on the oscilloscope. The corona onset voltage values presented in this work represent the mean value of at least ten individual measurements.

CHAPTER 5.

EXPERIMENTAL RESULTS

In this chapter, impulse breakdown measurements of both polarities are presented for SF₆, N₂ and mixtures of the two gases. Mixtures containing 0.01% to 100.0% SF₆ are investigated over a pressure range extending from 300 torr to 5 bar and gap lengths ranging from 5 to 50mm. Results on the temporal growth of ionization are presented through photomultiplier and discharge current measurements. Further information on the spatial growth of impulse coronas and spark trajectories in the inter-electrode area is given in the form of still photographs.

The 50% breakdown voltage (V $_{50}$) for most measurements had a standard deviation of less than 10% of V $_{50}$. Repeatability of results was in most cases good. However, for SF $_6/\mathrm{N}_2$ mixtures under certain mixture ratio and total pressure conditions, the repeatability of the results was relatively poor. Hence, unless otherwise stated the repeatability of the results will be considered as being within experimental uncertainty limits. Uncertainty bars, are included in areas where the error was relatively large, or in cases where the error bars could have an effect in the interpretation of the results.

5.1 <u>Breakdown Characteristics of SF</u> under <u>Negative and Positive</u> Impulse Voltages.

. The breakdown characteristics of SF $_{6}$ were examined separately from those of the SF $_{6}/\rm N_{2}$ mixtures. Unlike N $_{2}$ which

has uniform breakdown voltage pressure-characteristics under both polarities, SF₆ was expected to exhibit a discontinuity in the breakdown voltage-pressure characteristics in the pressure range of 1 to 3 par (17,19,57).

By applying negative impulse voltage on the rod electrode and varying the gap length, the breakdown voltage-gap length characteristics of Figure 5.1 were obtained at various gas pressures. One observes that the slope of the curves is larger at the lower gap-length region. This is because at high gap lengths the corona onset voltage depends makely on the radius of the hemispherical tip of the rod electrode. Hence the corona and spark onset voltage-pressure characteristics have a saturation tendency at higher gap lengths.

Figure 5.2 fillustrates the negative impulse breakdown voltage-pressure characteristics of SF $_6$ for different gap lengths. The 50% breakdown voltage increases with pressure uniformly over the pressure range of 1-5 bar. There was very little scatter in the values of V_{50} and the degree of reproducibility was relatively high.

The measurement of V₅₀ was made with a Textronix 549 storage oscilloscope. The signal prior to its input to the oscilloscope was attenuated 897:1 with the high voltage divider and 10:1 inside the cage with a microwave attenuator. The overall division of the signal was tested with the aid of low voltage calibration pulses (100-500V). This method, while acceptable for high voltage divider calibrations, has been criticized for its effectiveness to present a realistic situation where the input signal has high dV/dt values. As an added means of checking

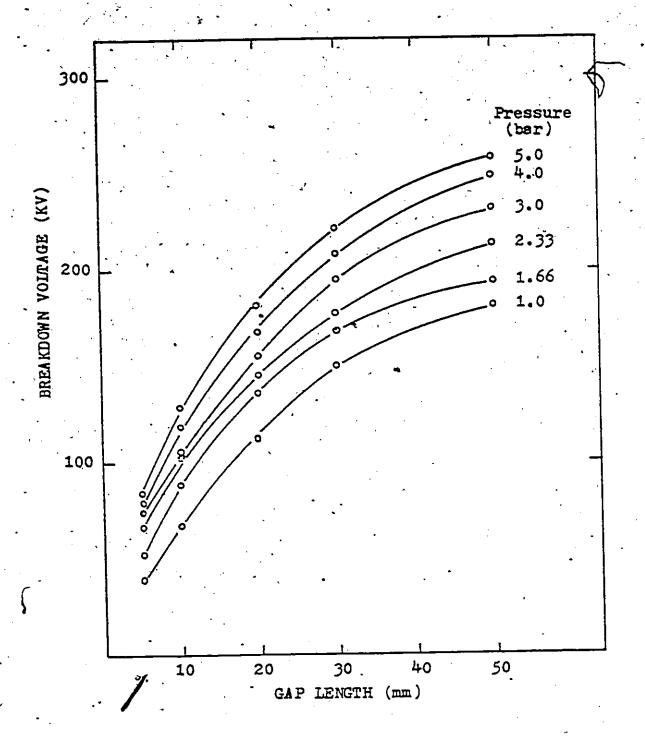


Figure 5.1 Negative impulse breakdown voltage versus gap length characteristics of SF₆ for a pressure range of 1.0-5.0 bar.

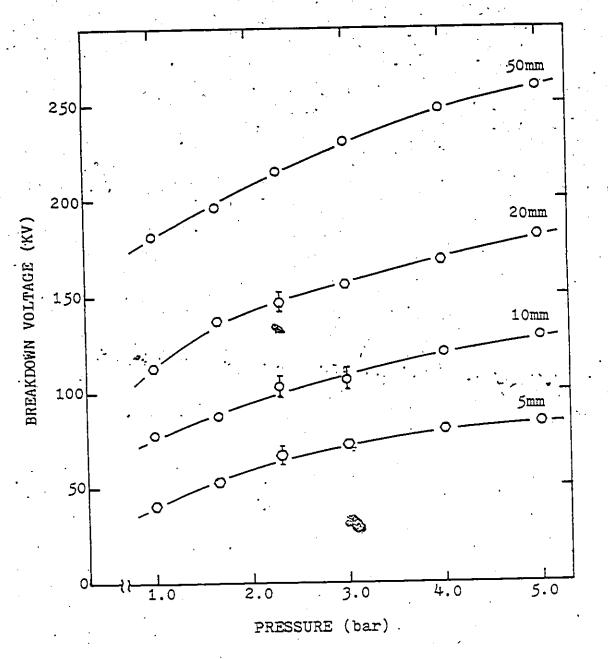


Figure 5.2: Negative rod-plane impulse breakdown voltage-pressure relationship for SF_6 , in gap lengths ranging from 5 to 50 mm.

the measured breakdown voltage level, a comparison is made.

of the present measurements with results obtained by Howard

(20) and Sangassad (55) under similar experimental conditions.

As shown in Figure 5.3 all results compare well through out

the pressure range and for both gap lengths.

where the breakdown voltage is plotted versus pressure for a 10mm and a 50mm gap. It is seen that a corona stabilized region appears in the 50mm gap for pressures less than Pmin The breakdown voltage increases rather rapidly with pressure up to Pmax, which corresponds to a local maximum in the voltage-pressure characteristics followed with a negative slope in the pressure characteristics followed with a negative slope in the again with pressure but, at a lower rate of increase. For the 10mm gap, the voltage maximum and the corona stabilized region seem less distinct and shifted towards higher pressures. This is in agreement with results presented by Works and Dakin (19), Hazel (7), and Sangassad (55).

In comparing the curves of Figures 5.2 and 5.4 one observes that breakdown under the same gap-length and pressure conditions was always lower for positive impulse. In addition, no voltage maximum was observed under negative polarity in the pressure range of 1-5 bar.

It sould be noted that a voltage maximum for negative polarity does exist but, it occurs at a higher pressure than \mathbf{P}_{max} of the positive polarity (78).

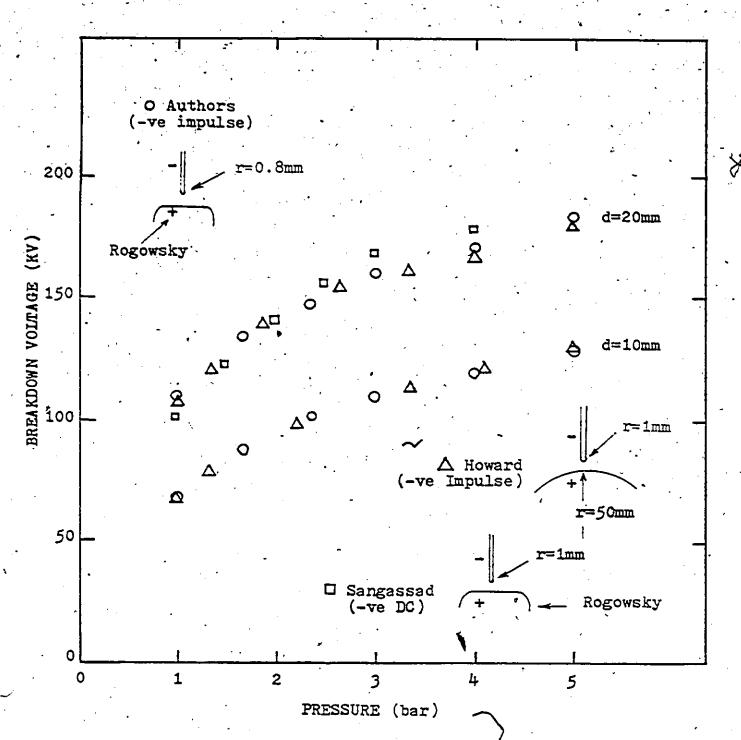


Figure 5.3 Negative impulse breakdown voltage-pressure characteristics of SF₆ for 10 and 20 mm gaps, compared with results obtained by similar experimental conditions.

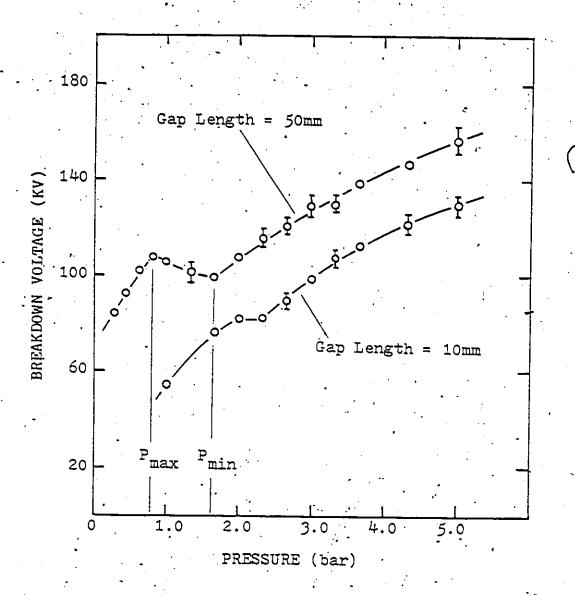


Figure 5.4. Positive rod-plane impulse breakdown voltage-pressure characteristics for SF₆. Note that the corona stabilized region is not as well defined for the 10mm gap.

5.2 Negative Impulse Breakdown in SF6/N2 Mixtures.

The ${\rm SF_6/N_2}$ mixtures were mixed by the procedure described in the previous chapter. After the two gases were admitted into the test chamber, the mixture was allowed a minimum of one hour before any breakdown measurements were taken.

Figure 5.5 shows negative impulse breakdown voltage data obtained at a total pressure of 1 bar for different mixture ratios and gap lengths. Each curve represents the breakdown voltage of a mixture plotted as a function of mixture ratio. The latter was varied from 100% SF $_6$ to 100% N $_2$ for a fixed gap length. The curves of Figure 5.5 follow a pattern reported earlier by Howard(20) (Figure 2.1) and Weiland (35), for quasi-uniform and uniform field gaps. As the % of SF $_6$ content is reduced, the dielectric strength of the mixture decreases at a constant rate down to about 10% of SF $_6$ and thereafter the rate of decrease becomes more rapid.

Figure 5.6 presents breakdown data for different mixture ratios in a 10mm gap, at pressures ranging from 1.0 to 5.0 bar. Starting at the low pressure end, one observes that for pressures up to about 3.5 bar the breakdown voltage-mixture ratio relationship is similar to that of Figure 5.5. However, at 5.0 bar of total pressure the dielectric strength of the mixture shows an unexpected decrease at relatively high contents of SF₆. This effect is more pronounced in longer or less uniform field gaps, as shown in Figure 5.7, where breakdown voltage data obtained for a 50mm gap are plotted. In this case the dielectric strength of the mixture is drastically reduced as the content of SF₆ is

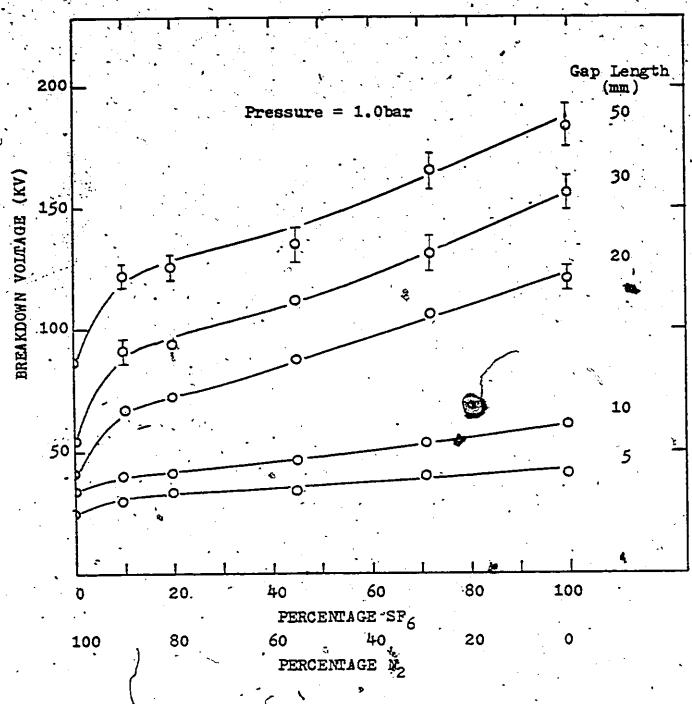


Figure 5.5. Dependence of magative impulse breakdown woltage on mixture ratio for rod-plane gaps ranging from 5 to 50 mm at a total pressure of 1:0 bar.

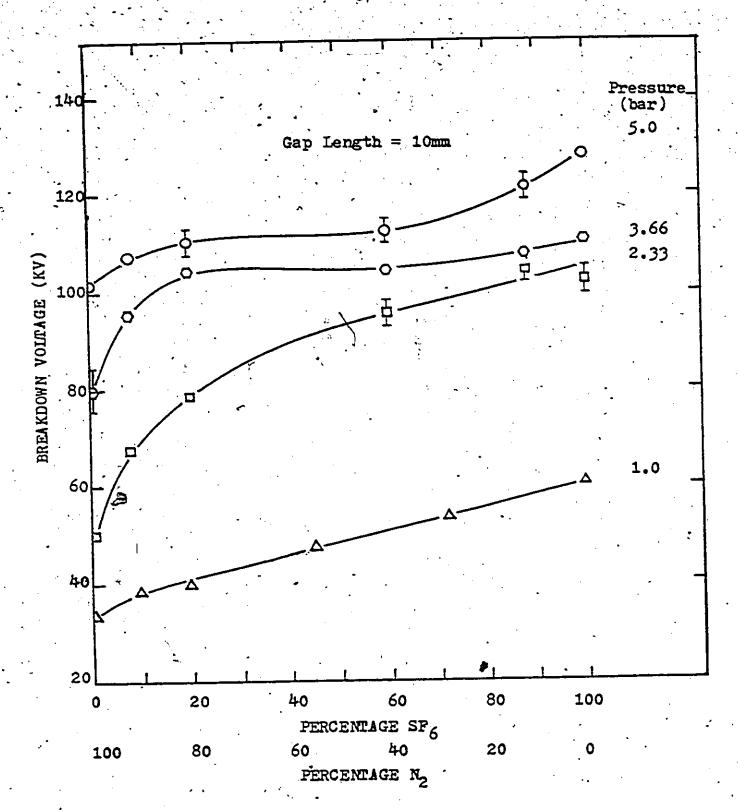


Figure 5.6. Negative rod-plane impulse breakdown voltage and mixture ratio relationship for a pressure range of 1.0-5.0 bar.

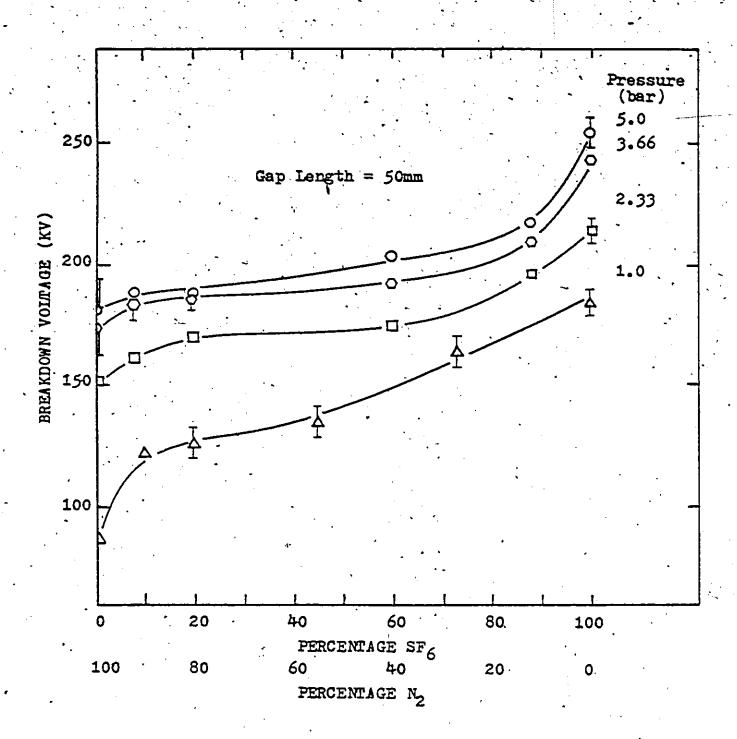


Figure 5.7. Negative rod-plane impulse voltage and mixture ratio relationship for a pressure range of 1.0-5.0 bar.

reduced from 100% to 80%.

Although the curves of Figure 5.6 indicated a trend of loss of dielectric strength at high pressure and/or gap length, the sudden drop/exhibited in the 3.7 and 5.0 bar curves of Figure 5.7 was not anticipated. Due to the lack of published data relating to this effect, the repeatability of the breakdown results in this region was methodically tested, and found to be satisfactory. Similarly, the scatter in the values of V₅₀ was generally lower than 5%.

5.3 Positive Impulse Breakdown in SF₆/N₂ Mixtures.

The breakdown characteristics of positive rod-plane gaps in pure SF₆ have been studied more intensively than those of negative polarity. Several investigators have shown that the non-uniform field breakdown voltage-pressure characteristics of pure SF₆ exhibits a negative slope at the lower pressures. The phenomenon has been ascribed to a space charge modification of the field (19).

Figure 5.8 shows the breakdown characteristics of SF_6/N_2 mixtures for a 10mm gap and pressures in the range from 1.0 to 5.0 bar. At the higher pressures the breakdown voltage mixture ratio relationship is nearly linear with a plateau between approximately 40 to 60% SF_6 content. At the lower pressures, notably at 1 bar, a new trend begins to develop. The addition of a small amount of N_2 to SF_6 increases the breakdown strength of the mixture above that of pure SF_6 . Figure 5.9 shows that this anomalous increase becomes more pronounced and

rather unpredictable as the length of the rod-plane gap increases (or the field distribution becomes less uniform). In the extreme case, the dielectric strength of mixtures composed of some 50% to 80% SF $_6$ with 50% to 20% of N $_2$ at a pressure of 1 bar approaches the dielectric strength of the same mixtures at a pressure of 5 bar. Figure 5.9 also shows the breakdown values for pure N $_2$ (dark points on the vertical axis) at 5.0, 4.0, 3.0, 2.0 and 1.0 bar in descending order.

It should be noted that for pressures above 2 bar, the breakdown values in pure nitrogen exceed the corresponding values in mixtures composed of 20% and 10% SF₆. The anomalous behaviour of the breakdown characteristics in mixtures of high and low content of SF₆ may be better appreciated from Figure 5.10 in which the breakdown characteristics for pure N₂, pure SF₆ and for different mixtures have been plotted versus the total pressure. At lower pressure (below 1 bar), the curves for the mixture with high SF₆ content exhibit the familiar steep increase in breakdown voltage with pressure, generally described as "corona stabilized breakdown", followed by the negative slope at higher pressure. Addition of 15% of nitrogen to SF₆ causes a large increase in the dielectric strength.

At pressures higher than 2 bar the breakdown voltages of the 95%, 85% and 65% SF $_6$ mixtures drop below that of pure SF $_6$ and continue to do so up to 5 bar of total pressure.

At lower SF $_6$ contents and pressures above 2 bar (Figure 5.10) the addition of some 10% to 20% of SF $_6$ to N $_2$ causes a reduction in the dielectric strength, a phenomenon not recorded

previously in the literature. Additional studies were therefore undertaken in mixtures containing less than 10% of SF6.

The content of SF6 was varied from 10% down to 0.01%. As the content of SF6 was reduced below 10%, at first the breakdown characteristics followed the trend shown in Figure 5.10 that is, the peak breakdown voltage observed at the lower pressure continued to fall with decreasing the content of SF6. As the content of SF6 was reduced below about 5%, the breakdown strength of the mixture started to increase, reaching a strength well in excess of that of pure SF6 as shown in Figure 5.11 and 5.12. The highest strength was observed in a mixture of 99.8% of nitrogen and 0.2% of SF6. Further decrease of SF6 content lowered the peak breakdown values. Comparison of the curves shown in Figures 5.10 and 5.11 show that the maximum strength in mixtures containing a fraction of a percent of SFG occurs at a pressure of about 2 bar, while in mixtures composed of high SF_6 contents (higher than about 5.0% SF_6) the voltage maximum is observed at about 1 bar of total pres-For mixtures with less than 0.1% of SF6, the peak of maximum voltage is shifting to higher pressures proportionally to the partial pressure of SF6

Figure 5.12 shows that the addition of 0.2% of $\rm SF_6$.to nitrogen approximately doubles the strength of pure nitrogen at about 1.7 bar of total pressure, an effect similar to that recently reported by Farish et-al.(3) for mixtures of $\rm SF_6/H_2$.

At pressures above 2 bar the pattern of the breakdown

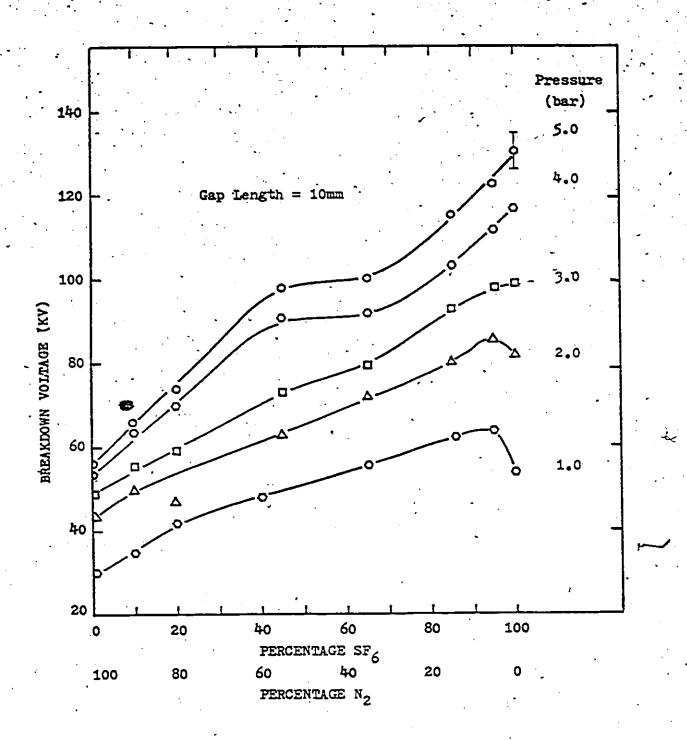


Figure 5.8 Positive rod-plane impulse breakdown voltage and mixture ratio relationship for a pressure range of 1.0-5.0 bar, and a 10 mm gap length.

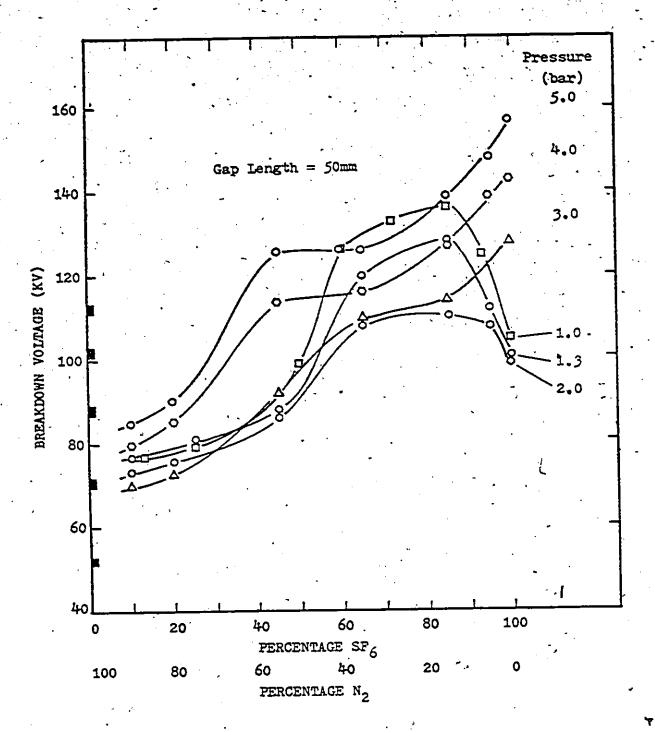


Figure 5.9 Positive rod-plane impulse breakdown voltage and mixture ratio relationship for a pressure range of 1.0-5.0 bar. The dark points on the vertical axis represent the impulse breakdown voltage of 100% N_2 at 1.0-5.0 bar in ascending order.

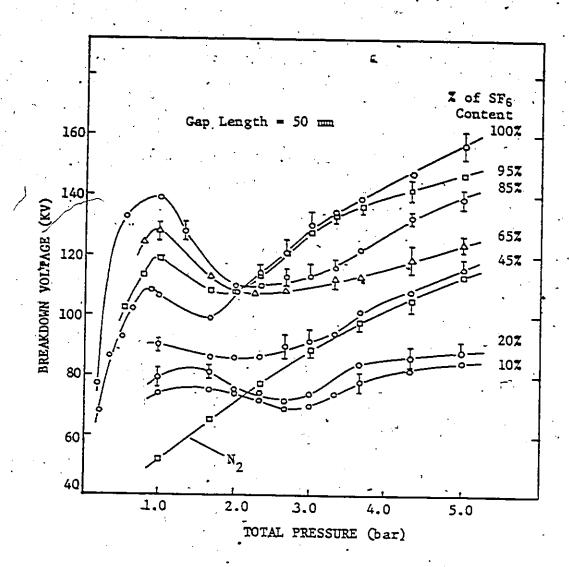


Figure 5.10 Positive rod-plane impulse breakdown voltage-pressure relationship for various $\rm SF_6-N_2$ mixtures. Mixtures with 65% of $\rm SF_6$ content or more at pressures less than 2.0 bar exibit higher dielectric strength than pure $\rm SF_6$.

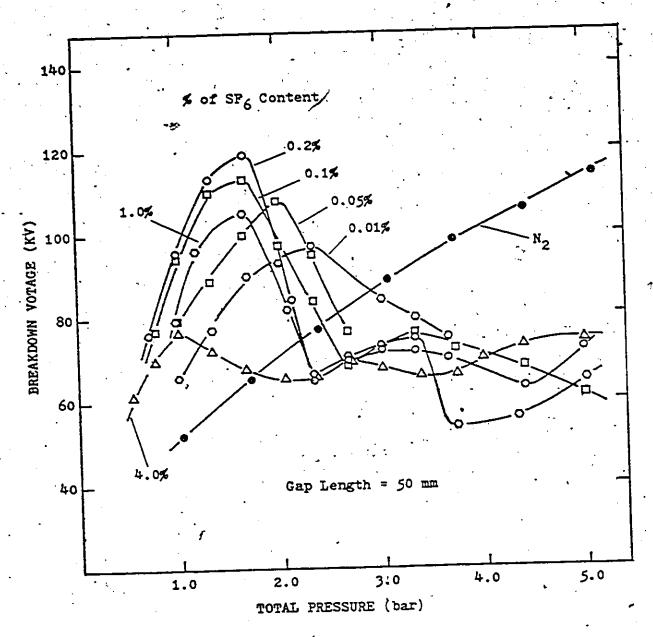


Figure 5.11 Positive rod plane impulse breakdown voltage and pressure relationship for mixtures containing small traces of SF₆. Gap length: 50 mm.

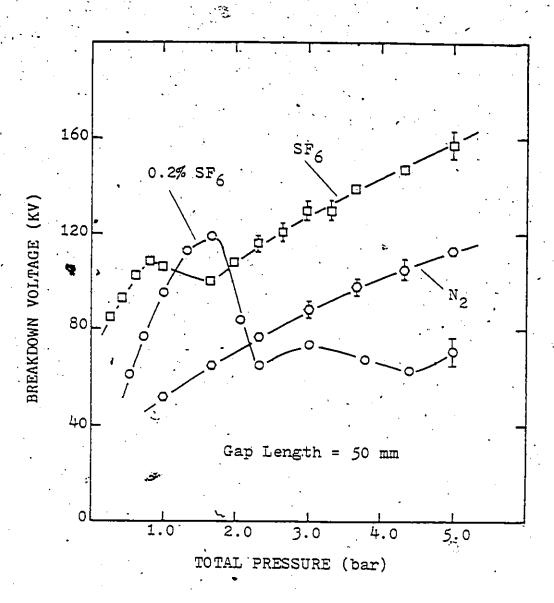


Figure 5.12. Positive rod-plane impulse breakdown voltage-pressure characteristics for: pure SF₆, pure Nitrogen and an SF₆-N₂ mixture with 0.2% of SF₆ content. Note that the breakdown voltage of the 0.2% SF₆ mixture at 1.7 bar (P_{max}), is higher than that of pure SF₆ and approximately twice as high as that of pure N₂ at the same pressure.

characteristics as shown in Figure 5.11 becomes complicated and unpredictable. While the scattering in the values of V 50 was small, the repeatability of the measurements was very poor. However, if the breakdown voltage pattern in this region is highly sensitive to the mixture ratio, then the repeatability of the results cannot be properly examined since the error involved in producing a 0.05% SF 6 mixture could be as high as ten to thirty percent.

Under positive polarity and both long and short gaps, it was observed that the measured breakdown values for different mixtures were influenced in different ways by the immediate history of the gas. Phenomena such as residual gas ionization and electrode and gas temperatures caused by previous sparks were found to affect the breakdown values of different mixtures differently. To minimize such effects, a time interval of 1 minute between consecutive impulses was adopted. This time. was found sufficient to give consistent results.

5.4 Temporal Growth of Ionization.

The temporal growth of ionization during and following breakdown was investigated mainly with the use of a photomultiplier. Each photomultiplier signal is a typical trace, representing at least 5 to 10 similar traces recorded for each different set of conditions. The photoelectric records were supplemented with current measurements during the spark development. The main emphasis in these measurements was placed on breakdown rather than prebreakdown phenomena. Hence the current

measurements were not pursued to a great extent.

The photomultiplier-transient digitizer system.used in these experiments is designed to give a high degree of temporal resolution. The results presented in this work show the complete photon activity in the gap from prebreakdown to recombination process which take place in a time interval of the order of microseconds. Therefore interference of the measuring system which has a sensitivity of the order of nanoseconds is minimal.

5.4.1 Growth of Ionization in Negative Rod-Plane Gaps.

·Figure 5.13(a) shows typical photomultiplier current records during the breakdown of a 5mm gap at a pressure of 1 bar in mixtures ranging from 100% SF6 to (100% of nitrogen. In pure SF6 at breakdown, the sharp rise indicates the formation of the leader stroke, followed by the main stroke which is barely distinguishable and a broad pulse a few microseconds later. Simultaneous current records showed no significant current flow corresponding to the last pulse (Figure 5.13(d)). Dale (84), obtained similar photomultiplier traces from sparks in air gaps, which he also photographed with the use of a streak The streak photographs did not record any light during camera. the last pulse and Dale concluded that this pulse was a saturation effect of the photomultiplier tube. In the light of these result a number of tests were conducted by the author to determine the The results of these tests (see Appendix 4) origin of this pulse. suggest a similar saturation effect as that described by Dale. .

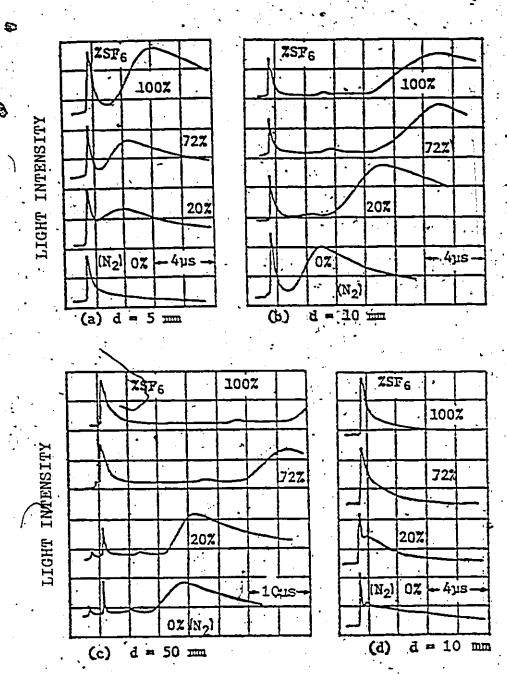


Figure 5.13 Photomultiplier records of gap discharge in various SF₆-N₂ mixtures, (a) 5mm; (b) gap - 10 mm; (c) gap - 50 mm; (d) gap current with gap - 10 mm

As the gap was increased from 10mm to 50mm, corona pulses were observed in mixtures of high nitrogen content, but the overall pattern of the photomultiplier pulses remained unchanged.

5.4.2 Growth of Ionization in Positive Rod-Plane Gaps.

Representative photomultiplier records of positive impulse rod-plane gap discharges in SF_6/N_2 mixtures and in the constituent gases are included in Figure 5.14(a) to (c). At a pressure of 1 bar the photomultiplier records were very similar to those observed under negative polarity (Figure 5.13 (c)).

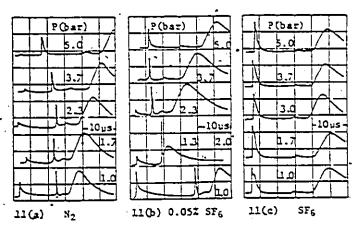


Fig. 5.14 Effect of pressure on the, photomultiplier pulses in N_2 , in N_2 -containing 0.05% SF6 and in SF6 respectively. (a) N_2 ; (b) N_2 - SF6 mixture: (c) SF6

The photomultiplier traces observed at a total pressure of . about 2 bar in pure nitrogen, in nitrogen containing a small amount of SF $_6$ (0.05), and SF $_6$ are represented with the second lowest trace in Figures 5.14(a) to 5.14(c) respectively. As it is seen, addition of a trace of SF $_6$ to nitrogen at that pressure caused an increase in the magnitude of both the corona and the leader stroke pulses.

The time lag between the corona pulse and the leader stroke is closely related to the statistical time lag for breakdown. Corona discharges take place in the front of the impulse wave close to the peak voltage, while the leader stroke represents bridging of the gap by the discharge at breakdown. No exact measurement of time lags was made, but statistical time lags were observed to be longer at low pressure and small gap lengths.

5.5 Spatial Growth of Ionization.

- During the course of breakdown voltage measurements in SF_6/N_2 mixtures, observation of the electrodes after a series of breakdowns showed that the rod electrode was at times pitted or dis-colourized along the cylindrical part, away from the sphe-This observation suggested that under certain conditions, depending on mixture ratio and pressure, the spark was forced to initiate away from the tip of the electrode. On the basis of those observations a still camera was introduced into the system. An FTb Canon, 35mm single lens reflex camera was used with a 50mm macro lens. . . The camera was mounted on one of the test chamber windows. Photographs of spark trajectories were obtained in SF₆, N_2 and SF₆/ N_2 mixtures, and impulse coronas under both polarities were also photographed whenever possible. The magnification in all the illustrations is approximately 0.9 times that of the real object.

5.5.1 Spark Trajectories in N2, SF6, and SF6/N2 Mixtures.

Spark discharges in nitrogen were photographed under both polarities in the pressure range of 1.0 to 5.0 bar. Under negative polarity, the spark paths were slightly curved as they approached the plane electrode, irrespective of gas pressure. Under positive polarity and low pressure, the sparks followed the minimum path distance along the line of highest field strength. As the pressure increased the spark trajectories curved in a proportional manner.

Figure 5.18 shows two typical discharges at 1.0 and 5.0 bar of nitrogen. These photographs indicate that there is a certain relationship between the gas pressure and the number and distribution of the positive ions in N_2 . At higher pressures, the space charge surrounding the anode is apparently larger and corona streamers that would ordinarily move towards the cathode are retarded and choked, until the voltage becomes high enough for them to reach the cathode by travelling around it.

In SF₆, photographs of discharges under negative polarity did not show any definite trend as the pressure varied. For positive rod-plane, previous investigations (18,19,56,57) have either indicated or shown that the spark trajectories are highly curved in the corona stabilized region (around P_{max} , Figure 5.4). The photos taken here are in agreement with these observations. At 1.0 bar where P_{max} occurs, the spark advanced from the tip of the anode to the cathode along a highly curved path. As the pressure increased to P_{min} (1.7 bar) the curvature of the paths decreased, and for pressures higher than P_{min} the spark paths

were moderately curved. Two typical spark trajectories in 1.0 and 5.0 bar of SF_6 are shown in Figure 5.19. Most of the sparks in SF_6 travelled along the line of highest field strength for a few millimeters before they finally curved.

In comparing Figures 5.19 and 5.18 one observes that while in $\rm N_2$ the curvature increased with pressure, in $\rm SF_6$ the spark paths reached maximum curvature in the region where corona onset preceded breakdown. Also, curved spark paths are in both cases associated with locally maximum breakdown voltage.

Spark discharges in SF_6/N_2 mixtures with high SF_6 contents did not show significant differences from pure SF_6 . However investigating SF_6/N_2 mixtures with less than 1.0% SF_6 , a most unusual phenomenon was observed under positive impulse conditions. The point of spark initiation on the rod electrode moved away from spherical tip as the pressure varied. An extensive investigation of SF_6/N_2 mixtures with 0.1 and 0.2% SF_6 , showed that the effect responsible for the movement of the spark which will be referred to as "creep effect", has a definite dependence of the partial pressure of SF_6 , as well as the total pressure of the mixture.

With reference to Figure 5.11, the breakdown voltage-pressure characteristics of the various mixtures have a positive slope at low pressures, followed by a negative slope and thereafter the breakdown voltage remains at a low level without a definite trend. Spark trajectories at the high pressure end initiated at the point and reached the plane electrode via moderately curved paths. Reducing the pressure to the region of the nega-

tive slope, the spark initiation point moved away from the spherical tip. At the voltage maximum(1.7 bar), the creep distance along the rod electrode reached a maximum value and the spark trajectories a maximum curvature. In reducing the pressure below Pmax (to about 1.0 bar), the creep distance was reduced to zero and the curvature of the trajectories was minimized.

A typical set of results for an SF_6/N_2 mixture with 0.1% SF_6 is shown in Figures 5.15 and 5.16. Photograph 5.16(b) displays the maximum creep distance and curvature.* Observations of the rod electrode after the measurements showed that, at 1.7 bar the creep distance was as high as 3.5 to 4.0 cm.

These results indicate the existence of a space charge surrounding the rod electrode and probably extending to the interelectrode area. Also, while the curvature of the trajectory is associated with $P_{\rm max}$, the creep distance seems to depend on the partial pressure of SF6. Figure 5.17 displays how the creep distance varies with the percentage content, or partial pressure of SF6. As it is shown in photograph 5.17(d) the creep distance is reduced to zero at about 7.0% of SF6 content.

5.5.2 Impulse Coronas in SF6/N2 Mixtures With Low SF6 Content.

Impulse coronas were photographed in pressure regions and mixtures in which corona onset preceded spark onset. Ilford film 400 ASA was used and in most cases the negatives were push-

^{*} Note that the spark ends at the edge of the plane electrode

processed at 1800 to 2000 ASA. The lens used was a Caron FD, f=1.8. Figure 5.20 shows two positive impulse coronas in an SF_6/N_2 mixture with 0.2% SF_6 at 1.0 and 1.7 bar of total pressure. Both coronas show intense streamers concentrated around the spherical tip of the electrode and unlike pure N_2 and SF_6 one can observe streamers of moderate intensity surrounding the cylindrical part of the electrode. At 1.0 bar the corona streamers grow in the direction of the plane electrode, coinciding with the trajectory of the sparks at this pressure which have low curvature and zero creep distance. While the corona pulse at 1.0 bar is generated at a voltage closer to breakdown than that of 1.7 bar, the streamers associated with the latter have a considerably higher luminosity.

Figure 5.21 shows a positive and a negative corona pulse at 1.7 (Pmax) for a 0.1% SF₆ mixture. The positive corona is similar to that of Figure 5.20(b). The intensity of the streamers is somewhat higher, but again no long range streamers are observed. One would expect that streamers extending to the cathode should start above the tip, with a creep distance equal to that of the discharge. The negative corona, shows a flarelike character and advances to the anode in a curved path.

5.6 Corona Onset Measurements.

The corona onset measurements in SF $_6$, nitrogen and SF $_6$ /N $_2$ mixtures will be presented in the next chapter for comparison with the theoretically calculated streamer onset voltage.

The lowest corona onset voltage measured was that of nitrogen. It is interesting to note that mixtures with low ${\rm SF}_6$

content that exhibited a positive impulse breakdown voltage at high pressures considerably lower than nitrogen, have an onset voltage at these pressures higher than that of nitrogen.

This is shown in Figure 5.22, where the breakdown and onset voltage of a 50mm gap in 0.2% SF₆ mixture and nitrogen are plotted versus pressure. As it is seen, the onset voltage of the 0.2% SF₆ mixture is slightly higher than that of nitrogen and coincides with the breakdown voltage at the higher pressures. This behaviour is similar to that of pure SF₆ and one could attribute the voltage maximum to a corona stabilized breakdown process. However in a further discussion (chapter 7), it is suggested that there are some basic differences between the mechanism responsible for the breakdown voltage peak of the 1 to 0.01% SF₆ mixtures and that of SF₆.

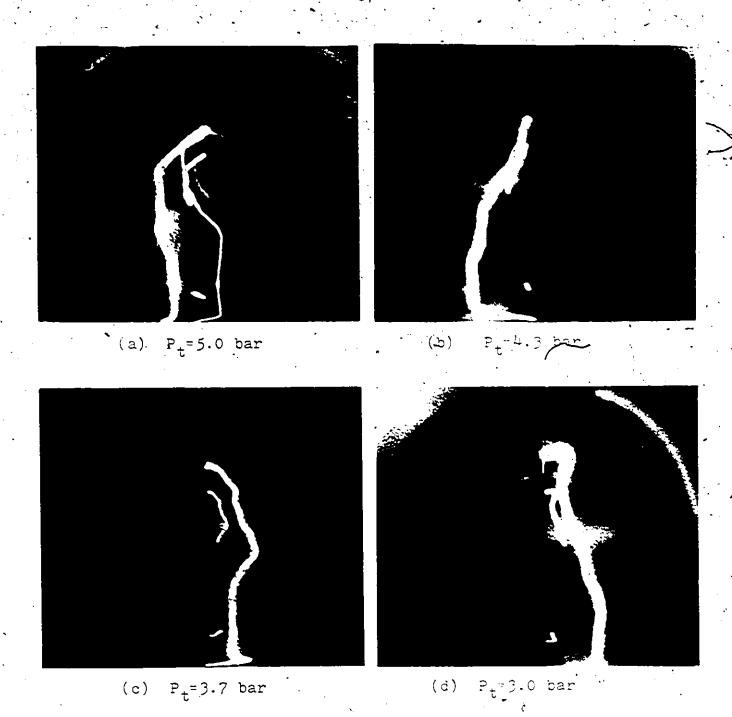


Figure 5.15. Positive impulse breakdown of a 50 mm rod-plane gap in SF_6/N_2 mixture with 0.1% SF_6 content. The effect of the total pressure $P_{\hat{\mathbf{t}}}$ on the spark initiation point is shown, for pressures of 5.0 to 3.0 bar respectively:

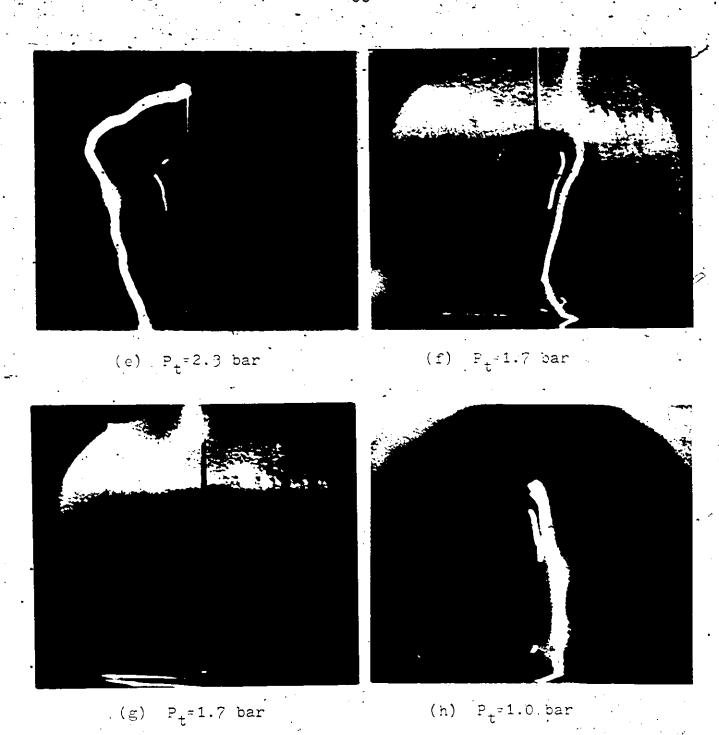


Figure 5.16. In continuation of Figure 5.15 the effect of further reduction of the total pressure P_t is shown in Figure (e) to (h) for pressures of 2.3 to 1.0 bar respectively. Finotographs (f) and (g) are taken under the same conditions, note that the spark in (g) ended on the wall of the chamber.

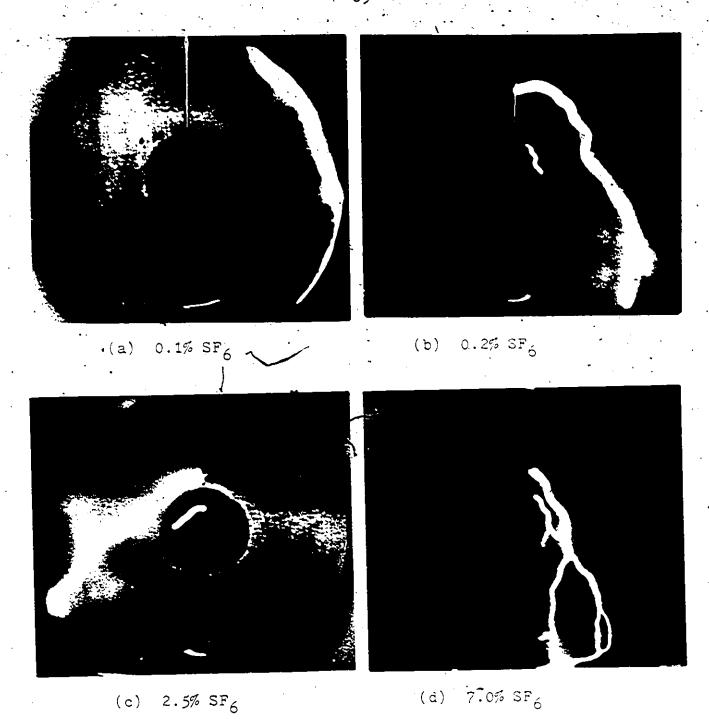


Figure 5.17. Positive impulse breakdown of a 50 mm rod-plane gap in mixtures of $\rm SF_6/N_2$ at 1.7 bar of total pressure. Photographs (a) to (d) show the effect of the % of $\rm SF_6$ content on the spark initiation point at the rod electrode.



(a) N_2 , P=5.0 bar



(b) N₂, P=1.0 bar

Figure 5.18. Positive impulse breakdown of a 50 mm rod-plane gap in Nitrogen. The effect of pressure on the spark movement through the gap is shown in photographs (a) and (b). This indicates a dependence of the positive charge concentration on the gas pressure.

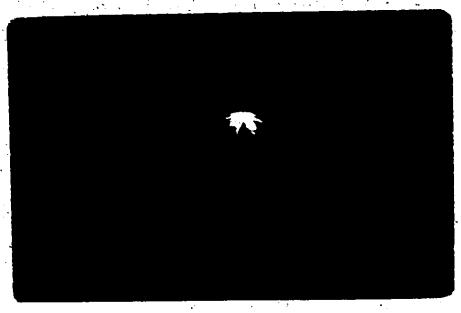


(a) SF₆, P=5.0 bar

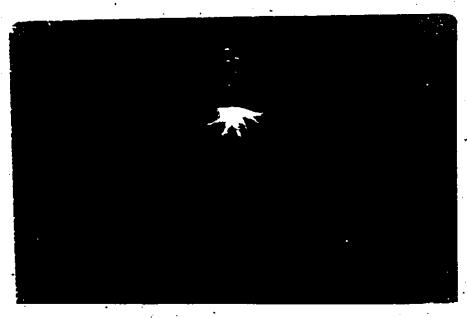


(b) SF₆, P=1.0 bar

Figure 5.19. Positive impulse breakdown of a 50 mm rod-plane gap in SF₆. The unusually high curvature of the spark trajectory at 1.0 bar (as compared to that of Figure 5.48(b)), is related to the presence of the corona stabilized breakdown mechanism at this pressure.

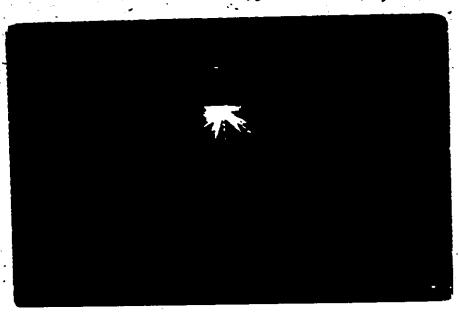


(a) 0.2% SF₆. P_t=1.0bar



(b) 0.2% SF_6 , $P_t=1.7bar$

Figure 5.20. Positive impulse coronas in an SF_6/N_2 mixture with 0.2% of SF_6 content. Photographs (a) and (b) show the difference in the position and intensity of the corona streamers, as the pressure increases from 1.0 to 1.7bar respectively.



Positive ' (a)

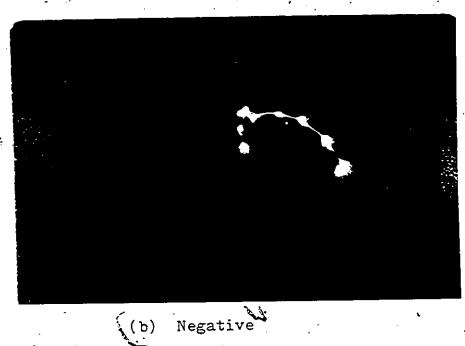


Figure 5.21. (a) Positive impulse corona in an $SF_6^{N_2}$ mixture with 0.1% of SF6 content and at a total pressure of 1.0 bar. (b) Negative impulse corona under the same mixture and pressure conditions.

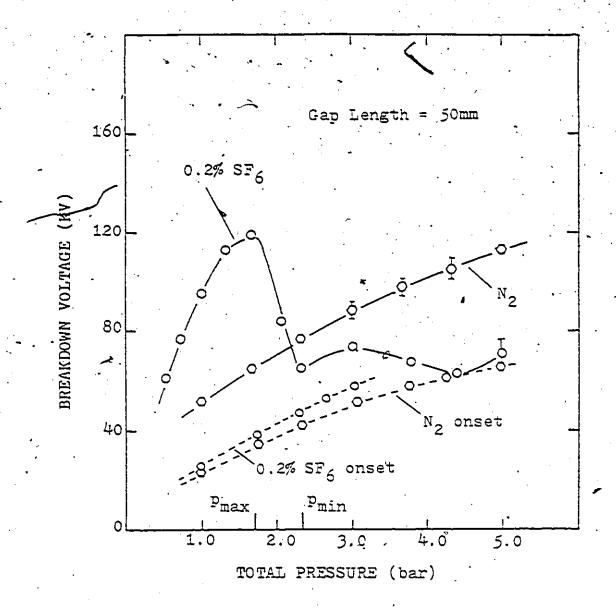


Figure 5.22 Positive rod-plane impulse breakdown and DC corona.onset voltage-pressure characteristics of nitrogen and a $\rm SF_6-N_2$ mixture with 0.2% $\rm SF_6$. Note that although: the breakdown voltage of the 0.2% $\rm SF_6$ mixture is considerably lower than that of nitrogen for pressures higher than 2 bar, the corona onset voltage of the same mixture is higher than the onset voltage of nitrogen.

CHAPTER 6

THEORETICAL ANALYSIS OF DISCHARGE CHARACTERISTICS IN SF_6 AND SF_6/N_2 MIXTURES.

The aim of this chapter is to present an informative description of the mechanism of breakdown operative under the present experimental conditions, and to calculate a number of parameters associated with corona and spark onset in SF_6/N_2 mixtures.

The streamer mechanism is briefly discussed and reference is made to various streamer formation criteria. In calculating streamer voltages in rod-plane gaps, use is made of the optimized charge simulation technique developed in chapter 3. Finally the theoretical results are discussed in conjunction with experimental results obtained in this work and elsewhere

6.1 Streamer Mechanism.

The streamer mechanism was developed to explain certain phenomena that occur in electrical discharges and are not accounted for by the Townsend mechanism. The Townsend theory is limited to uniform or near-uniform fields and constant voltage conditions during the prebreakdown developments. It is a relatively slow mechanism that requires the generation of successive avalanches prior to spark onset. In this sense, it fails to explain a number of phenomena, such as formative time lags of the order of 10⁻⁹ sec that occur in various overvolted gaps, and most of the observations associated with non-uniform fields of

symetrical or asymetrical electrodes.

The streamer theory is based on the assumption that the discharge initiates with a single avalanche, which leads to the formation of a fast moving plasma channel that bridges the gap and produces a collapse of the applied voltage. The main contributions to the development of the theory are those of Raether (11), Loeb (30) and Meek (58). Raether investigated both anode and cathode directed streamers in uniform and slightly overvolted gaps. By measuring the number of charge carriers in a single avalanche he showed that avalanches in a Townsend discharge have a carrier number 10⁶, while streamer avalanches (produced with a certain amount of over-voltage), have a carrier number of the order of 10⁸.

This additional space charge and the field produced by it were regarded as the reasons for the transition of the avalanche to an anode or cathode directed streamer. A streamer that moves from the anode to cathode for example, requires the initial avalanche to reach the anode with a carrier number of $N_c=10^8$. The rear portion of the avalanche enhances the field in that region and attracts photoelectrons which create new avalanches that attach to the old one and rapidly extend the plasma to the cathode. A condition automatically develops for a streamer formation; that is, the distance between the electrodes and the applied voltage should be sufficient for the carriers of the avalanche to reach $N_c=10^8$.

Meek developed his streamer theory from observations of a cathode directed positive corona streamer and Raether's obser-

vations of mid-gap streamers. When a voltage higher than the minimum breakdown voltage was applied across the electrodes, the mid gap streamers indicated that the field of the space charge of the avalanche is of the order of the applied field, before the avalanche reaches the anode. Meek then considered the transition from an electron avalanche into a streamer to occur when the radial field E_r produced by the positive ions at the head of the avalanche is of the order of the externally applied field.

While both Raether and Meek recognized the need of photo-electrons for the streamer propagation, they did not conduct any calculations involving photoionization. Loeb (30) developed a more explicit theory of streamer onset by introducing photoionization in the calculations via the absorption coefficient μ . Accompanying the ionization of an avalanche that yields N ions, there is an f_1N number of photons generated. The absorption coefficient μ will determine how many of these f_1N photons will be absorbed within a region close to the avalanche and the fraction f_2 of these photons that will lead to ionization. Hence on the basis of constants such as the probabilities f_1 and f_2 , and the absorption coefficient μ , Loeb developed an explicit relation for the threshold of streamer propagation, applicable for gases in which these parameters are known.

In more recent years there has been a considerable number of publications dealing with a variety of refinements of the streamer theory. The influence of different secondary processes has been investigated for various gases, including electronegative

insulants such as SF₆, for a number of electrode arrangements and gaps ranging from meters to millimeters.

To summarize, some of the properties of streamer break-down include, concentration of the discharge in a narrow channel with branches and abrupt changes in direction, high discharge currents before the avalanche space charge diffuses to the cathode (negative cathode), propagation of a streamer without any contribution from the cathode, high speed propagation that results in short formative time lags, and absence of this mechanism in rare or atomic gases.

6.2 Application of Streamer Theory for Calculating Streamer Onset Voltages in SF_6 and SF_6/N_2 Mixtures.

The main feature of the streamer mechanism is the perturbation of the applied field by the space charge of the initial avalanche and the effect of that perturbation on subsequent ionization. A number of streamer onset criteria in SF6 have been developed over the years, most of them based on analytical calculations of Raether, Loeb and Meek. Loeb and Raether performed a number of calculations on the influence of the space charge on the ionization coefficients and successor avalanches. Relatively recent computer accessibility has allowed many workers to carry out many of these analytical calculations and in almost all cases there is reasonable agreement with experiment. However, most of these calculations apply to uniform or quasi-uniform electrode geometries. The reason for this is that under non-uniform fields the mechanism of breakdown in SF6 is far from being clear. There

is a lack of knowledge of constants such as: secondary ionization coefficients, absorption coefficients, and various probabilities of excitation, attachment, and detachment under these conditions. Variables measured under uniform field conditions do not show any unusual pressure behaviour that would account for the negative slope of the breakdown voltage-pressure characteristics of SF5. Hence calculations that make use of uniform field and low presswre data should not be expected to exhibit a behaviour as complex as that of the SF breakdown voltage-pressure characteristics. This is shown in a recent attempt of Khalifa et al (60) to calculate positive spark-breakdown of SF in non-uniform fields. Using Loeb's streamer criterion as presented by Nasser in his book (63), and α , η , $\mu(p)$, f_1 , and f_2 * derived under uniform field conditions, they obtained a monotonically increasing breakdown voltage-pressure characteristic. Khalifa's relation does not apply to-non-uniform fields any more than Nitta's simplistic relationship (59) which is used for quasi-uniform field distributions, and was shown by the authors to be within 10% of their own calculations.

In the following section, streamer onset calculations in SF_6 are carried out using the onset criteria of Pederson (61,62) and Nitta (59). Pederson's criterion is also used for calculations in SF_6/N_2 mixtures, with Baumgartner's effective ionization coefficient for SF_6/N_2 as given in chapter 2.4.

^{*} f_1 is the ratio of excited to ionized states and

 f_2 is the probability of photoionization

6.3 Streamer onset Voltage Calculations in SF6. N2 and SF6/N2.

As mentioned earlier, Raether proposed that avalanche to streamer onset will occur when the number of charge carriers in a single avalanche reaches $N_c=10^8$. For SF₆, the total number of free electrons will be given by

$$N = N_0 \exp(\int_0^x (\alpha - \eta) dx)$$
 (6.1)

where No: the initial number of electrons

α: ionization coefficient

n : 'electron attachment coefficient

In Raether's criterion, $N=N_{\rm C}=10^8$. This number was shown to be independent of the gas and field uniformity. Nitta (59), using Raether's criterion and assuming that the field distribution near the surface of the highly stressed electrode is the same as that of two concentric spheres, with the radius of the inner sphere equal to the radius of curvature of the highly stressed electrode, developed the following relationship for predicting streamer onset or breakdown of SF₆ in quasi-uniform fields.

$$V_{n} = (E/p)_{cr} \cdot u \cdot p \cdot G \cdot (1 + \frac{k}{\sqrt{pR}})$$
 (6.2)

where $2 (E/p)_{cr} : 89 \text{ KV cm}^{-1} \text{ bar}^{-1}$

u : utilization coefficient.

p : gas pressure in bar

G : gap length in cm

 $k : 0.175 \text{ bar}^{\frac{1}{2}} \text{ cm}^{\frac{1}{2}}$

and R: the radius of curvature of the highly stressed electrode.

The calculated values of breakdown voltage V_n were found to be in good agreement with experimental results of rod-plane, rod-rod, and sphere-sphere electrode arrangements in pressures less than 5.0 bar (82). The only unknown in the above equation is the utilization factor u which is equal to the (average field)/(maximum field) or E_{av}/E_{max} . E_{max} is the field at the surface of the highly stressed electrode, which in this case is the hemispherical tip of the rod electrode. In the present calculations, the field along the axis of highest field strength in a rod-plane gap is given by,

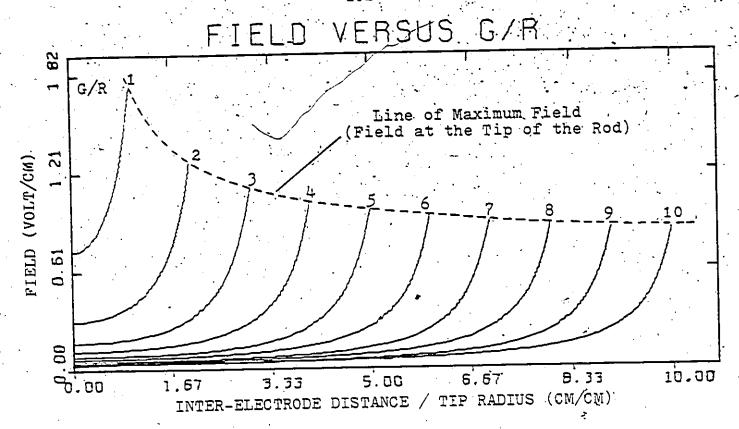
$$E(z) = \sum_{i=1}^{9} Q_{i} \left[\frac{R + (z_{i}' + z) / ((z_{i}' + z)^{2})^{\frac{1}{2}}}{z_{i}' + z + ((z_{i}' + z)^{2})^{\frac{1}{2}}} + \frac{R + (z_{i}' - z) / ((z_{i}' - z)^{2})^{\frac{1}{2}}}{z_{i}' - z + ((z_{i}' - z)^{2})^{\frac{1}{2}}} \right]$$

$$+ Q_{10} \left[\frac{z_{10} + z}{((z_{10}' - z)^{2})^{3}} + \frac{z_{10} + z}{((z_{10}' + z)^{2})^{3}} \right]$$

$$(6.3)$$

The above equation is a derivative of equation 3.6 with respect to z and the values of the charges Q_i and their position z_i are those obtained with the charge simulation technique. $E_{\rm max}$ is obtained by setting z equal to the gap length G. Figure 6.1 shows the field distribution along the z-axis of a rod-plane gap for different G/R ratios. A reference table of utilization factors up to G/R=500 is presented in Appendix 3.

Pedersen (61,62) proposed a semiempirical quantitative breakdown criterion on the basis of Meek's (58) streamer onset relationships. In an approximated form, this is given by,



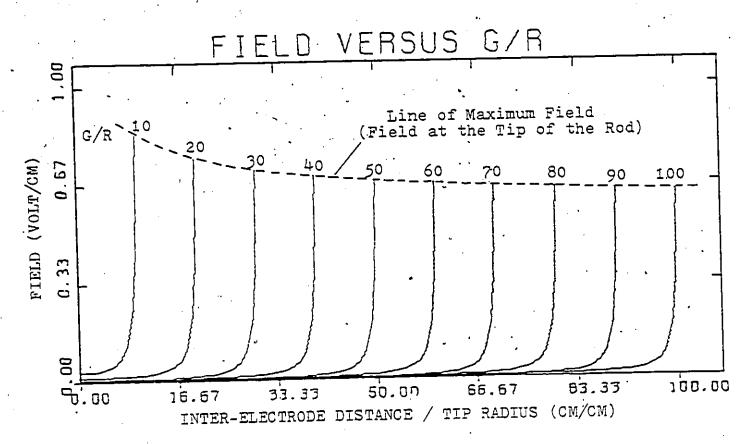


Figure 6.1 Field distribution along the axis of a rod-plane gap for various gap ratios G/R.

$$\int_{0}^{z} (\alpha - \eta) dz = K$$
 (6.4)

where z_c : critical length of the avalanche K: a constant equal to 10.5

The ionization and attachment coefficients can be expressed as functions of the pressure and the applied field by the relation (see chapter 2.3)

$$(\alpha - \eta)/p = C(E(z)/p - (E/p)_{er})$$
 (6.5)

where E(z) is the field along the z-axis given by the equation (6.3). At the point z_0 where an electron initiates the first avalanche, equation (6.5) can be written as

$$\alpha - \eta \Big|_{z=z_0} = p C(E(z)/p - (E/p)_{cr}) = 0$$
 (6.6)

The above equation is solved for z_0 using the Dichotomous technique (that is by a univariant search). Having found z_0 , equation (6.4) can be written in the form

$$\int_{z_0}^{G} p \, c \, (E(z)/p - (E/p)_{cr}) = K$$
 (6.7)

where G is the value of z at the surface of the hemispherical tip. The LHS of equation 6.7 is evaluated and compared to K. A higher

^{*} Pedersen had initially given K a value equal to 18.0, but in a later publication (62) he showed that K=10.5 is a more appropriate value for SF₆. Note that with K=18.0 equation (6.4) is equivalent to equation (6.1) with $N_0=1$

or lower value than K will indicate if the voltage applied to the electrode will be lowered or increased respectively. A change in the applied voltage will result in a change of the values of the field E(z), hence, equation 6.6 is solved again for z_0 and the process is repeated. When the LHS of equation 6.7 is equal to K, the applied voltage is equal to the breakdown or streamer onset voltage of SF_6 , for the particular rod-plane gap (defined by G/R) and pressure p.

Calculation of streamer onset voltages in nitrogen and $\rm SF_6/N_2$ mixtures were carried out in a similar fashion, using Pedersen's criterion of equation 6.4. Equation 6.5 was substituted by equation 2.2 for nitrogen and equation 2.5 for $\rm SF_6/N_2$. mixtures.

6.4 Comparison of Theoretical and Experimental Results.

Figures 6.2 to 6.5 show the corona onset voltage-pressure characteristics for nitrogen and SF₆ in 10mm and 50mm gaps and pressures ranging from 1 to 5 bar. The experimental results show that the negative corona onset voltage is in all cases lower than the positive onset voltage.

As it is seen in Figures 6.2 and 6.3, the theoretical streamer onset voltage of nitrogen is at best 50% lower than that of the negative corona onset. Similarily, Figures 6.4 and 6.5 show that in SF₆ the theoretical results are also considerably lower than the experimental ones. An error analysis is in order at this point to determine if such differences between the theoretical and experimental results are due to errors involved

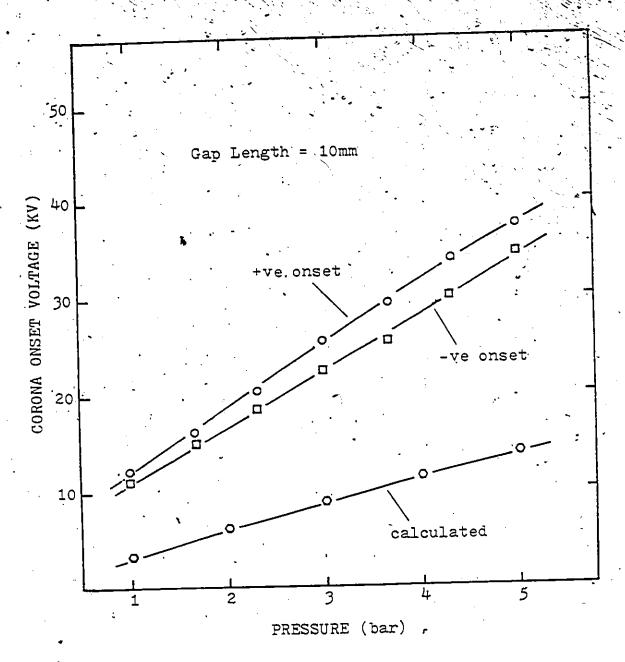


Figure 6.2 Experimental and theoretical corona onset voltage-pressure characteristics of a 10mm rod-plane gap in nitrogen. The theoretical results are derived from equation 6.4 with K=18 and α as given by equation 2.2.

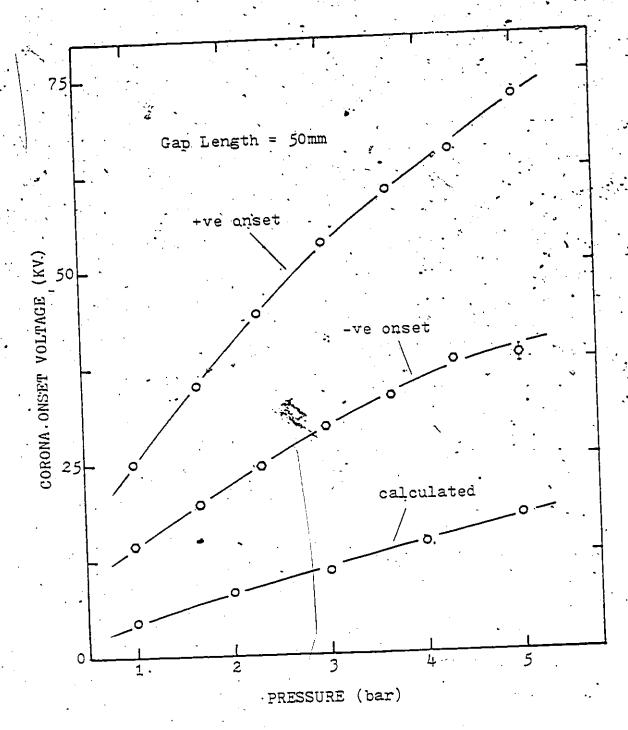


Figure 6.3 Experimental and theoretical corona onset voltage-pressure characteristics of a 50mm rod-plane gap in nitrogen. The theoretical results are derived from equation 6.4 with K=18 and α as given by equation 2.2.

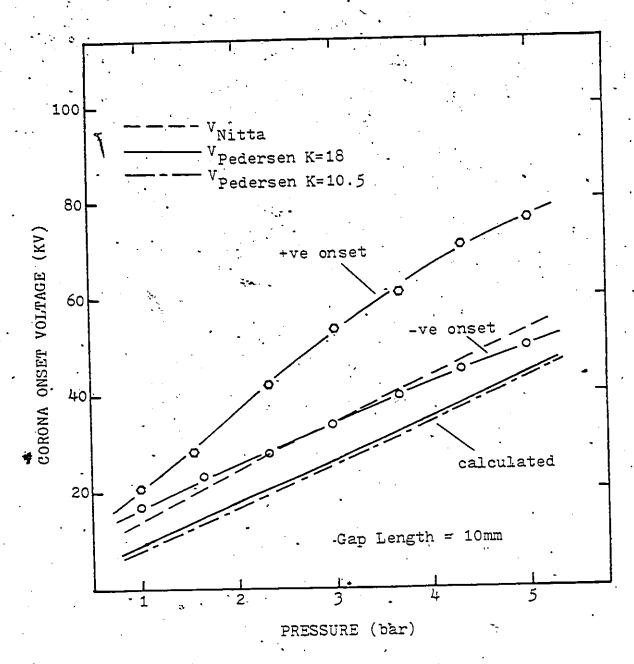


Figure 6.4 Experimental and theoretical corona onset voltage-pressure characteristics of a 10mm rod-plane gap in SF₆. The theoretical values of the onset voltage are calculated with both Nitta's and Pedersen's criteria using equations 6.2 and 6.4 respectively.

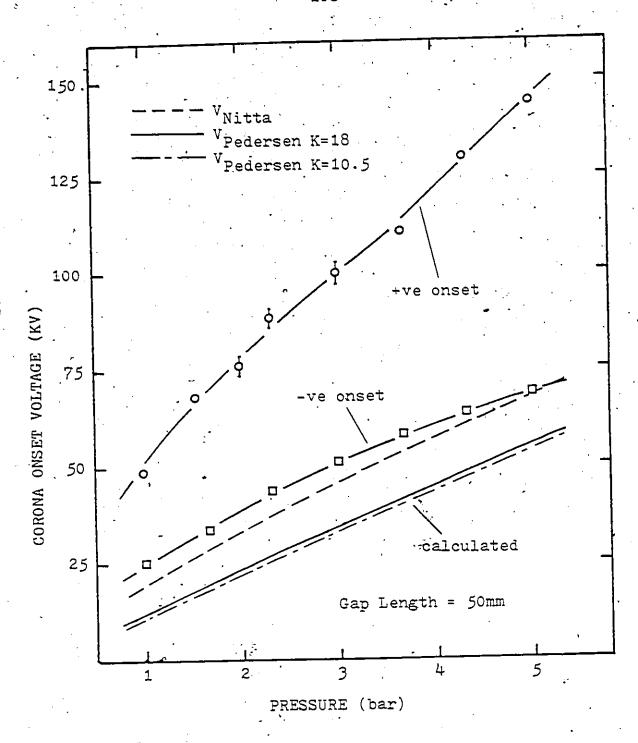


Figure 6.5 Experimental and theoretical corona onset voltage-pressure characteristics of a 50mm rod-plane gap in SF₆. The theoretical values of the onset voltage are calculated with both Nitta's and Pedersen's criteria using equations 6.2 and 6.4 respectively.

in the measurement or calculation of the corona onset voltage, or, the failure of the streamer onset criteria to make an accurate prediction of the streamer onset voltage under the present experimental conditions.

Experimental errors could involve uncertainties introduced in the system by such factors as, voltage measurement, accuracy of gap length, pressure measurement, dimensions of the rod electrode, and other less defined parameters such as impurities in the gas volume and the electrode surface. From the measurable parameters, the magnitude of the measured voltage is the largest single source of uncertainty in the system. The output of the HVDC generator (which was measured with a digital voltmeter connected to the generator's feed-back loop) was calibrated with a high voltage resistance divider. The accuracy of the HV divider was better than 1% and hence the total error in the measured values of the output of the HVDC generator for a fixed gap length and pressure, is expected to be less than 3-5%.

In the theoretical calculations errors can arise from mis-representation of the experimental system by a semi-infinite rod electrode and an infinite plane electrode. Kuffel and Husbands (80), Binns (81), and Singer (45) have studied the effect of nearby earth objects to a spark gap, both from a theoretical and experimental point of view. Their results show that for the present experimental system, inclusion of the chamber walls in the calculations would have reduced the theoretical values of the onset voltage by as much as 1-2%. In addition, the finite size of the plane electrode is expected to

result in lower field factors and therefore lower onset voltages. Kratzenstein (83) has shown that for a similar electrode arangement, the error in the calculated values of the utilization factor was less than 0.1% for d/D less than 0.1 (d=gap length, D=diameter of the plane electrode) and 3.0% for d/D=0.4, which corresponds to a 50mm gap in the present system. These arguments indicate that the theoretical results could be in error by as much as 2-5% and that a more rigorous analysis would have decreased the present values by that amount.

Thus the difference between the theoretical and experimental results of nitrogen (Figures 6,2 and 6.3) is too large to be accounted for by a systematic error. Similarly, Figures 6.4 and 6.5 show that for SF6, although Nitta's equation gives satisfactory results, onset values by Pedersen's criterion are considerably lower. A small difference was nowever anticipated; streamer onset voltages in SF6 derived by Nitta's or Pedersen's criteria could be either lower or even higher than the experimental ones (82), depending on uniformity and surface condition of the A good agreement is usually expected for electrode electrodes. In figure 6.6 geometries with quasi-uniform field distribution. streamer onset voltages calculated with equation 6.4 (K=18) are compared with Sangkasaad's experimental results. of the quasi-uniform field gap (d=10mm, r=10mm, d/r=1) the calculated streamer onset voltage is in good agreement with the expe-For the less uniform gap (d=20mm, r=1mm, rimental spark onset. d/r=20) although the calculated corona onset does not seem to be considerably lower than that of the negative and AC onset, the

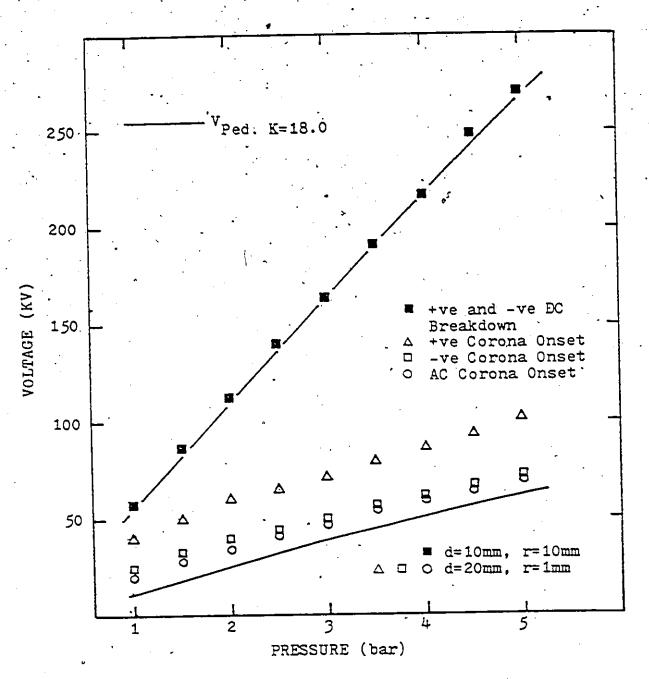


Figure 6.6 Comparison of Sangkasaad's (54) experimental results of breakdown voltage and corona onset of SF₆ in rod-plane gaps, with streamer onset values calculated by equation 6.4.

difference is approximately 50% at 1 bar of pressure.

In SF_6/N_2 mixtures, the calculations of the streamer onset voltage are carried out in a similar manner. Pedersen's criterion of equation 6.4 is used with K=18, since as shown in Figures 6.4 and 6.5, this gave an inbetween value of onset voltage, with respect to onset voltages obtained with K=10.5 and Nitta's expression of equation 6.2. Equation 6.5 was substituted by Baumgartner's effective ionization coefficient of equation 2.5, which relates the effective ionization coefficients of the different SF_6/N_2 mixtures with those of SF_6 and nitrogen through a weighting factor—that depends on the partial pressure of the component gases. This means that for one hundred percent of either SF_6 or nitrogen the calculated values of the streamer onset voltage will be the same as those derived by equations 6.5 and 2.2 respectively.

Thus, observation of Figures 6.2 to 6.5 should indicate the degree by which the corona onset voltage in SF_6/N_2 , mixtures can be predicted, at least in the neighbourhood of 100% SF_6 or 100% N_2 . Figures 6.7 and 6.8 demonstrate this by showing that if the behaviour of the corona onset voltage for various SF_6/N_2 mixtures is similar to the pattern exhibited in the breakdown characteristics of the mixtures under uniform conditions (Figure 2.1(a)), one should expect the calculated corona onset levels to be as accurate as those of the individual gases.

The agreement between the experimental results and equation 6.4 in Figures 6.7 and 6.8 could improve if Pedersen's criterion resulted in a more accurate prediction of the corona

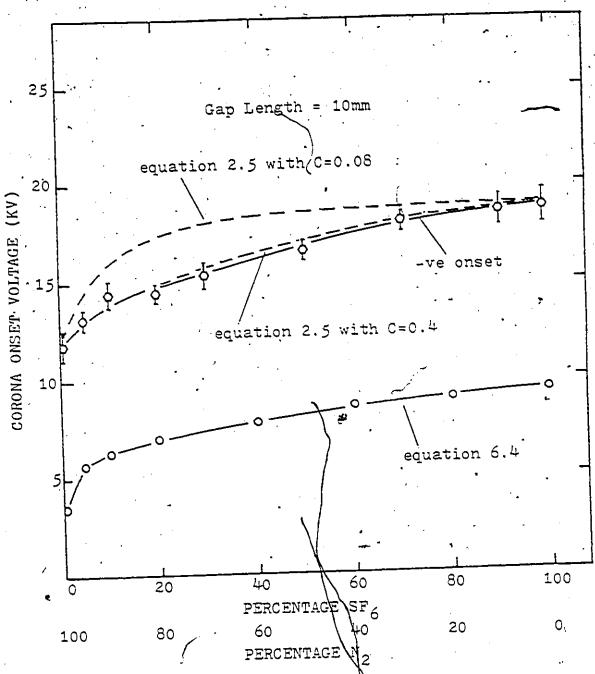


Figure 6.7 Experimental and theoretical corona onset voltage-mixture matio characteristics of a 10mm rod-plane gap in SF $_{6}$ N_{2} mixtures. The theoretical values of the onset voltage are calculated using Pedersen's criterion (equation 6.4, with K=18 and α - as given by equation 2.5) and also Takuma's empirical equation with C=0.08 and C=0.4.

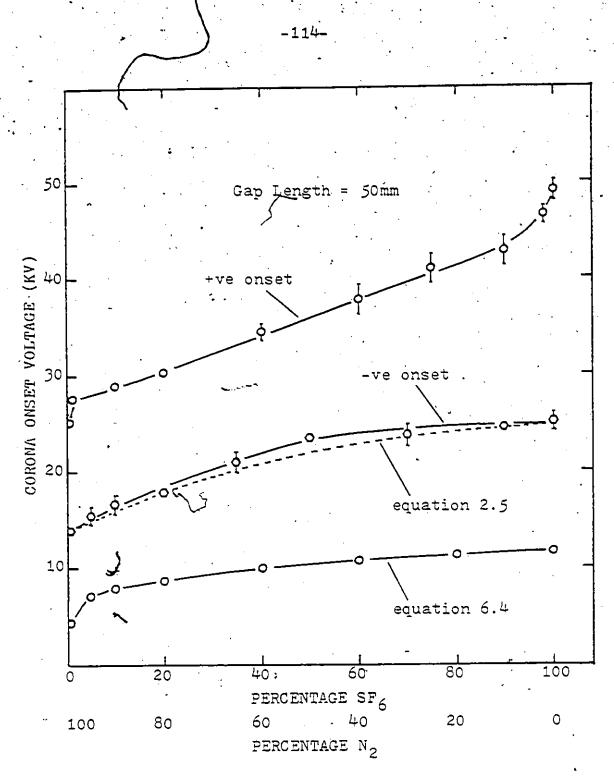


Figure 6.8 Experimental and theoretical corona onset voltage-mixture ratio characteristics of a 50mm rod-plane gap in SF_6/N_2 mixtures. The theoretical values of the onset voltage are calculated using Pedersen's criterion (equation 6.4, with K=18 and α as given by equation 2.5) and also Takuma's empirical equation 2.4 with C=0.4.

onset voltage in the individual gases under the same experimental conditions. An example of this is given in Figure 6.9, in which a good agreement is shown between experimental and theoretical results for SF_6/N_2 mixtures in a quasi-uniform rod-plane gap. Results of comparable accuracy can also be obtained for the present electrode configurations by making use of the empirical equation of Takuma and Watanabe (37) (equation 2.4), which makes use of the experimentally found onset voltages of 100% SF_{6} , 100% N_2 and the partial pressures of the two gases. stant C in equation 2.4 acts as a form factor that regulates the convergence of V_m to V_1 (N_2) , as the partial pressure of SF $_6$ is Takuma and Watanabe showed that for C=0.08 there is a good agreement between equation 2.4 and Howard's experimental results of Figure 2.1(a). However for the results presented in Figures 6.7 and 6.8 it was found that equation 2.4 gives a better fit for C=0.4.

Figure 6.10 shows the critical length of the avalanche $z_{\rm c}$ plotted for different ${\rm SF}_6/{\rm N}_2$ mixtures for a 5mm gap. As it is seen, the critical length $z_{\rm c}$ is relatively small for 100% ${\rm SF}_6$ and it increases abruptly as the ${\rm SF}_6$ content is reduced below 5%. Table 6.1 shows the streamer onset voltage and the critical length of the avalanche $z_{\rm c}$ for 10mm and 50mm gaps in ${\rm SF}_6/{\rm N}_2$ mixtures. For 100% ${\rm N}_2$, $z_{\rm c}$ is of the same order of magnitude as the radius of the hemi-spherical tip of the rod electrode (R=0.8mm), and much smaller than R as the ${\rm SF}_6$ content of the mixture increases. This indicates that for highly diverging fields the onset voltage depends mainly on the magnitude of the

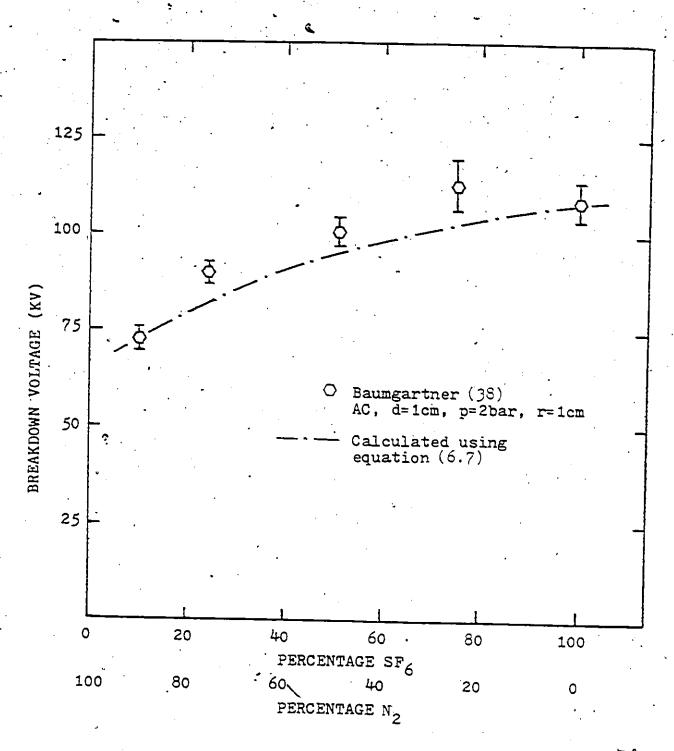


Figure 6.9 Comparison of experimental AC breakdown results of a rod-plane gap in mixtures of N_2 and SF_6 , with calculated ones using equation (6.7)

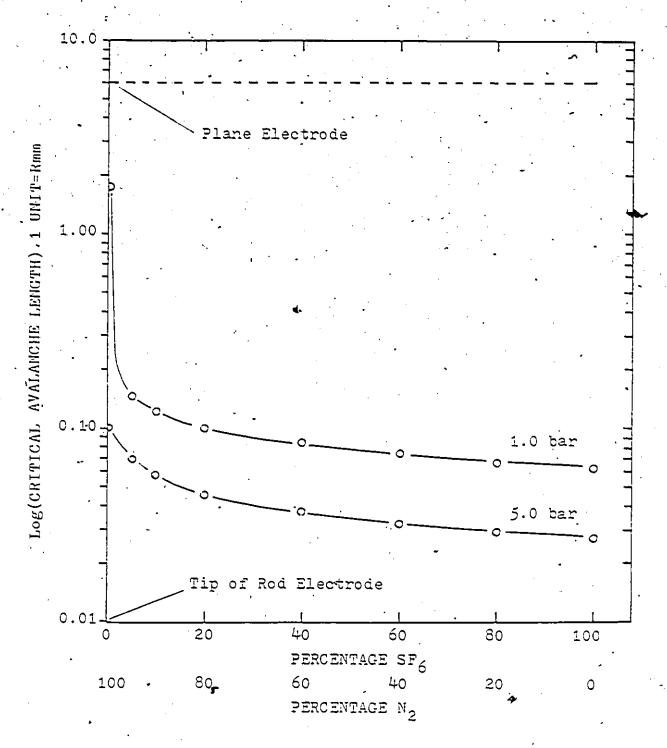


Figure 6.10 $^{\circ}$ Critical length of initial avalanche (z_c), for a 5 mm rod-plane gap in SF $_6/N_2$ mixtures at a total pressure of 1.0 and 5.0 bar. (r=0.8 mm, d/r=6.25)

Table 6.1. Streamer onset voltage Vonset and critical length of the avalanche z for 10mm and 50mm gaps in SF6/N2 mixtures at a total pressure of 1.0 bar.

7 0 6			
<u> 10 mm gap</u>	<u>Utilizaton Factor</u> :	=	0.096

% SF ₆	Vonset (V)	z _e (mm).
0.0	3158	0.9568
5.0	5408	0.1118
10.0	5941	0.0937
20.0	6608	0.0773
40.0	7475	0.0636
60.0	8085	0.0563
80.0	8466	0.0511
100.0	8800	0.0475

50 mm gap	Utilization Factor = 0.024
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% SF ₆	Vonset (V)	z _c (mm)
0.0	4277	0.9778
5.0	7294	0.1162
10.0	8000	0.0967
20.0	8913	0.0798
40.0	10063	0.0656
60.0	10825	0.0578
80.0	11381	0.0522
100.0	11841	0.0490

field in the neighbourhood of the rod-electrode. The maximum field however, varies very little for high values of G/R (see table of Appendix 3) and hence the onset voltage-gap length characteristics are expected to saturate as the gap length G increases. This can be seen in Table 6.1, where the difference in the values of $V_{\rm onset}$ between the 10mm and 50mm gaps is relatively small.

6.5 <u>Discussion</u>

The charge simulation method, combined with optimization techniques to solve Pedersen's criterion for streamer onset'voltages was found to be efficient and relatively easy to implement. Unlike other techniques (7) that require a good estimate of the breakdown voltage to assure convergence, the present method converged to the right value irrespectively of the initial value of the applied potential. Computing time for the solution of equation 6.7 was relatively small and could be reduced further by replacing the Dichotomous technique (that was used in equation 6.6), with the Fibbonacci or the Golden Rule methods. The advantage of using the charge simulation technique to calculate the field distribution of a particular electrode geometry, is that, streamer modelling can be handled in a quasi-analytical manner.

Apart from calculations using Nitta's and Pedersen's relations, the author carried out calculations based on a number of other models such as, Meek's critical field criterion (58), Khaled's ring charge model (71), and a hybrid of the two. In the latter one, the charge accumulated in an avalanche was calculated

in steps, assuming that it is concentrated in spheres of increasing diameter. The ionization and attachment coefficients were calculated ahead of every sphere taking into account the pertubation of the field from the accumulating charge. The results showed that in all models (including Nitta's and Pedersen's), the calculated onset voltages were within a few percent of each other, thus presentation of elaborate modelling was considered unnecessary.

The results presented in Figures 6.2 and 6.3 show that for nitrogen, the calculated onset voltages using equation 6.4 were at best 50% lower than the experimental ones. This large discrepancy cannot be accounted for by errors in either the experimental or the theoretical results. However the effect of parameters such as impurities in the gas volume and on the electrode sorface is not very clear. The engineering nature of the experiment did not allow high purity conditions that could have resulted from degasing of the electrodes and evacuation of the chamber to pressures better than 10⁻⁵ torr. As described in chapter 4, measurements in 100% No were taken after evacuating the chamber to $10^{-1}-10^{-2}$ torr, flushing it with nitrogen and then evacuating it again. With this procedure, possible traces of $\mathbf{0}_2$ or residual traces of \mathbf{SF}_K are expected to be present in amounts less than 0.01% of the minimum working pressure (760 torr).

Weissler's (15) corona onset results of nitrogen in point-to-plane gaps (ranging from 3.1 to 4.6cm) show that the negative onset voltage of pure nitrogen (3700V) is increased to 4300V with the addition of 0.1% 0_2 . Similarily, the results

of Figure 5.22 show that the onset voltage of nitrogen increases substantially with the addition of 0.2% SF₆.

So, although an increase in the experimental values of the nitrogen onset voltage can be expected due to impurities in the gas volume, its magnitude cannot be determined due to their undefined character and amount. However it should be noted that Weissler's results (15) and those of the Figures 6.7 and 6.8, indicate that the onset voltage increases as the percentage of the impurity increases and thus the increase of the onset voltage for impurity contents less than 0.01% is not expected to be high. In conclusion, the difference between the experimental and theoretical results of Figures 6.2 and 6.3 is much higher than any onset voltage increase that one could expect from impurities in the gas volume.

Figures 6.4 and 6.5 show that for SF₆ the calculated onset values are within 50 to 10% of the measured ones for the 10mm gap and 50 to 20% for the 50mm gap. As it is seen, the calculated onset voltage-pressure characteristics are lower than the experimental ones and have approximately the same slope. As a result of this, the discrepancy is higher at the lower pressures, with a maximum deviation of 50% at 1 bar.

The incapability of making an accurate prediction of the onset voltage in nitrogen and at low pressures of SF_6 , is reflected in Figures 6.7 and 6.8, where the onset voltages of a 10mm and a 50mm gap are plotted for different mixture ratios. These results indicate that the calculated onset characteristics using Baumgartner's ionization coefficient of equation 2.5, exhibit

a behaviour similar to that of the experimental results, disiplaced however by an amount relative to the 100% SF6 and 100%. $\rm N_2$ onset levels. In addition, the use of Takuma and Watanabe's empirical relation of equation 2.4 showed that different form factors (constants C) are required to fit the present results of Figures 6.7 and 6.8 and Howard's experimental results of Figure 2.1(a) (37). Baumgartner's coefficient of equation 2.5 has a fixed relationship between the partial pressures of the two gases and their corresponding ionization coefficients and thus, it makes no provisions for any anomalous behaviour of the onset voltage between 100% SF6 and 100% $\rm N_2$.

In conclusion, it could be stated that the use of Baumgartner's ionization coefficient is limited to uniform and probably quasi-uniform field configurations. Future improvements in the calculation of onset voltages in SF $_6/\mathrm{N}_2$ mixtures are expected to be associated with experimentally measured ionization and attachment coefficients.

CHAPTER 7

DISCUSSION AND INTERPRETATION OF THE EXPERIMENTAL RESULTS.

The results of the present work indicate that the dielectric behaviour of different SF_6/N_2 mixtures under both impulse polarities is much more complex than that of the individual component gases in their pure form. In general, SF6 mixtures lack investigation and relatively little is known of the various reactions and reaction rates between SF and different gas molecules. SF_6 and its ions $(SF_6^7, SF_5^7, F^7, SF_4^7, F_2^7, SF_3^7)$ are not expected to react chemically with nitrogen. Charge transfer (72) and three body reactions will however involve both molecules, but the significance of such-reactions is not known. transfer reactions in particular, are of little importance under impulse voltage conditions due to the quasi-static nature of the It is also important to note that the rate of two body reactions in SF6 such as, the associative and dissociative attachment reactions presented in Chapter 2.3 will proceed at a rate independent of the carrier gas. The collisional stabilization of SF_6^- at pressures of about 1 torr occurs so fast that the nature of the third body (nitrogen) is not very important (25). Davis and Nelson (85,86) have shown that the apparent rate const--ant for the production of negative ions in SF_6 mixtures with low ${\rm SF}_{\rm K}$ concentrations remained constant for a variety of different SF₆ mixtures (including SF₆/N₂, SF₆/H₂, SF₆/He, SF₆/CO₂..).

Factors that are expected to play an important role in the dielectric properties of the different $\rm SF_6/N_2$ mixtures will depend mainly on the molecular structure of the individual gases.

The nitrogen molecule, although not as complex as the SF₆, has metastable and active states which could affect the secondary ionization process of the different mixtures. The nitrogen metastables have been long known to interact with gas impurities such as mercury (74) and produce a Penning effect, large enough to alter the value of the first Townsend coefficient of ionization. The metastable states in nitrogen* have a relatively long lifetime (1-2 sec), that allows them to store energy which is released upon a collision in either the gas volume or the surface of the electrodes. From the latter type of collision, secondary electrons will be emitted with an energy and efficiency depending on the nature of the electrode material and the energy of the metastable state. In the gas volume, a collision or an absorption of a photon will usually result in an energy transfer or a radiative emission.

SF₆ exhibits a relatively low photon absorption in the visible part of the spectrum. It has however, a number of broad absorption peaks in the ultra violet region, followed by an absorption continuum that starts sharply at the ionization wavelength $(780A^{\circ})$ (28, 68, 69). The relatively high absorption of SF₆ and its variation with pressure and mixture ratio could introduce significant changes in the ionization coefficients of

^{*} Some of the metastable states are: $A^3\Sigma_u^+ = 6.1 \text{ev}$, $B^{\cdot 3}\Sigma_u^- = 8.1 \text{ev}$ $\alpha^{\cdot 1}\Sigma_u^- = 8.3 \text{ev} \text{ and } \alpha^1\pi_g = 8.5 \text{ev}. \quad \text{Potential curves for N}_2, \text{ N}_2^+$ and N_2^- are also given in reference (70).

the mixtures, by enhancing the effects of secondary mechanisms such as photoionization and thus altering the space charge distribution in the inter-electrode region.

The number of unknowns involved in the interaction of SF_6 with nitrogen under the different experimental conditions rule out a quantitative interpretation of the results. The discussion in this chapter includes negative polarity effects, negative coronas, positive polarity effects in mixtures with high and low SF_6 content, positive coronas, and qualitative interpretations when results obtained in this work (and/or elsewhere) allowed.

7.1 Negative Rod-Plane.

The negative rod-plane data shows that at low pressure and gap length, the breakdown voltage of the mixture is nearly proportional to the SF6 content. At higher gap length and pressure, as shown in Figure 5.7, the SF6/N2 mixture looses most of its differential strength at relatively high contents of SF6. It is not known why such little amounts of nitrogen can result in such a dramatic decrease in the breakdown voltage. A somewhat similar behaviour has been noted to occur in mixtures of N2/O2 (Loeb's discussion on results of Huber, and Mohr and Weissler, reference (16) p. 244.). The breakdown voltage of the N2/O2 mixtures was found to decrease slightly in going from 20% to 70% O2. Loeb's interpretation of this effect is based on the suppression of the negative ion sheath through a reduction of the photoionization in the gas.

Under the present experimental conditions it is not known if the photoionization in the gas volume has either been decreased or increased with the addition of nitrogen in SF6. Blair's et-al. (66,67) absorption measurements of SF_6/N_2 mixtures with $0\%(100\% N_2)$, 10%, 20% and 100% SF_6 at 1 bar of total pressure show that the apparent absorption coefficient of the mixtures (in the range of 900A° to 1500A°) increases with the content of SF6. This however does not imply that the number of photons absorbed per unit length during the ionization process will be a maximum for 100% SF6. Nitrogen, has a large number of electronic transitions in the visible-ultraviolet region and addition of nitrogen into SF6 could increase the total photon emission in this region. Thus, a mixture that has for example 20% SF_6 could absorb more photons in a certain region of the spectrum than pure SF_6 at the same total pressure The photomultiplier traces of Figure 5.13(c) show that. the corona pulses become more visible as the percentage content of nitrogen in the mixture increased. This indicates that the light emitted in the visible range during the formation of the corona streamers has increased, since SF6 is optically transparent in this region (29) and the reduction of its partial pressure is not expected to alter the absorption characteristics of the mixture.

Figure 5.21(b) shows that ionization starts at the tip of the cathode and electrons are initially repelled along the lines of force in a space charge perturbed diverging field.

 ${\rm SF}_6$ will form most of its negative ions in the field reg-

ions where the electrons move slowly enough to undergo resonance capture reactions, which require electron energies less than 1 ev. These electrons are produced either by photoionization, or, they are created by decaying streamers and have escaped recombination. If the number of negative ions was proportional to the amount of SF₆ in the mixture, one would expect the breakdown voltage to increase proportionally to the percentage of SF₆. The results of Figure 5.7 indicate that this is not true for high values of pressure and gap length, where the breakdown voltage drops sharply as the percentage of SF₆ is reduced below 100%.

A reduction of the mean free path of photons with the addition of nitrogen could have accounted for the sudden drop in the breakdown voltage, through a decrease of the photo-ionization in distant regions where the photoelectrons would be slow enough to produce negative ions (16). However as previously indicated, there is no detailed information on the absorption coefficients of the different SF₆/N₂ mixtures to either substantiate or refute the latter argument.

Apart from the effect of photoionization on the rate of production of negative ions, one should also consider the probable changes in the rate of their destruction. It is possible that the rate of detachment of electrons from the SF6 negative ions has increased greatly in the presence of the excited or metastable nitrogen molecules. Massey (75) indicates that one of the most efficient detachment reactions is,

$$A^{-} + B^{*} - A + B + e$$
or $SE_{6}^{-} + N_{2}^{*} - SE_{6} + N_{2} + e$ (7.1)

where N_2 is an excited, or metastable nitrogen molecule. The above reaction occurs when the energy of N_2 is higher than the electron affinity of SF_6 (or SF_5), and the excess energy is transfered to kinetic energy of the released electron (75). The free electron will in most cases be captured through an attachment process or it will recombine with a positive ion. This however depends on its energy, the mean free path between collisions, and the direction of the applied field. That is, the significance of the detachment process as a whole will be expected to vary with gas pressure, partial pressure of SF_6 and polarity of the gap.

7.2 The Negative Impulse Corona.

The negative corona of Figure 5.21(b) provides a reasonable illustration of the spatial growth of the corona streamers under negative impulse conditions. Photographs obtained by Watanabe and Takuma (5) under similar conditions show that the flare-like character of the streamers is not affected much by the changes in the gap length or the percentage content of SF₆.

The initial streamers (first generation) propagate towards the anode along a curved path due to the perturbation of the applied field by a space charge. Moving in a diverging field, mutual repulsion forces them to diffuse in space and create the flare-like effect. During the expansion of the initial streamers, the small gap between the space charge and the cathode is bridged either by slight movement of the positive charges or field emission. Some of the electrons are then expected to flow into the space charge to neutralize the positive The streamers of the first generation stop propagating at the point where the electrons do not have sufficient energy to ionize, due to the weakening external field and the retarding As it appears, one of effect of the positive space charge. the streamers in the flare develops conditions that prolong its lifetime and expansion into the gap. This streamer will be the only one that is effectively conducting and electrons from the cathode will flow through, producing a luminous conducting channel of plasma. Depending on the resistivity of this channel some of the cathode voltage will be conducted to

the head of the streamer, which will become an effective cathode and the whole process will be repeated.

The streamer generation finally stops when the field ahead of the streamers is not sufficient to sustain ionization. In this case further propagation into the gap can only be obtained by increasing the applied voltage until the streamers reach the anode and provide favorable conditions for spark onset.

7.3 Positive Rod-Plane - SF6/N2 mixtures with Less than 1%SF6

 ${\rm SF}_6/{\rm N}_2$ mixtures with low ${\rm SF}_6$ content exhibited a number of unusual phenomena under positive impulse conditions. Figures 5.11 and 5.12 show that at low pressures, the dielectric strength of mixtures with less than 1% ${\rm SF}_6$ increased well above that of nitrogen. The breakdown voltage-pressure characteristics of these mixtures show a voltage peak similar to that of ${\rm SF}_6$ under DC conditions (7,17,19,32,56). Under impulse voltage conditions this peak is not as pronounced as that of the DC voltage (Figure 5.4 and ref. 19), or that of the ${\rm SF}_6/{\rm N}_2$ mixtures with less than 1% ${\rm SF}_6$ (see Figure 5.12).

The breakdown voltage-pressure characteristics of these mixtures suggest that the breakdown mechanism could be similar to that of SF₆, yet a number of other observations indicate that there are some fundamental differences in the temporal and spacial behaviour of the ionization, prior to and during the breakdown.

The creep effect shown in the illustrations of Figures 5.15 to 5.17 occurred only in mixtures with less than 1% ${\rm SF}_6$

and it is related to the voltage maximum of the positive impulse breakdown characteristics. Cookson and Wootton (76) have recently reported a similar effect in mixtures of SF_6/H_2 in rod-plane gaps under AC voltages, but due to the limited information in their report with regard to the conditions of occurrence, one cannot comment on any similarities. aring spark trajectories associated with the creep effect and spark trajectories in SF6 under both impulse (Figure 5.19) and DC conditions (7,54), it is seen that the only similarity is that in all cases the curvature of the trajectories becomes. a maximum at the voltage peak of the breakdown characteristics. Sparks that exhibited a creep effect have a maximum path length twice as long as that of the sparks in SF6. Also, comparison of the illustrations of Figure 5.17 with Figures 5.10 and 5.11 shows that the magnitude of the voltage peak decreases proportionally to the creep distance. Thus, unlike SF6, the mechanism responsible for the voltage peak in SF_6/N_2 mixtures with less than 1% SF6 is directly related to the ionization process that forces the spark to initiate away from the tip of the electrode. In addition the photomultiplier results of Figure 5.14 show that the magnitude of the corona pulses and the statistical time lags of the 0.05% ${\rm SF_6/N_2}$ mixture, do not resemble those of ${\rm SF_6}$, but the ones of nitrogen. The SF6 traces (fig. 5.14(c)) show relatively small statistical time lags (2 to 3µs) and the light emitted during the formation of the corona streamers (not including ultra-violet) was too small to be detected.

The observations of the creep effect along the rod-

electrode assumes the presence of a space charge around the tip of the anode that produces a choking or retarding effect on the corona steamers in that area. This space charge is believed to be composed mainly of positive ions. Negative ions are too few to form significant space charges. As argued by Loeb (16) for mixtures of N_2/O_2 , the formation of a negative charge sheath would require at least a few percent of the electronegative component. The effect of a negative space charge (that is a breakdown voltage increase) is in general expected to be proportional to the SF₆ content. But as shown in Figure 5.11 the breakdown voltage between 1 and 2 bar increases as the percentage content of SF₆ is reduced.

The presence of a positive charge in regions away from the spherical tip is the result of ionization in that area. The positive coronas of Figure 5.20 and 5.21 show that corona streamers do indeed surround the cylindrical part of the rodelectrode as far as 3 to 4 cm away from the tip. Thus, in the cases where breakdown occurs with a certain creep distance, the pre-breakdown streamers that reach the cathode should also start above the tip of the rod. Photographic evidence of such streamers was recently obtained by Watanabe and Takuma (5).

The initial ionization will take place in the region of highest field strength (spherical tip of the anode) by electron collision. Photoelectrons are then created away from the tip, at a distance related to the mean free path of the photons tip, where μ_m is the photon absortion coefficient of the mixture. The photoelectrons that are produced in a region where αn will result in further ionization by collision, generating new avarage.

lanches and thus new photoelectrons further away from the tip. The initial boundary of the α -n region for a space charge free environment is defined by the radius $z_{\rm c}+R$, where $z_{\rm c}$ is the critical length of the first avalanche and R the radius of the spherical tip of the rod-electrode. Table 6.1 gives the values of $z_{\rm c}$ for a 10mm and a 50mm gaps in SF $_6/N_2$ mixtures at a total pressure of 1 bar. Photoelectrons generated inside $z_{\rm c}$ will lead to further ionization while photoelectrons generated outside $z_{\rm c}$ will undergo capture and create negative ions through an associative or dissociative attachment process (reactions 1 and 3 of page 9).

The mean free path of the photons λ for N₂, SF₄ and 10% and 20% SF6 mixtures at 1 bar of total pressure are obtained from the absorption coefficients of these gases as given by Blair et-al.(56,67). In nitrogen the average absorption coefficient for wavelengths between 1000A° to 1500A° is 0.6mm-1. Addition of 20% SF, increases this coefficient approximately by an order of magnitude to 6.7mm_1. These coefficients correspond to mean free photon paths of $\lambda_{\rm N_{-}}$ = 1.7 mm and $\lambda_{20\%}$ SF = 0.14 mm. From Table 6.1 the values of $z_{\rm c}$ for nitrogen and 20% SF $_{6}$ mixture are 0.98 mm and 0.08 mm respectively. Therefore radiation in the above range of wavelengths will be absorbed mostly outside the ionizing zone, thus if it does result in the ionization of already excited molecules, the generated photoelectrons will be

^{*} The coefficients of individual lines could differ considerably, for example, for the 1084A° nitrogen line λ_{N} =2.8 mm and λ_{N} =0.08 mm.

captured (in the case of a mixture) to produce negative ions.

Photons of higher energy will be absorbed inside the ionizing zone: Simpson et-al(69) have measured the absorption cross section of SF₆ in the far ultraviolet region and found that an absorption continuum begins sharply at 15.5ev with a cross section of 10⁻¹⁶cm². This cross section corresponds to a mean photon path of

$$\lambda_{SF_6} = 1/N_0 \cdot \sigma_a (cm^{-3})(cm^2)$$

$$= 1/2.7 \cdot 10^{19} \cdot 10^{-16}$$

$$= 0.0037 \text{ mm}$$
(7.1)

where N_0 is Loschmidt's number and σ_a is the absorption cross section.

Table 6.1 shows that for SF_6 $z_c=0.05\,\mathrm{mm}$, hence for SF_6 , as well as nitrogen (90), most of the absorption in the far ultraviolet region will take place inside the ionizing zone.

In general, energetic radiation (above 10ev) will be absorbed both inside and outside the ionizing zone and this after. all is one of the basic assumptions of the streamer theory (30). However, as it is shown above, the mean free path of the photons can vary significantly with SF₆ content and this could have an effect on the photoionization process of the different mixtures. Loeb (30) investigating the importance of secondary mechanisms in non-uniform fields, suggested two types of photoionization action in the anode depending on the absorption coefficient of the mixture.

" 1. If the coefficient of absorption for photoionizing action is of the order of locm-1 (ionizing free path

- lmm), breakdown characterized by spread over the anode surface occurs. (Burst-pulse or Geiger counter actions.)
 - 2. If the coefficient of absorption for photoionizing action is of the order of 100cm. or less with appropriate geometry, a self-sustaining process projects radially into the gap by photoionization and spacecharge action leading to breakdown. (Streamer action)

For nitrogen with small impurities of SF_6 , $^{\lambda}SF_6/N_2$ is expected to be relatively long. This could result in photoionization of SF_6 molecules that are in the neighbourhood of the ionizing zone but relatively distant from the origin of ionization. Such type of photoionizing action could spread rapidly over the anode surface, suppressing further ionization until the space charge moves away from the anode, or the voltage is high enough for the breakdown streamers to initiate away form the tip of the anode and reach the cathode by travelling around the space charge. This type of action is expected to depend mainly upon the nature of the gas volume, yet the effects of the electrode surface should also be considered and in particular the photoelectric emission from the surface of the brass anode.

If one assumes that the brass electrode has the work function of copper (W≈4.5 ev), then photons with wavelength λ =2755Ű are needed to produce photoelectrons from the anode. In addition the ionization potential of the Cu vapour is V_i =7.7 ev and that corresponds to 1610Ű photons. Emission data (87) shows that both the above wavelengths are well within the emission spectrum of N_2 (and that of SF6 and SF6/ N_2 mixtures (67)). Hence electron emission from the anode will depend on the value of the sec-

ondary photon emission coefficient $\gamma_{\text{D}}.$ The effect of $\gamma_{\hat{1}}$ (secondary ion emission coefficient) should be small due to the static nature of the space charge under impulse conditions. The values of these coefficients for a brass or copper anode in both SF6 and SF_6/N_2 mixtures are unknown. However, γ_i and γ_D in mixtures of $\rm SF_6/N_2$ with a small trace of $\rm SF_6$ are not expected to vary significantly from those of pure \mathbb{N}_2 . $\overline{}$ Since ionization above the tip is not present in pure N_2 (or pure SF_6), it is less than likely that a small trace of SF_6 in N_2 will alter the surface properties of the anode to such an extent that corona streamers on the cylindrical part of the electrode will be produced by some efficient γ_n mechanism alone. Hence, although the surface of the anode will be active, the main source of the free electrons that are required to initiate the ionization in regions surrounding the anode is believed to be photoionization of the SF6 impurity in the gas volume.

As mentioned earlier, the ionization could spread around the surface of the anode, if the ionizing radiation has a relatively long path and if it is absorbed in the neighbourhood of the ionizing zone, so that the generated photoelectrons can gain enough energy between collisions to ionize. The lack of absorption measurements in SF_6/N_2 mixtures with less than 1% SF_6 does not allow much speculation as to the type of radiation involved

^{*} In mixtures of N_2/O_2 with a platinum anode the addition of 5.0% O_2 in N_2 resulted in a decrease of γ_1 by a factor of 5 and an increase of γ_p by one order of magnitude. (reference (16) page 433).

in this process. However under the assumption that the photon paths are relatively long, the ionizing radiation can not be from the far ultraviolet region since both SF6 and nitrogen have relatively high photon absorption coefficients in this region (69, 90). If the ionizing radiation has a wavelength in the region of 900A° to 1500A° this would mean that a two (or more) step ionization process is involved. In this case both the partial pressure of SF6 and the total pressure of the mixture are expected to have an effect on the spread of the ionization. The partial pressure of SF6 will regulate the absorption of the mixture in the ultraviolet region and the total pressure will have an effect on the probability of excitation by collision, that is needed to complete the two (or more) step ionization process.

Under DC conditions (88), the breakdown voltage-pressure characteristics of $\rm SF_6/N_2$ mixtures with less than 1% $\rm SF_6$ show a behaviour similar to that of the impulse voltage, but with almost zero creep distance. That is, the space charge has probably drifted into the inter-electrode region away from the anode, but it is still effective in raising the breakdown voltage.

In conclusion the increase of the dielectric strength of mixtures containing small traces of SF6 at low total pressures, is believed to be the result of a photoionization process that generates a positive space charge around the anode which impedes further ionization. The density and the extent of this space charge depend on the partial pressure of SF6 and the total pressure of the mixture. The creep effect indicates the extent of the space charge above the tip of the anode and the creep dist-

ance is expected to vary with different impulse fronts.

7.4 Positive Rod-Plane - SF₆/N₂ mixtures with SF₆ Content Higher than 5%.

Under positive impulse conditions SF_6/N_2 mixtures with high SF_6 content exhibit a similar behaviour to that of pure SF_6 . As shown in Figure 5.10 the corona stabilized region in the mixtures occurs at about the same pressure as that of SF_6 . The shielding of the anode seems to be so effective in preventing streamers from reaching the cathode that at P_{max} the breakdown voltage of mixtures with 60% - 95% of SF_6 is higher than that of pure SF_6 ?

On the basis of the discussion in the previous section, the addition of nitrogen into SF_6 can affect both the rate of production of negative ions, as well as the distribution of the space charge in the anode region. However as shown in Figure 5.9 the breakdown voltage-mixture ratio characteristics are far too complex for one to attempt their interpretation on the basis of the present information.

At higher pressures (Figures 5.8 and 5.9), the breakdown voltage drops with percentage of SF₆ in a manner similar to that of the negative polarity (Figure 5.7). But unlike the negative breakdown voltage-pressure characteristics, the breakdown voltage of the 50 mm gap (Figure 5.10) for pressures higher than 2.0 bar and mixtures with less than 20% SF₆, drops below that of pure nitrogen. This suggests that the effective coefficient of ionization of these mixtures has increased above

that of SF₆ or nitrogen. However, it is interesting to note that the corona voltage of a mixture exhibiting this effect is higher than that of nitrogen. This is shown in Figure 5.22 for a 0.2% SF₆ mixture. In pure nitrogen, breakdown occurs at voltages higher than the corona onset voltage through a corona stabilized mechanism. Addition of small amounts of SF₆ seems to reduce the efficiency of the corona stabilized process at the higher pressures. That is, the initial corona streamers have sufficient intensity and length soon after they are generated to lead to a breakdown. But further speculation along these lines would require a more detailed study of the temporal and spatial growth of ionization under both impulse and DC voltage conditions.

CHAPTER 8

CONCLUSIONS

- 1. In negative rod-plane gaps, and for low values of pressure and gap length, the breakdown voltage of the SF $_6/N_2$ mixtures decreases at a slow rate as the percentage of SF $_6$ content is reduced from 100% to about 10%. Lower contents of SF $_6$ result in a higher rate of the dielectric strength loss, which becomes a minimum for 100% N_2 .
- 2. Under negative impulse conditions and high values of pressure and gap length, the breakdown voltage of the mixtures decreases significantly at relatively high contents of SF₆. In a case of a 50 mm rod-plane gap and 5.0 bar of total pressure, most of the differential strength of the mixture is lost as the SF₆ content reduces to 80%. The process responsible for this effect is by enlarge unknown. A reduction of the negative space charge with the addition of nitrogen could account for the sudden drop in the dielectric strength, but experimental evidence relating to such mechanism is not available.
- 3. For positive rod-plane gaps in SF₆, the impulse breakdown voltage-pressure characteristics exhibit a voltage maximum similar to that of the DC characteristics, which is attributed to a corona stabilization process. The voltage peak occurs at about the same pressure and has a lower magnitude, due to the limited time allowed for the formation and diffusion of the space charge.
 - 4. In positive rod-plane gaps, the breakdown voltagepressure characteristics of mixtures with more than 5-10% of

 SF_6 exhibit a voltage maximum, at about the same pressure as that of SF_6 . The magnitude of the voltage peak varies with the percentage of SF_6 , and it is higher than that of SF_6 for mixtures with 60% to 95% SF_6 . This effect is believed to be the result of an intensified corona stabilization mechanism due to an increase of the photoionization in the gas.

- 5. Under positive impulse conditions the addition of small percentages of SF_6 (1.0%) in nitrogen result in an increase of the breakdown voltage for total pressures less than 2.0 to 3.0 bar. At a total pressure of 1.7 bar a mixture with 0.2% of SF_6 exhibits a breakdown voltage approximately double that of nitrogen.
- 6. The increase of positive impulse breakdown voltage in SF_6/N_2 mixtures with less than 1.0% SF_6 is manifested as a movement of the initiation point of the spark along the rod electrode. This movement which is referred to here as "creep effect", is the result of a shielding mechanism produced by a positive space charge, which is generated by ionization that extends above the spherical tip of the rod. The extent and effectiveness of the space charge are controlled by the pressure of the mixture and the partial pressure of SF_6 .
- 7. The positive impulse breakdown voltage of SF_6/N_2 mixtures with 40% to 0.05% SF_6 and total pressures higher than 2.0 to 3.0 bar, is lower than that of nitrogen. At 5.0 bar of total pressure the breakdown voltage with 0.1% to 0.2% SF_6 can be 50% that of N_2 .
 - 8. The solution for the potential distribution of the

rod-plane configuration with the present optimized approach, indicates that the time required in setting up a problem of this kind is drastically reduced, and it is believed to be the shortest when compared to any other technique achieving comparable accuracy. When compared with the conventional charge simulation approach, we find that unnecessary guess-work is eliminated, and some of the insight required in solving such problems is replaced by computation time.

- 9. The streamer onset calculations in SF_6 and SF_6/N_2 mixtures suggest that, although the ionization and attachment coefficients of the mixtures are calculated from those of the individual gases, the degree of prediction is of the same order as that of SF_6 . That is, in the region where the various breakdown criteria are applicable (quasi-uniform fields), the comparability of theoretical and experimental results in SF_6/N_2 mixtures is about the same as that of SF_6 . For non-uniform field electrode configurations such as the ones used in this work, the calculated corona onset voltage is in poor comparison with the experimentally measured one. Further improvements in this area are expected to include experimentally measured ionization and attachment coefficients for different SF_6/N_2 mixtures.
 - 10. In general, the behaviour of the ${\rm SF_6/N_2}$ mixtures under both impulse polarities is found to be far more complex than that of the individual gases. The results of this work suggest that certain ${\rm SF_6/N_2}$ mixtures have an impulse breakdown strength superior to that of ${\rm SF_6}$. However, unlike the simpli-

city of the single component gases, the use of mixtures will involve a much more intricate set of constraints, regarding parameters such as uniformity factor of the system, partial pressure of SF₆, and total pressure of the mixture

8.1 Suggestions for Future Work.

The results of the present work indicate that ${\rm SF}_6/{\rm N}_2$ mixtures could prove to be an insulating medium that is desirable both technically and economically. Including this work, there are relatively few investigations on the properties of the different mixtures and a great number of suggestions for future work could be made, ranging from arc quenching properties to thermal conductivity of the mixtures. For this reason, the suggestions presented below are limited to material along the lines of the present investigation.

- Breakdown voltage measurements in ${\rm SF_6/N_2}$ mixtures under both AC and DC voltages have not been pursued to any great detail and this could justify a number of general systematic studies in both quasi-uniform and non-uniform electrode arrangements.
- Study of different corona modes and their variations with percentage of SF₆ content. This type of information could provide a better understanding of some of the effects observed in the present work. For example, when small amounts of SF₆ are added to nitrogen at total pressures higher than 2 bar, the breakdown strength of nitrogen is found to decrease. This suggests that corona streamers soon after their onset have enough intensity and length to bridge the gap and lead to a breakdown. Knowledge of the evolution of the corona pulses

during the short time interval prior to breakdown could aid the understanding of the effects produced by the SF6; impurity, and possibly provide certain clues relating to the mechanism of breakdown under these conditions.

- Breakdown studies of different SF_6/N_2 mixtures with impulses of variable front, ranging from standard impulse to switching surges. This study will not only provide useful data on the behaviour of SF_6/N_2 mixtures under switching surges, but it will also relate to some of the arguments put forward in this work with regard to the "creep effect" mechanism. Application of slower impulses are expected to result in lower creep distances due to movement of the space charge away from the anode.
 - Introduction of a chromatographer for the analysis of mixtures containing small percentages of one of the component gases. Mixtures with small percentages of SF_6 under negative impulse polarity should take priority in this study, as the author believes that there might be an anomalous behaviour of the breakdown voltage of nitrogen with impurities of SF_6 (or SF_6 and O_2) less than O_3 .
 - Spectroscopic studies of SF_6/N_2 mixtures are in great need, to provide information about the ionization, attachment, and swarm parameters of the different mixtures. Such information is expected to elucidate to some extent the irregular behaviour of the dielectric strength of the mixtures and lead to improvements in the calculation of the corona and spark onset voltage.

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APPENDIX 1

COMPUTER PROGRAM FOR THE POTENTIAL DISTRIBUTION OF A ROD-PLANE GAP USING THE CHARGE SIMULATION TECHNIQUE.

The following program represents a solution of equation 3.3 for nine semi-infinite line charges and one point charge (46). Ten boundary points (r_j, z_j) are used, three of which lie on the spherical part of the boundary and the remaining seven along the cylindrical part starting at z=G+R (see Figure 3.1(a)). The problem is solved on the basis of the following data.

- 1. Radius of spherical tip R = 1unit (cm)
- 2. Gap length G = 10R
- 3. Gap potential GPOT = 1V

Having solved equation 3.3, the value of the charges Q_1 (i=1,2,..10) are substituted in equation 3.6. The potential $\emptyset(r,z)$ can then be calculated at any point (r,z) in the inter-electrode region and along the boundary of the electrode to test for the accuracy of the simulated potential.

WRITE V(O,G A(J)) .

```
. 1
```

```
A RUD-PLANE GAP
        POTENTIAL DISTRIBUTION OF
       DOUBLE PRECISION ZS.TS.T1.DSIN.DCUS.XS(20).DLOG.XC.PN(10).PSFo(10)
DOUBLE PRECISION X1.X2.PT.PE.TS1.TS2.PCL(20)
DOUBLE PRECISION A(9).Z(9).PUT(10).VOLT(100.20).YY(100).Y(10.10)
                                PA4.PR. PZ,U(10).VNITA-UTILE
        DOUBLE PRECISION
                                                         PP. VTOTAL, ZZ, ZZZ, ZZZ, Z1, XX(20)
        DOUBLE PRECISION DOUBLE PRECISION
                                 ZED . AA.AP.
                                B.C.D.E.F.G.P.J.R.S.T.X.Y.VI.V2.V4.P2.P4.VA.RR
BB.CC.DD.EE:FAI.FA2.FA3.FA4.VR.VZ.PAI.PA2.PA3
GPL.PTRAD.GPOT.POTFCR.FLDFCR.GA(90)
XL.ZSO.PRESS.APPLV.FZ.FLDZ. RD.XU.Y32
        DOUBLE
        DOUBLE
                  PRECISION
        DOUBLE
                  PRECISION
        DOUBLE
                  PRECISION
                  PRECISION STOT. ERAD. DEXP.DABS
        DOUBLE
                  PRECISION EPNT, EANCO, FZI, FZ2, ZP(50), CRG(50), OZ
PRECISION DLOGIO, DSQRT, TTI, TT2, FCT, C1
        DOUBLE
        DIMENSION XCD(100).YCD(100).XCD1(60).YCD1(60).XCDJ(20).YCDJ(∠0)
        DIMENSION VALT(100,20)
\sigma
        READ IN THE FOLLOWING DATA GRL = GAP LENGTH - IN CEN
        GPL = GAP LENGTH - IN CENTIMETERS
PTRAD = RADIUS OF THE HEMISPHERICAL ELECTRODE -
                                                                               IN CENTIMETERS
        GPOT = POTENTIAL ACROSS THE GAP - (1 VOLT)
  READ (5.111) GPL.PTRAD.GPOT
111 FORMAT (F8.2/F5.2/F8.2)
   SS8 WRITE (6.8) GPL.PTRAD.GFOT
8 FORMAT (1HO./.24X. GAP LENGTH = ...E7.2.//.22X. POINT RADIUS
       1.//.22x. 'GAPPOTENTIAL' = '. F7.2//)
        INTRODUCE THE POSITIONS (0,Z')=A(I) OF THE SEMI-INFINITE LINE CHARGES, AND THE POINTS (R,Z) ON THE BOUNCARY OF THE ELECTRODE WHERE THE BOUNDARY CONDITIONS ARE APPLIED.
cccc
         TT1 = 0.0500
         TT2 = 0.100
         TS1 = (180.000/3.1415900)*T51
         TS2 = (180.000/3.1415900)*TT2
         G=GPL/PTRAD
         F=G+1.000
         A(1)=F
         A(2)=F+.1D0
         A(3)=F+.20C
         A(4)=F+.500
         A(5)=F+1.000
         A(6)=F+9.000
         A(7)=F+24.0D0
         A(8)=F+89.000
          A(9)=F+239.0D0
         Z(1)=F
          Z(2)=F+1.000
          Z(3)=F+4.0D0
          Z(4)=F+14.0D0
          Z(5)=F+39.0D0
Z(6)=F+139.0D0
          Z(7)=F+439.0D0
                = G+(1.0D0-DCQS(TT1))
          Z(8)
          Z(9) = G+(1.000-DCOS(TT2))
 UUÚUU
          FORM MATRIX OF CCEFFICIENTS
     COMPLIE V(0.G A(J)) AND LOCATE PUSITION IN MATRIX OF LEFFICIENTS 12 FORMAT ('1'.//.47X.1HA.14X.'V(0.'.F6.1.'A)')
          WRITE (6,12)
          DO 14 J=1.5
          R = 0.000
          X=A(J)
          B= X+G .
          C = X - G
          D = F
                   -G
          E=F+G
                 DLDG((8+DSORT(R*R+8*8))/(C+USORT(R*R+C*C)))
           V1=
             = 10
           1V=(L.1)V
```

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21/18/45
```

```
WRITE (6.13) A(J).V(I.J)
13 FORMAT (*0*.42x.F6.1.13x.F1C.8)
   14 CONTINUE
       COMPUTE P(O.G) AND LOCATE POSITION IN MATRIX OF COEFFICIENTS
       I
      J = 10
P=1.000/(DSQRT (R*R+D*D))-1.000/(DSQRT(R*R+E*E))
       Q=(L,I)V
     - WAITE P(O.G)
   WRITE (6.15) G.P
15 FORMAT (*0(.//.45x.4HP(0.F6.1.3H) =.FL1.8)
       WRITE
              (6,21)
      FORMAT ( | I | . //.9 x.1HZ.5 x.9HV (I.Z A1) ,2 X.9HV (1.Z A2) . 2 A. 9HV (1.Z A3) 1.2 X.9HV (1.Z A4) . 2 X.9HV (I.Z A5) . 2 X.9HV (1.Z A6) . 2 X.9HV (1.Z A7) . 2 X.9H
   21 FORMAT
    2V(1.Z A8).2X.9HV(1.Z A9))
٥
       COMPUTE V(1.Z(1) A(J)) AND LOCATE POSITION IN MATRIX OF COEFFT'S
       DO 23 I=1.9
DO 23.J=1.9
       IF(I-8) 801.802.803
  801 R = 1.000
       GO TO 805
  802 R = DSIN(TT1)
       GO TO 805
       R = DSIN(TT2)
  E 0.3
  805
       Y=Z(I)
       (L)A=X
       B=X+Y
       C=X-Y
       D=F-Y
       E=F+Y
             DLUG((8+050RT(R*R+8*8))/(C+050RT(R*R+C*C)))
       V1=
       IV = (L, I)V
    23 CONTINUE
000
       WRITE V(1,Z(I) A(J))
    WRITE (6.25) (Z(I) (V(I.J).J=1.9).I=1.9)
25 FORMAT ('0'.6X.F5.1.2X.9F11.8)
              (6,26)
       WRITE
    26 FORMAT (*1*,//,51X,5H(R,Z),14X,6HP(R,Z))
       COMPUTE P(1.Z(I)) AND LOCATE POSITION IN MATRIX OF COLFFICIENTS
       00 28 [=1.9,
         = .10
        IF(I-8) 901,902,903
  901 R=1.0D0.
        GD TD 905
         = DSIN(TT1)
   902 R
       GB TO 905
       R = DSIN(TT2)
   503
   905
         = Z(I)
       D=F-Y
        E=F+Y
       P=1.0D0/(DSQRT(R*R+D*D))-1.0D0/(DSQRT(R*R+E*E))
        9=(L:1)V
000
        WRITE P(1.Z(I))
    WRITE (6.27) Z(I).P
27 FORMAT (*0*.48x.3H(1...F5.1.1H).10x.F10.8)
    28 CONTINUE
        WRITE MATRIX OF COEFFICIENTS
        WRITE (6.51)
    51 FORMAT ( *0 . //, 48x, 41 HMATRIX OF COEFFICIENTS PUI (EQUATION 3.3) .
       1/.10x.'(1)'.9x.'(2)'.
       19X, 1(3) 1, 9X, 1(4) 1, 9X, 1(5) 1, 9X, 1(6) 1, 9X, 1(7) 1, 9X, 1(8) 1, 9X, 1(9) 1, 9X,
       2 ( ( 10 ) )
        WRITE (6.53) (I,(V(I,J),J=1.10),I=1.10)
    53 FORMAT( '0', 1H( , 12, 1H) , 10F12.8)
```

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```
MATN
```

```
WRITE (6.61)
61 FORMAT (*1.14X.20HPOTENTIAL VECTOR VJ
000
      FORM THE POTENTIAL VECTOR VJ
       DO 73 [=1+10]
    71 U(I)=1.000
    73 CONTINUE
مامن
       WRITE THE POTENTIAL VECTOR VUI
  . 00 74 I=1.10
74 WRITE (6.75) U(I)
75 FORMAT (*0*,22X.F3.1)
       SOLVE FOR POTENTIAL COEFFICIENTS
             DSIMQ(V.U.10.0)
    WRITE (6.81)
81 FORMAT ('1'.//.3CX. CHARGE VALUES OF THE NINE LINE CHARGES AND 1 POINT CHARGE')
      WRITE POTENTIAL COEFFICIENTS
    DO 88 I = 1.10
83 WRITE (6.84) I.U(I)
    84 FORMAT ('0',48x.5H(0.Z',12.1H),2x,1H=,2x,F11.6)
       CONTINUE
    88
        00 2331 = 1.9
          = 11+I
   XS(I) = U(I)
233 XS(I) = (I)
        xs(10) = U(10)
        xS(11) = F
        R = 0.000
        RR = 0.000
         1=しし
    102 ZS= G
         I = I
    105 DO 101 I = 1.9
         YY(II)=ZS ·
                  XS(I)*DLDG((XS(J)+ZS+DSURT(RR+(XS(J)+ZS)*(XS(J)+ZS)))/
          = 11+I
        POT(I) =
       1(XS(J)-ZS+DSQRT(RR+(XS(J)-ZS)*(XS(J)-ZS))))
    VTOTAL = 0.000
         OO 103 K = 1,10
VTOTAL = VTOTAL+POT(K)
         CONTINUE
         VOLT(II \cdot JJ) = VTOTAL
         Z1 = ZS-61.000
IF (F-Z1) 200.200,201
    201 CONTINUE

IF(ZS-G) 212.212.213

212 ZS = ZS-G /100.000
            = II+1
          IF(II-100) 105.1C5.231
     213 CONTINUE
         ZS = ZS+1.0D0
         II = II + 1
         .GO TO 105
     231 CONTINUE
          IF(R-5.000) 202,203,203
     202 CONTINUE
         R = R+0.500
          RR = R*R
          JJ = JJ+1
GO TO 102
     203 CONTINUE
     WRITE (6.106)
106 FORMAT (11.35X-49HPUTENTIAL DISTRIBUTION IN INTER-ELECTRODE REGIO
         1H0.0.8x,3H0,5,8x,3H1.0.8x,3H1.5.dx,3H2.0.8x,3H2.5. 3x,3H3.0.6x,3H3.
             .//,4x,5HZ /.R,5X,3
         25.8X.3H4.0.8X.3H4.5.8X.3H5.3)
```

DATE = 78037

PAC

```
MAIN
```

```
WRITE (6,107) (YY(II) (VOL
FORMAT ('0'.F7.2. 11F11.4)
DO 403 II = 1.100
VALT(II.1) = VOLT(II.1)
XCD(II) = YY(IL)
YCD(II) = 1.000-VALT(II.1
                        (YY(II) . (VOLT(II.JJ) .JJ=1.11) . II=1.100)
 I:C7
                     1.0D0-VALT(II.1)
 403 CONTINUE
     WRITE(6.556)
FORMAT(*1:.25x.:POTENTIAL DISTRIBUTION ALONG THE 1 IELD STRENGTH*)
                                                                       AXIS JF HIGHEST
             PLOT 3(XCC.YCC.100)
 SOO CONTINUE
      COMPUTE POTENTIAL DISTRIBUTION ON CYLINDRICAL PORTION OF
                                                                                  BOUNDARY
        = 1.000
      RR = 1.000
       LL
          =
       ZS = F
       ΙI
       ĞŌ TO 105
  200 CONTINUE
       WRITE POTENTIAL DISTRIBUTION ON CYLINDRICAL PORTION OF
                                                                               BJUNDARY
  WRITE '(6.206)
206 FORMAT ('1'.25X, 'POTENTIAL DISTRIBUTION ON CYLINDRICAL PURTION OF 1 THE BOUNDARY'. //,58X,'R = 1.0', //,53X,'ZS'.7X,'POTENTIAL')
  WRITE (6.207) (YY(II), VOLT(II.1), II=1,60)
207 FORMAT (10,50x.F7.2,F11.4)
       DO 401 II = 1.60
VALT(II.1) = VOLT(II.1)
       XCDI(II) = YY(II)
YCDI(II = (1.000-VALT(II.1)) *100.000
                     YY(II)
  401 CONTINUE
       ina = r
       COMPUTE ZS AND R COORDINATES OF SPHERICAL PORTION OF BUUNDARY
U U U
 WRITE(6,1801)
1801 FORMAT(11,30x, PO ESTIAL DISTRIBUTION ALONG THE CYLINDRICAL PART
           THE BOUNDARY!)
      1 OF
        CALL PLOT 3(XCDI,YCDI,60)
        II = I
        DO 259 L = 1.20
        TI = 3.1415900/(2.000*20.000)
TS = TI*L
        R = DSIN(TS)
        ZS = G+(1.000-DCCS(TS))
        YY(II) = ZS
        = (11) \times
        RR = R*R
      · COMPUTE POTENTIAL DISTRIBUTION ON SPHERICAL PORTION G
                                                                                 アンスのとりのと
        DO 258 I = 1.9
        POT(I) = XS(I)*DLOG((XS(J)+ZS+DSQRT(RR+(XS(J)+ZS))*(XS(J)+ZS)))/
       1(XS(J)-ZS+DSQRT(RR+(XS(J)-ZS)*(XS(J)-ZS))))
        POT(10) = XS(10)*(1.0D0/DSQRT(RR+(XS(11)-ZS)*(XS(11)-ZS))
    258 CONTINUE
       21.000/DSGRT(RR+(XS(11)+ZS)*(XS(11)+ZS)))
         VTOTAL = 0.000
         DO 109 K = 1.10
         VTOTAL = VIOTAL+POT(K)
         CONTINUE
         AVIOLA ( CC.II) LOA
             = II+1
    259 CONTINUE
         WRITE POTENTIAL DISTRIBUTION ON SPHERICAL PORTION OF SUUNDARYS
 O Q C
                  ( 1 . 40x , PCTENTIAL DISTRIBUTION ON SPHERICAL PURTION OF TH
          #RITE (6,320)
        1E BOUNDARY * . / / . 50X , * ZS* , 9X , * R f . 7X , * POTENTIAL* )
WRITE (6,321) (YY(II) , XX(II) , VOLT(II, 1) . II=1,20)
FORMAT (*0*,47X + F6.2 , F11.4 , F11.4)
    320 FORMAT
    321 FORMAT
         DO 402 II = 1.20
```

VALT(II.1) = VOLT(II.1)

YCCJ(II) = (1.000-VALT(II.1)) *100.000

XCOJ(II) = XX(II)

402 CONTINUE

WRITE(6.1302)

1802 FORMAT('1'.30X.FPOTENTIAL DISTRIBUTION ALONG THE SPHERICAL PART OF

1 THE BOUNDARY')

CALL PLOT 3(XCOJ.YCOJ.20)

STOP

END

```
SUBROUTINE DSIMQ(A.B.N.KS)
   FOR THE SOLUTION OF A LINEAR SYSTEM OF EQUATIONS DESCRIPTION OF PARAMETERS

A -MATRIX OF COEFFICIENTS STORED COLUMNWISE B -VECTOR OF UNKNOWNS, REPLACED BY THE FINAL SOLUTION VALUES (VECTOR X).
            -NUMBER OF EQUATIONS AND VARIABLES -OUTPUT DIGIT
        Ν.
      ΚS
             O FOR NORMAL SOLUTION
              I FOR SINGULAR SET OF EQUATIONS
   DOUBLE PRECISION A(100) .B(10).TOL.BIGA, SAVE .DABS.
   TOL = 0.000
   KS = 0
    N- = LL
   DO 65 J=1.N
JY = J + 1
JJ = JJ + N+1
   BIGA = 0.000
           JJ-J
    DO 30 I = J.N
    IJ = IT + I
    IF(DABS(BIGA)-DABS(A(IJ))) 20,30,30
20 BIGA = A(IJ)
    I = XAMI
30 CONTINUE
   IF(DABS(BIGA)-TOL) 35.35.40
35 KS = 1
    RETURN
   II = J + N*(J-2)

IT = IMAX - J

DO 50 K = J*N
40
    II = II + N
                                               д
    12 = 11 + 17
    SAVE .= A(I1) -
    A(II) = A(I2)
    A(I2) = SAVE
    A(II) = A(II)/BIGA
SAVE = B(IMAX)
    B(IMAX) = B(J)
    B(J) = SAVE/BIGA
IF(J-N) 55,70,55
    IQS = N*(J-1)
    DO 65 IX = JY+N
IXJ = IQS + IX
    xI-L = TI
    N.YL = XL 09 DD
    TI + XLXI. = XLL
    ((XLL)A*(LXI)A)-(XLXI)A = (XLXI)A
65 B(IX) = B(IX) - (B(J) * A(IXJ))
70 NY = N-1
    TT
        = N*N
    = 0.080 =
                  1.NY
    IA = IT-J
    IB
        L-N =
        = N
    IC
    DO 80 K = 1.J
    B(IB) = B(IB) - A(IA) * B(IC)
eo IC = IC-1
    RETURN
    END
```

GAP LENGTH = 10.00
POINT RADIUS - 1.00
GAPFCTENTIAL = 1.00

V(0. 10.0A) 3.04452244 11.0 2.95396286 11.1 2.87157962 11.2 2.66258783 11.5* 2.39789527 12:0 1.09361229 20.0 0.58778666 35.0 0.20057070 100.0 0.08004271 250.0

P(0. 10.0) = 0.95238095

11.4021952411.402056491,1.4019968411.4016924511.4011670311.3896596911.3516545210.4J988227 1.38627092 J.78470576 J.68940218 J.59505624 J.3259441J 2.94774006 I.23J95044 O.65027195 O.22088256 O.02805615 4.71048724 4.64231491 4.57043187 4.33181181 3.87163476 1.38265485 0.71427428 0.24114970 0.89607306 6.046325EE 6.02561853 6.004298NO 5.53646819 5.807773287 1.93626092 0.91576630 0.30226517 0.12014334 7.61031655 7.cc598927 7.60152297 7.58705283 7.56382021 6.81237145 1.78933623 0.51079718 0.2006906 13.6041942913.6041833713.6041723513.6041387013.6040806413.6028147513,5581742713.605413.23565882 3.04520843 2.55464339 2.87234767 2.66320292 2.39842215 1.03877338 0.597NuJ74 0.2U069592 C.04065272 9,16096158 5,16003261 9,15909456 9,15622449 9,15125J02 9,0J6J1566 8,5J81,110U 1,69852341 0,40546164 3.04726700 {,{55668559 2.87435240 2.66504870 2.40000306 1.09925634 0.58801477 0.20077162 (.08908273 VII.2 AUT: VII.2 A91 (14 2:1)V /A(1.2 A6) 一是 ~ : : : > V(1,2 A4) V(1,2 A3) V(11.2 A1) V(11.2 A2) 50.0 4 50 : 0 0.1 25 . 0 50.0 0.01 0.01 12.0 15.0

	1
	1101 0.95459234 0.6456556 0.20410250 0.004347998 0.00924136 0.00010071 0.95239202 0.95239202
•	(4) (9) (22086256 0.06005615 (2,114970 0.09007304 (0.320217 0.12014314 (0.51079718 0.20006906 (1.09862341 0.40546164 (0.01.986227 1.38627092 (3.20077162 0.08005272 (3.20077162 0.08006273
	(4) 9.22088256 0.06005615 6.2114970 0.09007304 0.30226517 0.12014334 1.09862341 0.20066906 1.09862341 0.40546164 10.41986227 1.3862762 0.20077162 0.08006273 0.20077162 0.08004271
•	11,1011.11. 0.6502/11/2 0.6502/11/2 0.71423424 11,1011/2 11,5900/2 0.58100000000000000000000000000000000000
0.13469214 0.66146956 0.20410250 0.007141998 0.00924130 0.00013871 0.95239282	HAIRIX OF CUEFFICIENTS [6] [1] [1] [1] [2] [2] [2] [2] [2] [2] [2] [2] [2] [2
10 10 10 10 10 10 10 10 10 10 10 10 10 1	0. CUEFFICIENTS [2] (E) (5) (5) (6) (6) (7) (6) (7) (7) (6) (7) (7) (7) (7) (7) (7) (7) (7) (7) (7
(1, 12.4) (1, 12.4) (1, 15.0) (1, 25.0) (1, 56.0) (1, 160.0) (1, 10.0)	4.3.161813 4.3.161181 6.93636819 7.581785283 9.18622449 11.40169245 13.6013870 1
	(4) (4) (4) (4) (4) (6) (6) (6) (6) (6) (7) (8) (9) (9) (9) (9) (9) (9) (9) (9) (9) (9
	•
	(1) (2) 3.74470576 3.66940218 4.71048724 4.64231491. 6.04632508 6.025616€3 7.61033655 7.6055927 3.160903130 9.16003261 11.60419429 13.60418333 3.04520843 2.95464339 3.04452244 2.95666655
_	

(H, 2

POTENTIAL VECTOR VJ

1.0

11.0

1.0

1.0

1.0

1.0

1.

. 5

(

CHARGE VALUES OF THE NINE LINE CHARGES AND THE POINT CHARGE

 $(0/2 \cdot 1) = -44.912401$

(0.Z' 2) = 82.200071

(0.2:3) = -45.354784

(0.2.4) = 10.213713

(0.2.5) = -1.483524

(0,Z,6) = -0.030520

(0.2:7) = -0.022561

(0.2:8) = -0.021720

(0.2'9) = -0.015278

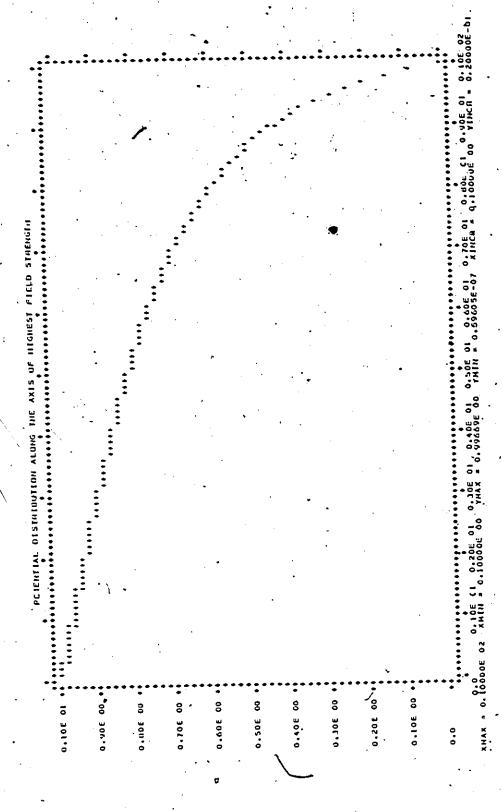
(0.710) = 3.166699

. نيت

		:	4		•					-						•	-																	•	•		•					
•	5.0	00.14.00	0, 3302	. 0, 1523	0.3284	0.1245	0.1206	N 4 4 5 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7		0.3527	d. 30bB	0.1048	0.1000	0.2968	0.2926	0.2880	0.2640	0.2800	0.2769	0,2729	0.2609	0.2049	0.2610	0	0.62.0	166710	0,2492	0,2453	01.2414	0.2375	0.2337	0.2298	0,2260	0.2222	0.2105	0.2147	0.2110	0,2012	0.2036	0.1999	0.1962	
•	4.5	01 30 10	9955.0	0.144	1041.0	1911 0			0.3369.	0,3325	0.3261	0.3236	0.3192	0. 31 47	0.3103	0, 3050	0.3014	0.2969	0.2925	0.2685	0.2417	0.2241	0.2740		0.2706	0.2662	0.2619	0.2576	0.2534	0.2491	0.2449	0.2408	6.2366	0.2325	0.2284	0,2243	6,2203	0.2163	0.2123	Ò.2083	0.2044	
		7.001.0	H 4 H 1 C	, 902.6	66,50		20015-0	0595.0	0.3600	0.3549	6645.0	0.3448	0.3378	0.3347	0,3297	0.3246	0.3196	0,3146	C. 30%	2.104.3		0.7.7.D	9,44.0	0.2039	0.2851	(.2003	0.2755	0.270	0.2661	0,2014	0.2568	0.2522	0.2477.	0.24.52	0.2307	0.2343 .	0.2299	. 0.2256	0.2213	0.2170	C.212H	-
	· ·			0.14.0	0.407	0.404.0	0. 3962	0.1723	O. Jour	9.3000	0.1/94	4.3649	0.36.1	10.1572	0,3514	0.145.0	0.3340	0.111	41.71	1025.0	0.326.0	0.3172	. 0,3114	0. 100 1	0.3007	0.2/53	0.2877	0.2047	0.2734	0.2.743	0.2072	0.2641	0.2591	10,2542	0.2473	0.2445	0.2397	0.2350	0.2304	0.2258	0.2214	
7 1010		0.7	02.34.0	0.4522	0.4453	0.4384	0.4314	0.4244	0.4174	. 4014*0	0.4034	4067.0	0.1HV5	0.3826.	0.1757	000	0.01.0	3 70 . 0	9787	0.34.70	0.1424	0.3360	0.3297	0,1234	0.3372	0.3111	1500.0	0.2991	0.2933	0.2075	0.2019	0.2763	0.2708	0,2653	0.2600	0.2547	0.2495	0.2444	401.5	0.2344	0.2295	
		2.5	0.5659	0.4974	0.4008	0.4001	0.4714	01.46.25	0.4539	0.4853	. 9984-0	3000	1034.0	20110	4 6 6 6	25.0	0.3948	0, 3868	0.3709	0.3711	0.3635	0,3560	0.3487	0.3414	0.3343	0.3274	0,3206	66.16.0	0.1073	0.000	0.2946	0.2001	0.2823	0.2763	0 20105	0.2647	0.2591	36360	2503.0	7777	0.2174	
	DH IN INTER	4.0	0.5666	0.5551	0.14/15	0.5320	0.5204	0.5007	0.4975	1,4116.1		.76/10	1 424 0	0.4530	2644.0	0.1130	0.4210	0.4113	0.4018	0.3945	9696.0	0.3767	1895.0	. 1661.0	0.3516	36.45	9		6026.0			0.2000	0.2912	7.400			0.52.0	0.402.0	0.2019	0.250	F0GZ*0	
•	DISTRIBUTION IN INTER-ELECTRONE	ş. I	0.6489	7169.0	0.6146	\$0.5977	0,5011	0.5640	() 4 W	4	6556.0	0.15.0	0.5047	0.49090	0.4776	Q+24.0	0.4523	0.4404	. 0.4289	0.4178	0.4071	0, 3968	0.3868	0.1772	0.3679				0.14.1	0.11.0	0.1230		0,36,0	מייים י	0.2959	0.200	0.2822	0.2757	0,2693	0.26.10	0.2509	0.2509
	PUTENTIAL	· •	0.7049	0.1350	0.7064	0.6754	0.68.10	4954	0.020	0.600	0.5854	0.5652	0,5462	0.5282	0.5112	0.4962	0.4400	0.4655	0.4\$1B	3,4307	0.4263	•		1661.0	17650		0.1710	0. 36.9	∂₽ 1527	0.54EV	0.3350	0.126	0.11.80	0.3108	2001.0	0.2958	0.2887	0.2017	0.2750	0.2684		0.2558
		· ·	9150		0000		7 7 7 7	0.1623	0.6506	0.6590	0.6304	. 0.4042	-0.5862	0.5560	0,£375	.0,5165	1000.00	0.4841	0.4665	0.4538	901400	0.4267	0.4142	*******	******	0165.0	0,42802	0.3699	0.3600	0,3506	0.3413	0.1325	0,3241	0.3169	0.3079	0.3003	0.2920	0.1856	0.2767	0.2719	0.26\$2	0.2560
					0.9236	0.63.0	9 5 00 5 0	0.7587	0.7170	9109.0	0.6493	0.6202	91.92.0	0.5698	0.5470	1.4	0.5086.	1164.0	1974.0	6.456			*11.4.0	F111 0	0.404.0	0.3944	0.3833	0.3727	0.3626	0,3529	0.34.35	0.3346	0632c0	0.7176	9605.0	0.3010	0.2943	0.2010	0.2799	0.2730	0.2664	0.02200
•	•				90 • 6.	00 0	0. 7	09.6	9.50	0 40	9.30	9.23	· 61 .	. 00 .	0.40	00.00	02.4	H. 60	9			90.	02.0	6.10	00.0	05 • 2	100	7.70	7,60	7.50	7.40	0r 1	1.20	7.10	1.00	6. 30	6. 60	6. 70	6.60	05.0	6.40	.43.30

	0.1.926	0,1840), I us4	0.1019	0.1783	0.1748	0.1713	0.1678	0.1644			. 6/51.0	0.1541	0.1508	0.1474	0.1441	0.1408	0.1375	0.1342	01110	0.1277	0.1245	0.1213	0.1181		9511.0		, 1001.0	0.1056	0.1025	4,69.0	. 1960.0	0.0932	2060.0	0.087	0.004	1190.0	0.0701	0.0751	0.0722	0.00.02	0.0662	:.	
	0, 2005 0	0 . 1461.0	0.1928. 0	0591.0	0) (69110						0.1668	0.1632	1961.0	1951.0	0.1526 .	1611.0	0.1456	0.1421	0.1367	0.1353	0.1319	4871 6	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	10110	. 17110	0.11.66	0.1153	0.1121	0.1008	0.1056	.0.1024	0.0992	0.0.00	0.9929	0.0057	0,0006	0.0035	0,0404	0.0173	0.0142	0.0/11	0.0481	,	
s	0.2006	0.2045	C.2004	,	,	•	0.1844			0.1706	0,1727	9601.0	1591.0	0.1614	0.1577	0.1610	+001.0	0.1467	0.1435	90:130		2051.0	6261.0	0.1290	0.1256	0.1221	6.1107	0.1153	0.1120	9901.0	.0.1053	6,1020	6.0587	0.0954	0,0922	0.0000	0.0857	0.0025	0.0794	0.0762	0.0730	5500.0		
•	0,2107	0.2123	0.2017	0.2015	2 2 2		0.1.1.0		0:180/	0,1420	0.1705	0.1743	0.1703	0.1666	0.1620	Husi o	0.44	7		7 1 1 1	0.1437	0.1400	10110	0.1127	0.1291	0.1255	0,120	0.1145	0.11.0	0.1115	0.1001	0.1017	r101.0	0.0017	\$ 0.0342	210.00	0,0017	0.0040				3.00		•
	2347	21.00		0.2132	0.210	0.2050	0.2015	0.1970	0.1926	6661.0	0.1840	0.1790	0.1756	2 2 2			7701.0	76010	1661.0	0.1564.	0.1475	0.1437	0.1399	1911.0	0.1324	0.1287	0.1250	0.1214	0.1178	24110	90110	0.1071	9501.0	0.1002	1960.0	0.0933	6680	0.0865		1600.0	0.070	0.0764	0.0731	
		0,2343	0.22/2	0.2222	0.2172	0.2124	0.2070	0.2029	0.1982	0.1937	18401			5001.0	0.1760	0.1717	0.1675	0.1633	0.1592	1551.0	0.1511	0.1471	15 +1 .0	9.1392	0.1354	0.1316	0.1278	0.1240		77110				0.1039	1000	2870.0	166010	01'6070	0.0182	0.0047	0.0813	0.0777	0.0745	.·
_		0.2392	0.2338	0.22d4	0.2252	.0.2181	0.2130	0,2001	0.2032	*****	19.	0.1937	1691.0	0.1845	00110	65/1.0	0.1711	0.1668	0.1625	0.1503	0.1542	0.1530	0.1460	0.1420	0.11.0	095110			5071.0	0.1263	2011.0	0:11:0	0.11.0	0.1076	6.101.0	0.1003	0.00.0	0.0932	0.0076	1900.0	0.0026	1670.0	0.0757	
,	•.	0.2451	10.2394	0.2330 De	0,2243	0.2229	0.2176		1000	0.50	0.2024	0.1476	0.1927	0,1679	0.1033	0.1787	0.1742	1491.0	0.1063	0.1610	0.1567	0-1525	E041.0			10 11 0	1961.0	0.1321	0.1282	0.1243	0.1204 .	0.1166	0.112н	1601.0	0.1054	0.1017	0.0940	0.0944	0.000	0,0072	0.0837	0.0802	0.0767	
•		0.2457	0.2437	0.2379	0.2322	0.2266		÷	0.12.0	0.2106	0.2054	0.2004	0.1954	9061.0	0.1858	0.1811	0.1764	91110	0.1674		•		501.0	0001.0	0.1456	0.1417	0.1376	0.1335	0.1295	0.1256	0.1217	0.1178	0.1140	0.1102	0.1064	0.1027	066010	0.0953	0.0917	0.0000	0.0845	0,000	0.0774	
	•	0.2525	0.2464	0.540	4116	0773	0.2209	0.2233	0.110	0.2125	0.2013	0.5052	0,1571	0.1922	0.1073	0.1825	0.1770	217.0	404.	2701.0	0.1642	0.1557	0.1554	1151.0	0.1460	0.1426	0.1385	0.1344	13c 100	0.1264	0.1254 .	0.1165	0.1147	0.1168	0.1070	0.1033.	0.0956	0.0959	0.0522	0.0066	0443	4163	0.623.0	; ;
		26.36		0.2474	0.241.5	0.2355	0.2297	0.2241	0.2186	0.2132	0.2079	0.2028	A-1977	2001			0.000	70.7.		0.1691.0	0.1646	0.1601	9581.0	0.1514	0.1472	01 1 1 0	. 0.1368	0.1347	0.1307	0.1263	0.1227	0.1100	0.1149	0.1111	0.1073	0,1035	0.0998	0.0960	420000		0.000	10000	0.0013	0.07
		•		, 01.9	to • 00	2.40	5.60	5. 70 .	5.60	5.50	- Q	;			o1 :	00 .	4.40	9	02.	4.60	4 . 50	4.40	. 00	4.20	01.4	00.4	3, 90	3.80	3, 70	04.1	05.5	9	9					3 6) · ·	2.10	2.60	0°.5	2, 43	2.10

0.0603 0.0574 0.0545 0.0546 0.0458 0.0458 0.0472 0.0472 0.0342 0.0245 0.0245 0.0220 0.0220 0.0142 0.0142	
0,0051 0,0550 0,0550 0,0550 0,0550 0,0510 0,0410 0,0410 0,0101 0,0122 0,0122 0,0234 0,0263 0,0175 0,0263 0,0175 0,0263	•
0.0668 0.0636 0.0674 0.0574 0.0574 0.0583 0.0482 0.0482 0.0360 0.0391 0.0300 0.0300 0.0160 0.0160 0.0160 0.0160 0.0160 0.0160	
10.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044 0.0044	
0.0646 0.0640 0.0633 0.0666 0.0536 0.0536 0.0440, 0.0472 0.0472 0.0472 0.0472 0.0472 0.0250 0.0250 0.0145 0.0146, 0.0146	•
0.067U 0.067U 0.057U 0.057U 0.057U 0.057U 0.057U 0.057U 0.057U 0.057U 0.057U 0.057U 0.057U 0.051U 0.0119 0.0119 0.0129 0.0225 0.0225 0.0127 0.0127 0.0127 0.0127	
0.0123 0.0041 0.0052 0.0052 0.0052 0.0052 0.0052 0.00350 0.0350 0	
0.0697 0.0697 0.0697 0.0629 0.0555 0.0551 0.0527 0.0427 0.0427 0.0427 0.0427 0.0246 0.0294 0.0228 0.0294 0.0294 0.0294 0.0294 0.0294 0.0294 0.0294 0.0294 0.0296	
0.0738 0.0701 0.0269 0.0566 0.0532 0.0563 0.0532 0.0444 0.0439 0.0357 0.0359 0.0259 0.0259 0.0150 0.0150 0.0150 0.0150 0.0150 0.0150 0.0150	,
0.6743 0.6662 0.6633 0.0663 0.0663 0.0563 0.0399 0.0399 0.0332 0.0332 0.0232 0.0232 0.0232 0.0232	•
0.0144 0.00709 0.0074 0.0074 0.0079 0.0079 0.0079 0.0570 0.0570 0.0570 0.0570 0.0570 0.0570 0.0570 0.0570 0.0570 0.0199 0.0199 0.0199 0.00192	
2.20 2.10 2.60 1.40 1.40 1.50 1.50 1.10 0.90 0.90 0.90 0.50 0.40	



EQTENTIAL DISTRIBUTION ON CYLINDRICAL PORTION OF THE BOUNCARY

R =	i.o :
ZS	POTENT IAL
11.00	1.0000
12.00	1.0000
13.00	r.3046
14.00	0.9952
15.00	1.0000
16.00	1.0089
17.00	1.0172
18.00	1.0223
19.00 >	1.0211
20.00	1.0092
21.00	0.9963
22.00	0.9923
23.00	0.9931
24.00	0.9961.
25:00	1.0000
26.00	1.0043
27.00	1.0085
28.00 _,	1.0125
29.00	1.0161
30∙00	1.0190
31.00	1.020-9
32.00	1.0214
33.00	1.0195
34.CO	1:0132
35.00	0.9996
36.00	0.9858
37.00	0.9791
38.00	0.9764
39.00	0.9759
40.00	0.9765
4100	0.9778
42.00	0.,3796.
43.00	0.5817
44.00	0.9841
45.00	0,4366
46.00	0.9392
47.00	0.9918

Sand of the A

0.2uE 01 00	0.0	-0.20 t 01 ***	-0.30E 01 ••

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POTENTIAL DISTRIBUTION ON SPHERICAL PORTION OF THE BOUNDARY

zs	, R	POTENTIAL
10.0c	0.0735	1.0000
10.01	0.1554	1.0000
10.03	0.2334	1.0000
10.05	0.3090	1.0000
10.08	0.3827	1.0000
10-11	0.4540	1.0620
10.15	0.5225	1.0000
10.19	C.5878	1.0000
10.24	.0.6494	1.0000
10.29	0.7071	1.0000
10.35	0.7504	1.0000
10.41	0.8090	0.9999-
10.48	0.8526	0.9999
10.55	0.3910	0.9999
10.62	0.9239	0.9998
10.69	0.9511	0.9998
10.77	0.97241	0.9997
10 🕳 4	0.9877	0.9997
10.92	0.9969	0.9998
11-00	1.0000	1.0000

0.2JE-01 ••	ı			•		•		•	
, , , ,						•		•	
0.17E-01							•	•	
0.116-01	· ·	•	•				•	•	-
	•						•	•	
0.546-02	,		•		•		. •		
0.248-02		• •	•	•	• .	•			

PUTENTIAL DISTRIBUTION ALONG THE SPHENKCAL PART OF The Worlday

APPENDIX 2

COMPUTER PROGRAM FOR THE POTENTIAL DISTRIBUTION
OF A ROD-PLANE GAP USING THE OPTIMIZED CHARGE
SIMULATION TECHNIQUE.

The following program represents a solution of equation 3.9 for nine semi-infinite line charges and one point charge. The variables of optimization are the positions of the charges (r_i, z_i) and their values Q_i (i=1,2,...10). The constraints imposed on the variables are given in Table 3.2.

The initial values of the variables are chosen within their corresponding constraints. In this case due to the relatively slow convergence of Rosenbroks optimization subroutine, the initial values used are the final values of the variables from a previous run. The overall computer time (on a IBM 360 fast core) is approximately 70 min, and it is typical for optimization of a function with large number of variables using Rosenbroks optimization technique.

Note: As an addition to references provided in the main text, it should be noted that, Anis et-al (77) have recently presented a modified charge simulation technique by applying multiple linear regression to the number and position points (r,z) on the boundary surface, against the number of the fictitious charges. This is a quisi-optimization approach and like the method presented here it represents an improvement over the conventional charge simulation technique.

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STEV2
                                             XXXXXXXXX
          $108
C
C
C
                           WATFIV
                                                                                                                        ROD-PLANE
                                                                                         SOLUTION OF
                        OPTIMIZED CHARGE SIMULATION
                        EXTERNAL SUB
DOUBLE PRECISION TI.T.R.Z.DSIN.DCDS.P.ZS.GG.F.A(9),ZET(9)
DOUBLE PRECISION RR.YY(100).PDT(10).XS(20).VTDTAL.VOLT(100,20)
DOUBLE PRECISION GPDT.GPL.PTRAD.FX.PDTX.
DOUBLE PRECISION S(500).G(20).H(20).U.B.X(2G).DUM
DOUBLE PRECISION S(500).G(20).H(20).U.B.X(2G).DUM
DOUBLE PRECISION S(500).G(20).H(20).U.B.X(2G).DUM
DOUBLE PRECISION S(500).G(20).H(20).XCDI(60).YCDI(60)
DOUBLE PRECISION Z1.TS.XX(100)
DOUBLE PRECISION Z1.TS.XX(100)
DIMENSION VALT(100.20).XCDI(100).YCDI(100).XCDI(60)
INTEGER N
  1234
  6789
                          INTEGER N
1 C
                         READ IN THE FOLLOWING DATA

GPL = GAP LENGTH - IN CENTIMETERS

PTRAD = RADIUS OF THE HEMISPHERICAL

GPOT = POTENTIAL ACROSS THE GAP - (
            COOOC
                                                                                                                                              CENTIMETERS .
                                                                                                            ELECTRODE
                                                                                                               VOLT)
                 READ (5.112) GPL.PTRAD.GPOT

112 FORMAT (F8.2/F5.2/F8.2)

998 WRITE (6.8) GPL.PTRAD.GFOT

8 FORMAT (1HC./.24X.'GAP LENGTH = 1.1/.22X.'GAPPOTENTIAL = 1.F7.2//)
1.1
·12
13
                                                                                                      F7.2.//,22X. POINT RADIUS
 1 4
                                = GPL/FTRAD
                          NOUMBER OF VARIABLES : N
                           N = 20
  16
                           F =GG+1.0DC
 į 7
             C
 1501223
                           KWRT = 1
                           INDEX = 2
                           NVR = -20
                          NCON = 20
                            NF IG =
                               = 500
                           NTRIPY = 500
   24
                                    0
  25
                            INTRODUCE THE CONSTRAINTS IMPOSED VARIABLES OF OPTOMIZATION .
              SOUP
                                                                                                          CN
                            DO 1 I = 1.1C
H(I) = 10CCC.CDO
G(I) =-1GCCC.CDO
   26
27
28
29
30
                             CONTINUE
                            DO 3 I = 11.20
G(I) = GG+C.99DO
H(I) = F+4E.CDC
    31
                   3 ړ
                             ASSIGN INITIAL VALUES TO THE VARIABLES OF OPTIMIZATION. THESE VALUES CAN BE ARBITRARY NUMBERS WITHIN THE LIMITS CONSTRAINTS. OR VALUES OF THE VARIABLES FROM A PREVIOUS
    32
               00000
                                                                                                                                                              OF THE
                                                                                                                                                               RUN.
                                            13.46400
                             X(1) =
X(2) =
X(3) =
                                              -18.CSEDC
1.9527DC
     33
    33333333
                                             3.549DC
-C.689DO
-C.C317DC
                                        =
                              X(4)
                              X(5)
X(6)
X(7)
                                         = -0.0153D0
= -0.041600
= -0.0090600
                                         =
                               x(8)
     4 C
                               X(9)
     41
                                           = -C.(7900
                               x(-16)
                               X(11)
X(12)
     44
                                                 F+(.115D0
      45
46
47
                               x(13)
                                            =
                                                F+C.45700
F+C.48700
                                             =
                               X(14)
                               X(15)
                                                F+1.176D0
F+1.537DC
                               X(16)
X(17)
      48
                                                  F+16.5600
                                X(18)
      5 C
                                                  F+C.C17D0
                                x(19)
      51
                                                 F+47.46500
                                           CLIMBD (NVR.X. NCCN, U, NFIG.S.L., KART.G.H. INDEX. NTRIPV. SUB)
I = 1.20
                                X(20)
      52
                                           THE
                                CALL
                                CALL DO 5
      53
      54
                                             =
                                                 ×(I)
      55
```

0.000

```
RR = 0.000
 57.
                                                                    -173-
                    ココニエ
 5 E
. 59
             102
                    ZS = GG
 6 C
                    I \cdot I = 1
             105
                   DU 101 I = 1.5
 62
63
                    YY(II)=ZS
                          11 + I
                  PDT(I) = XS(I)*DLDG((XS(J)+ZS+DSQRT(RR+(XS(J)+ZS)*(XS(J)+ZS))
1(XS(J)-ZS+DSGRT(RR+(XS(J)-ZS)*(XS(J)-ZS)))
 64
 65
             101
                    CONT INUE
 66
                  POT(10) = XS(10)*(1.000/DSQRT(RR+(XS(11)-ZS)*(XS(11)-ZS))
21.000/DSQRT(RR+(XS(11)+ZS)*(XS(11)+ZS)))
                    PDT(10) =
 647
                    VTGTAL = C.OCC
DO 103 K = 1.10
 ó٤
 67777777
                    VTOTAL = VTCTAL+POT(K)
             103
                    CONTINUE
                    VOLT([I.JJ) = VTOTAL
Z1 = ZS-61.000
IF (F-Z1) 200.201
             201 CONTINUE
 75
76
77
                    IF(ZS-GG) 212,212,213
ZS = ZS-GG/100.000
                    II = II + 1
 78
79
80
                    IF(II-100) 105.105.231
                    CONTINUE
                    ZS = ZS+1.CDC
II = II+1
 81
 82
                    GO
                        TO 105
             231 CONTINUE
 84
                    IF(R-5.0DC) 202,203,203
 85
                    CONTINUE
R = R 0 -SDC
 86
                    RR = R*R
             JJ = JJ+1
GO TO 102
203 CONTINUE
 88
 85
9¢
          C
             WRITE (6.1C6)

106 FORMAT ('1'.35X.45HPOTENTIAL DISTRIBUTION IN INTER-ELECTRODE REGIO IN .//.4X.5HZ / R.5X.3

1H0.0.8X.3HC.5.3X.3H1.0.8X.3H1.5.8X.3H2.0.8X.3H2.5, 8X.3H3.0.8X.3H3

2.5.8X.3H4.0.8X.3H4.5.8X.3H5.0)

WRITE (6.1C6) (YY('II).(VOLT(II.JJ).JJ=1.11), FI=1.100)

107 FORMAT ('0'.F7.2. 11F11.4)

DO 403 II = 1.1C0
 91
 92 .
 93
 94
95
96
97
                    VALT(II:1) = VOLT(II:1)
XCO(II) = YY(II)
YCO(II) = 1-000-VALT(I
             YCO(II) = 1.000-VALT(II.1)

403 CONTINUE

WRITE(6.556)

596 FCRMAT('1'.25x,'POTENTIAL DISTRIBUTION ALONG THE AXIS OF HIGHEST
 98
 99
100
101
                  TIELD STRENGTH!)
CALL PLOT E(XCG, YCO, TOO)
102
             CALL PLO
103
                    COMPUTE POTENTIAL DISTRIBUTION ON CYLINDRICAL PORTION OF EDUNDARY
104
                       = 1.000
105
                    RR = 1.000
106
                    LL
                        =
107
                    ZS
                        =
                           F
īοε
                    ΙI
105
                    GQ TO 105
110
             200 CINTINUE
                    WRITE POTENTIAL DISTRIBUTION ON CYLINDRICAL PORTICA OF ECUNDARY
                  WRITE (6.206)
FORMAT_('1',25x,'POTENTIAL DISTRIBUTION ON CYLINDRICAL PORTION OF
1 THE BOUNDARY',//,53x,'R = 1.0',//,53x,'ZS',7x,'POTENTIAL')
117
             206
             WRITE (6.207) (YY(II), VOLT(II, 1), II=1,60)
207 FORMAT (('C', 50X, F7.2, F11.4)
DD 401 IT = 1 50
113
114
                    DO 401 II = 1.50 - VALT(II.1)
115
116
                    XCCI(II) = , YY(II)
118
                    YECI(II)
                                       (1.CD 0-VALT(II,1)) *10 0.CDC
119
             401 CONTINUE
          UUU
                    COMPUTE ZS AND R COORDINATES OF SPHERICAL PORTION OF BOUNDARY
```

```
120
121
                   WRITE(6.1801)
                 FORMAT('1',30X, 'POTENTIAL DISTRIBUTION 10F THE SCUNCARY')
CALL PLOT 3(XCOI,YCOI,50)
                                                                             ALONG THE CYLINDRICAL
           1,801
122
                   1 = LL
124
                   II = 1
125
126
127
                  TS = T1*L

R = DSIN(TS)

ZS = GG+(1.000-DCUS(TS))

YY(II) = ZS
 128
 īãó
                   xx(II) = -\bar{R}
 131
                   RR = R*R
 132
                   COMPUTE POTENTIAL DISTRIBUTION ON SPHERICAL PORTION OF BOUNDARY
          č
                   DO 258 I = 1.9
 133
134
                  POT(I) = XS(I) *DLOG((XS(J) + ZS+DSQRT(RR+(XS(J) + ZS) * (XS(J) + ZS)))/
1(XS(J) - ZS+DSGRT(RR+(XS(J) - ZS) * (XS(J) - ZS))))
 135
             258 CONTINUE
POT(10) = -x5(10)*(1.0D0/DSGRT(RR+(XS(11)-ZS)*(XS(11)-ZS))
21.0D0/DSGRT(RR+(XS(11)+ZS)*(XS(11)+ZS)))
 136
 137.
                   VTCTAL = 0.000
DO 109 K = 1.10
 138
139
                    VTOTAL = VTCTAL+POT(K)
 14 C
14 1
              109
                  -CONTINUE.
                    VOLT(II+JJ) = VTOTAL
  142
 143
                    II := II + 1
              259 CONTINUE
  144
                    WRITE POTENTIAL DISTRIBUTION ON SPHERICAL PORTION OF BOUNDARY
                  FORMAT (*1:.40x, *POTENTIAL DISTRIBUTION ON SPHERICAL PORTION OF TH 1E BOUNDARY*, //.50x, *Z$*, $x.*R*, 7x, *POTENTIAL*)
WRITE (6,321) (YY(II), xx(II), VOLT(II,1), II=1,20)
FORMAT (*0:.47x, Fo.2. F11.4 , F11.4)
                    WRITE (6.320)
  145
            .320 FORMAT
  146
  147
              321 FORMAT
  148
                    DO 402 II = 1.20
  145
                    VALT(II.1) = VOLT(II.1)
  15C
                    YCOJ(II) = (1.0D0-VALT(II.1))*100.000
  151
152
153
                   XCCJ(II) = >X(II)
CONTINUE
                   WRITE(6.1802)
FORMAT(*1*.3CX.*POTENTIAL DISTRIBUTION ALONG THE SPHERICAL
1 THE BOUNDARY!)
  154
  155
            1802
                    CALL PLOT 3(XCOJ,YCCJ,20)
  156
                    STOP
  157
                    END
  158
```

THAT IS

```
SUBROUTINE SUB REPRESENTS THE OBJECTIVE FUNCTION (U), THE BE MINIMIZED. UIN THIS CASE IS THE ACCUMULATIVE SQUAR ALONG 15 POINTS ON THE SPHERICAL PART OF THE ELECTRODE, ALONG 15 POINTS ON THE SPHERICAL PART OF THE ELECTRODE,
         nnnnnn
                                                                                                                        AND 50
                     POINTS ALENG THE CYLINDRICAL PART.
                    SUBROUTINE SLB(NVAR.X.NFGN.U.G.H)
DOUBLE PRECISION X(20).FX1.FX2.FX3.FX4.T.T1.DS1N.DCD5.R.Z.FX5
DOUBLE PRECISION G(20).H(20).U .PDT(99).TT(5)
DOUBLE PRECISION DSQRT.FX6.DLOG.P.CAB5 .F.ZZ(7).GG
159
160
161
162
                     J = 0
FX6 = 0.000
164
                            =. 0.CDC
                     FX4
165
166
167
                                0.000
                     FX2 = 0.0DC
                     GG = 10.0DC
F =GG+1.0D0
X(11) = F
 168
169
170
                     \hat{x}(\hat{1}\hat{2}) = \hat{1}\hat{1} = \hat{1}
 171
                           C. 01DC
                      Ť
 172
                            DSIN(T)
                        =
 173
                            F-DCOS(T)
 174
                      DO 5 1 = 1.5
                      F \times 1 = X (I f * DLDG((X(J) + Z + DSQRT(R*R + (X(J) + Z) * (X(J) + Z))))
 175
 176
                                                                 -Z]*(X(U)-Z))))
                        (\dot{x}(J)-\dot{z}+\dot{p})
                     CONTINUE

FX5 = X(10) *(1.000/DSQRT(R*R+(X(11)-Z)*(X(11)-Z))

11.000/DSQRT(R*R+(X(11)+Z)*(X(11)+Z)))
 178
179
                   5
  180
                       FX2 = FX2+FX5
POT(II) = FX2
  181
                       FX3 = (1.000-FX2)*(1.000-FX2)
  182
  183
                             = FX4+FX3
                       FX4
                       Tî = (180.c0C/3.14159DC)*T
  184
  185
                       FX2 = 0.0000000
II = II+1
T = T+0.1D0
  186
  187
  188
                                            1.1.6
                        IF (T-1.500)
   189
                       CONTINUE
FX2 = 0.00C
   190
                       -FX2
  191
                              1.000
                        R =
   192
1.93
                        K =
Z =
                           =
   194
                        DC 25
   195
                  20
                        FX1 = X(I)*DLDG((X(J)+Z+DSORT(R*R+(X(J)+Z)*(X(J)+Z)))/
(X(J)-Z+DSORT(R*R+(X(J)-Z)*(X(J)-Z)))
   196
   197
                        FXE = FX2+FX1
   198
                        FX5 =X(1C)*(1.CCO/DSORT(R*R+(X(11)-Z)*(X(11)-Z))
                       CONT INUE
   199
                       11.000/DSGAT(A*R+(X(11)+Z)*(X(11)+Z)))
    200
                        FX2 = FX2+FX5
POT(K) = FX2
   201
202
203
                         FX3 = (1.000-FX2)*(1.000-FX2)
FX6 = FX6+FX3
    20/4
                       :K = K+1
                       FX2 = 0.0DC

·IF(Z-(F+2.0DC))

Z = Z+0.5DC
    206
                                                          40,40
    207.
    208
                         GOTO 2'0
Z = Z+1.00C
    205
210
211
                         IF(Z=(GG+50.CDO))
    212
                                        +FX6
                              = F × 4
                         U
                          RETURN
     215
```

A CHARLES AND A

```
-176-
```

```
SUBROUTINECLIMBD(NVR.X.NDN.U.NFIG.S.LS.KWRT.G.H.INDEX.NTFIPV.FCN)
275
                FUNCTIONAL OFTIMIZATION BY ROSENBROCK S METHOD OF HILL-CLIMBING
        Č
                                                                       NVAR # (NVAR+5) +NCON
                THE ARRAY S MUST BE DIMENSIONED AT
                                                                LEAST
        υμυψυμυμυμυμύν
                                                                                    SUPPRESSED
                                                                         CUTPUTS
                KWRT SET AS FOLLOWS FOR OUTPUTS
                                                                    2
                                                                        AT START AND END CHLY
AT END OF EACH STAGE
AFTER EVERY N TRIALS
                                                                    ٥
                             SITIVE FOR SIGNIFICANT FIGURE CONVERGENCE CRITERION ... CONSTRAINTS ON INDEPENDENT VARIABLES - SETS G.H LARGE FINITE CONSTRAINTS ON INDEP. VARIABLES SUPPLIED ON ENTRY
                          FCSITIVE
                 INDEX
                 Ð
                             FCR RE-ENTRY WITHOUT INITIALIZATION
                 AS IN 3 BUT KTRIAL = 0
INDEX NEGATIVE OF ABOVE FOR EXIT CNLY AFTER SPECIFIED TRIALS
                 IMPLICITE AL *8(A-H.O-Z)
DIMENSIONE(E).G(NON).H(NON).X(NON).S(LS)
 28 C
               INITIALIZATION
LINE COUNTER IS SET SO THAT HEADINGS WILL BE PRINTED.AT
 281
                                                                                            THE HEAD
                 EVERY PAGE.
             OF
 282
                  NCCN=NCN-IAES(NVR)
 283
                  NV AR= I ABS (NVF)
 284
                  SGN=NVR/NVAR
 285
                  NWRT=IAES(X #RT)
 286
                  NTCT=NVAR+NCEN
  287
                  N2=NVAR+(NVAF+1)
  288
                  N3=N2+NTCT
  285
                  N4=N3+NV AR
  290
                  N5=N4+NV AR
  291
                  NTRIAL=NTRIFV*NVAR
  292
                  NCCNS=NTGT
  293
                  NT=NVAR+(NVAR+5)+NCON
  294
                  NEND=0
  295
                  -CONV=.500*(.100)**NFIG
                   IND=IABS(INDEX)

THE COMPROMISE VALUES OF THE 3 HILL-CLIMBING PARAMETERS FOLLOW

THE COMPROMISE VALUES OF THE 3 HILL-CLIMBING PARAMETERS

ALPHA AND EETA ARE FORWARD AND BACKWARD STEPPING PARAMETERS
  296
  297
         ٠Ç
                   ALPHA= 2.DC
  298
                   BETA-.500
  295
                   FAIL=1.DO
   300
                   CL IFF= .000100
   301
                    IND1=0
   302.
                   GOTO(1.2.150.5). IND
   303
                   KTRIAL=0
          ٠,5
   ·304
                   IND1=1
   305
                   MWRT=NWRT
   306
                    GOTO39
   307
                    DOZI=1.NVAF
            1
   308
                    NCCNS=NCCNS-1
   309
                    G(I)=-1.00+75
   310
                    +(I)=-G(I)
           2
   311
                    D04 I=1 .NT
   312
313
                    S(1)=0.D0
IF(KWRT.GT.1]GDT011
    314
                    IF (SGN) 10 . 7 . 7
    315
                    WRITE(6.101) NVAR NCONS
    316
317
            7
                    GOTO 11
                                                                                VARIABLES WITH
                    WRITE(6.102)NVAR.NCONS
                                                                       ',I3,'
            10
                                                   OF FUNCTION OF
                    FORMAT (////EX. MAXIMUM
    318
            101
                                                                                 VARIABLES WITH
    319
                   * CENSTRAINTS')
                                                                        ·,I3,'
                                                    OF FUNCTION OF
               102 FORMAT (////5x. MINIMUM
    320
                   * CCNSTRAINTS!)
                11 E(2)=0.00
E(3)=C.D0
    321
322
                     KTRIAL=C
    323
                     MWRT=NWRT
    324
                     CO 15 I= 1 -NV AF
    325
                     IF(G(I)-H(I))13,14,13
     326
                     S(I)=#1D0
     327
            · 13
                     NI=(NVAR+1) * I
             14
     328
                     S(NI)=1.DC
     32 9
33 0
             15
                     BIC=DABS (X(1))
                      IF (NVAR .EC . 1)GOTD185
     331
```

DO18 I= 2. NVAR

16

```
AEX=DAES(X(1))
  333
                 IF (ABX . CT . E 1G )BIG=ABX
 334
                 CONT INUE
  335
         18
                 BIG=10.D0*(FLPHA-1.D0)*BIG+1.D0
         185
  336
                 KCCNV=0
  337
                 X0=1.D0
  338
                 IF (XO.GT.BIG)GOTO21
         -19
  335
                 KCCNV=KCCNV+1
         20
  34 Ô
                 XC=ALPHA*XC
  341
                 G0 T0 19
  342
         C.
                 CHECK INITIAL VALUES WRT. CONSTRAINTS IF (NCON.LT.1) GOTO225
  34 Z
         21
                 NV 1=NV AR+1
          215
  344
                 NC I=NVAR+NCCN
  345
                 D022I=NV1.NC1
  346
                 X(I)=.5D0*(G(I)+H(I))
  347
  348
                  NG=0
                  DO38 I= 1.NTCT
  349.
                  IF(H(I)-G(I))35, 25, 25
IF(X(I)-G(I))27, 26, 26
IF(H(I)-X(I))28, 38, 38
  350
  35.1
          25
          26
  352
                  IF(DABS(G(I))-1.D0)24.24.23
  353
          27
                  X(I)=G(I)+CLIFF*DABS(G(I))
          23
  354
                  GD TD 30
  355
                  X(·I)=CLIFF
  35€
          24
  35 Ŧ
                  GD TO 30
                  IF(DABS(H(I)-1.D0))37.37.36
          28
  358
                  X(I)=H(I)-CLIFF*DABS(H(I))
  359
          36
                  GBTD30
  360
3(
                  x(I)=CLIFF
  361
          37
                  IF (NG.NE.0)GCT032
  362
363
          3C
                  wRITE(6,105)
                                                                                    JN CONSTRAINTS!
          31
                  FORMAT ( /5x . INITIAL VALUES MUST NOT LIE CUTSIDE
                                                                               DR
           105
   364
                 *//)
                  NG=1
   365
                  IF(G(I)-H(I))33.34.33
           32
33
   366
                  WRITE(6, 106) I.X(I)
   367
                  FORMAT(ICX, "VARIABLE", 14."
                                                       TAKEN AS
           106
   368
                  GOTO38
   365
                  X(I)=G(I)
   370
           34
                   WRITE(6.107) I.X(I)
                                                      CONSTRAINED TO BE '.G16.7)
   371
                  FORMAT (10X. "VARIABLE", 14.
           107
   372
                   GOTO 38
   373
                 WRITE(6.1CE)I.G(I).H(I)
FORMAT(/SX.*FOR VARIABLE*.I4.*
* LIMIT*,E1E.8.* HAD TO BE INT
           35
                                                                                        AND UPPER .
   374
                                                            LOWER LIMIT .E15.8,
           1.08
   375
                                                 BE INTER CHANGED 1/)
                   G1=G(I)
   376
                   G(I)=H(I)
   377
                   \vdash(I)=G1
   378
                   G0T025
    379
                   CONT INUE
           38
    38 C
                   U1=C .DC
    381
                   IF (NTRIAL . EQ . C) GOTO 86
    382
                   CONT INUE
           39
    383
                   CALLFON(NVAR,X,NCON,U1,G,H)
    384
                   U1=SGN *U1
    385
                   D040 I= 1 - NTCT
    38€
                   N2 I=N2+ I
    387
                   S(N2I)=U1
           4 C
    388
                   IF (KWRT .EC . 2) GOTU90
    385
                   GOTO82
    39C
            000
                   BEGINNING OF HILL-CLIMBING
                   STAGE OUTFLIS OR END OF CALCULATION, IF (KWRT-1)82.81.83
            Č
               80
    391
                    IF (KTRIAL.EC.3820) GOTO871
    392
393
594
              305
                    IF (KTRIAL . EQ . C) GOTOE2
            81
                    IF (NEND . NE . 1 ) GOT 090
                    CALLFON(NVAR.X.NCON.B(1).G.H)
    395
            82
                    IF (L INES -LT - 60)GDTD999
    396
                    CONT INUE
               871
    397
                    PRINT99
                                                                       LAST SUCCESSFUL VALUE OF FUN
                                                                                             TUTAL DIS
    398
                                                    CURRENT TRIAL
                    FORMAT ( *1 1//T06, 'ND.
                                              OF
                                                                                      FUNCTIONAL VAL
            99
    399
                             CHANCE IN DIRECTN'/T6. TRIALS MOVED DF MOTION'/T
                   *TANCE
                                                                            VARIABLES! . T47. DURING
                                                   DE MOTION'/T14,'IND
                                 FROM LAST STAGE!/)
                   *UE
                   * STAGE
```

```
FORMAT(111-16X-3G16-7/(11X-G16-7))
4C2
               IF (KTR IAL .EG . 3820) GO TO EC
LINES-LINES+NVAR+1
40 Z
404
               IF(KWRT.EC.1)GCT088
405
               IF (KTRIAL .LT .NTRIAL) GOTGES
406
       83
               CALLFON(NVAR.X.NCON.B(I).G.H)
407
               U= E(1)
408
               RETURN
405
               IF (NEND.LT.1)GOT090
        88
410
               IF (KWRT.GE.2)GOTOBO
WRITE(6,113)NFIG
FORMAT (//5x, CCN VERGENCE TO 14.
        89
411
        91
412
                                                            SIGNIFICANT FIGURES REACHED
413
       .113
              *ALL INDEPENDENT VARIABLES. 1/)
        87
               GO TO 86
        C
        2000
              BEGINNING OF STAGE
               FORWARD STEP-OF VARIABLES
               IF (IND1.EG.1)GOT093
D092J=1.NVAR
415
41 É
               しょしょく しょくしょく
417
418
                し+ 30=し34
                S(N3J)=0.00
415
                S(N5J) = 0 . DC .
        92
420
421
        93
                JS=1
                IND1=0
422
                NEND=0
423
                DD96 I= 1.NVAR
424
        94
425
                IF(G(I)-H(I))95,96,95
                NI =NVAR* I+JS
426
        95
                (I) \times (2L) \times (IN) = (I) \times (I)
427
        96
               CONTINUE
428
                FUNCTION EVALUATION KTRIAL=KTRIAL+1
429
430
                CALLECN(NVAR.X.NCON,U2.G.H)
IF(KTRIAL.EG.3820)GOT0871
431
                U2=SGN*U2
 432
       Ç
                CHECK CONSTRAINTS
                DC128I=1.NTC1
 433
                N2 I=N2+I
 434
                IF(G(I)-F(I))125.128.125
 435
                IF(U1-U2)126,126,145
IF(X(I)-G(I))145,145,127
        125
 436
        126
127
 437
                 IF (H(I)-X(I))145.145.128
 43 E
                 CONT INUE
         128
 439
                D0135I=1.NTOT
440
 441
                 N2 I=N2+I
                 IF(G(I)-H(I))120.134.120
 442
443
                 IF (DABS(G(I))-1.00/121.121,122
         120
                 SN1=CL IFF.
 444
         121
                 GOTO123
SN1=CLIFF*CAES(G(L))
 445
 446
         122
                 IF(X(I)-(G(I)+SN1))129+130+130
         123
 447
         129
                 GO=(G(I)+SN1-X(I))/SN1
 44 8
                 G0T0132
 445
                 IF (DABS(H(I)-1.D0))136,136,137
 45 C
         13C
                 SNI=CLIFF
         136
 451
                 GCT0 138
 452
         137
138
                 SN1=CL IFF*DAES(h(I))
 453
                 IF(H(I)-SN1-x(I))131+133+133

GO=(X(I)-H(I)+SN1)/SN1
 454
 455
         131
 456
         132
                 H0=U2-S(N2I)
                 U2=U2+G0*HC*((4.D0-2.D0*G0)*G0-3.D0)
 457
                 IF (U1-U2) 135,135,145
  45 E
                 S(N2])=U1
  459
         133
                 G0T0135
  46 C
                 S(1)=0.D0
  461
         135
                 CONT INUE
  462
                 IF(G(JS)-+(JS))140,142,140
  463
                 2C+40=L44
  464
        . 140
                 SL+6N=L2N
  465
                 IF(S(N5J)-.500)141,142,142
  466
                 S(N4J)=0.DC
          141
  467
                 S(N5J) = 1.00
  458
                 2 C+EN=LEN
          142
  465
                 (2L)2+(LEN)2=(LEN)2
  47 C
  47 i
                 U1=U2
```

```
GG-TD-150
473
               UNDO UNSUCCESSFUL STEP AND REVERSE
                                                          DIRECTION WITH
                                                                              REDUCED
474
               00148I=1+NVAR
475
               IF(G(I)-H(I))146-148-146
476
               N [≒N VAR* I+JS
        146
               (2L)2*(1/)2-(1)x=(1)x
477
47E
               CONT INÚÉ
        148
479
               (2L)2*4T55-=(2L)2
48 C
               2 L+ 4M=L 4M
               S(N4J)=S(N4J)+1.D0
481
        c
               CHECK FOR STAGE OPTIMUM IN
                                                EVERY
                                                         DIRECTION
               IF (KTRIAL. CE.NTRIAL) GJTC30
        150
482
               D01551=1.NVAF
:483
        151
               IF(G(I)-H(I))152,155.152
484
        152
               N4 I=N4 + I
485
486
               N5 I=N5+I
               IF (S(N4I)+.500-FAIL) 160.153.153
IF (S(N5I)-.500) 160.155.155
487
        153
488
               CONT INUE
485
        155
               GOTO41
490
        160
491
                JS=JS+1
                IF (JS.GT.NVAR)GCTO165
492
493
                IF(KWRT.GE.0)G0T0170
        164
        165
                IF (KTRIAL .LT .MWRT) GOTO170
494
                INTERMEDIATE FORCED OUTPUTS
495
          166
               MWRT=MWRT+N#RT
               UP=SGN.*U1
496
               WRITE(6.115)KTRIAL, UP. (X(I).S(I).I=1.NVAR)
FORMAT(31X.I10.16X.G16.7/(11X.G16.7.16X.G16.7))
497
498
        115
                IF (US.LE.NVAR)GOTO94
499
        170
                GCT093
500
        169
                IF (KTRIAL.LT.KCCNV)GOTC164
501
                IF(INDEX.LE.C)GDT0164
502
        171
                CCNVERGENCE TESTS
               D01801=1.NVAF
503
               DX=0 -D0
, D0173K=1.NVAR
504
505
50 ć
                NI=NVAR*I+K
                DX=DX+S(NI)*S(K)
IF(DABS(X(1))-1.00)174.174.175
507
        173
50 E
                IF RELATIVE CONVERGENCE TESTS ARE MAGNITUDES THE PREVIOUS STATEMENT NEED. FOR EXAMPLE IF (ABS(X([V)))
                                                          DESIRED
                                                                    FOR LESS THAN UNITY
        nnnn
                                                          SHOULD BE CHANGED TO SUIT
                                                                                           USERIS
                                                         175,174,175
                                                   MAGNITUDES
                BUT UNDERFLOWS MAY OCCUR
                                                                ARE
                                                                     VERY
505
       - 174
                CRIT=CABS(CX)
                GOTO 176
 510
 511
        175
                CRIT=DAES(EX/X(-1))
        176
                IF (CRIT.GE.CENV) GOTO 164
 512
                CONT INUE
 513
        .180
 514
                NEND=1
 515
                G0 T0 80
                IF (KTRIAL.EQ.3820) G0 T0 671
           306
 516
        C
                TRANSFORMATION OF COORDINATES AT END OF STAGE
                                                                             GRAM-SCHMIDT, GRTH
 517
                D045 I= 1 . NV AF
 518
                NN=NVAR*I+NVAR
 515
                S(NN)=S(N4)*S(NN)
                D045J=2.NVAR
 520
 521
                1+1-3478=14
 522
                しい ナビバーしこん
                LA+I*AAVM=IN
 523
 524
        45
                S(NI)=S(NJ)+S(NI)+S(NI+1)
                IF (NVAR.EG.1)S(3)=C.0DO
 525
                D050J=2.3
        47
 526
 527
                E(J)=0.D0
 528
                D049 [= 1 . NVAR
                NI=NVAR#I+J-1
 529
 530
        49
                3(J)=$(N1)**2+6(J)
                B(J)=DSQRT(E(J))
B(Z)=B(Z)/E(Z)
 53 i
         50
 532
         55
                J=1.
 533
         56
57
                K=1
 534
 535
                IF(K.EG.J)60TG68
 536
         58
                OG. C=(1)E
                DC60 I= I . NVAR
```

4

53 9 54 0 54 1 54 2	60	NK=NI-K B(1)=B(1)+S(NI)*S(NK) B(1)=B(1)+S(NI)*S(NK) NI=NVAR*I+J	
543 544 545	65	NK=NI-K S(NI)=-S(NK)*E(1)+S(NI) K=K+1 GCTO57	
546 547 548	68	E(1)=0.D0 D070 I=1.NVAR NI=NVAR*I+J	
54 9 55 0 55 1 55 2	70	3(1)=8(1)+S(NI)**2 B(1)=DSQRT(E(1)) DC7S[=1+NVAR	
553 554 555 556 557 558	75 :	NI=NVAR*[+J S(NI)=S(N1)/E(1) J=J+1 IF(NVAR.GE.J)GOTO56 GOTO30 END	

TOTAL DISTANCE

DURING STAGE

0.0000000

MOVED

IN DIRECTN

STAGE

عن

FROM LAST

0.0000000

MINIMUM DEFEUNCTION OF 20 VARIABLES WITH 20 CONSTRAINTS

LAST SUCCESSFUL

FUNCTIONAL VALUE

4.319623

CURRENT TR

IND VARIABLES

11:49070 12:19665 24:47829 47:16338 11:01959 58:97390

TRIAL

NC. OF

TRIALS

```
13.46400
           -18.09600
1.952700
             3.549000
          -0.6850000
-0.3170000D-01
-0.1530000D-01
          -0.4160000D-01
-0.9060000D-02
             .79000000-01
             11.00000
             11.00000
             11.14900
             11.45700
             11.48700
             12.17600
             12.93700
27.56000
11.01700
            .58.46900
                                                                                 CHANGE IN DIRECTN
OF MOTION
                                LAST SUCCESSFUL
           CURRENT TRIAL VALUE OF
                                                          TOTAL DISTANCE
NC. OF
                                FUNCTIONAL
                                                                  MOVED.
                                                VALUE
TRIALS
                                                                                   FROM LAST
                                                                                                 STAGE
                                                           DURING STAGE
            IND VARIABLES
                                                            0.26883220-01
                                    C.5684940D-C6
                                                                                   0.1133980
   3820
              13.47005
             -18.09311
1.954576
             3.542860
0.6839622
            -0.3196166D-C1
-0.174735D-C1
-0.3912360D-C1
-0.5400372D-C2
             0.2307157
               11.00000
               11.00000
               11.10970
               11.38584
```

	•	4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4		10H 1H 1HTC	HOTOLINA IN THIER ELECTROSE REGION	ne Gron					
		Polication.		2.0	2,5	3.0	121	ò.	4.5	0	
0.0	٠	21.0	0.6495	0.5671	0.5062	0.45.0	0174.0	0.1895	0.3626	0.1591	
0000.1		FC 57 - 0	0.6121	0.5555	0.4976	0.1922	6.11.0	0,3146	0.35.05	0.1159	
0.9238		556.0	1414	0.5419	0.44.0	1644.0	0.40%	161520	2+51.0	0.1121	
0.0601		5007.0		1012	0.4001	0.4384	0.403.0	0.3748	0.3499	0.32 42	
0.808.8	B 0.7647	0.6758	70.0.0		0.44.05	41140	1.701	0.3699	0.3436	0.3244	
0.7590	0 .0.1250	~ 0.6342	9185.0	0.560		3 2 2 2 2	4. 197.1	0.3649	0.3412	0.3204	
0.7181	0.6969	0 • 6 100	0.5653	0.5072	0.4628			0.1599	0.1150	0. 1165	
0.6019	9 0.6554	0.6072	0.5455	0.4978	0.4541				4711.0	0.1126	
0.6456	6 0.6367	0.5854	0.5342	0.4845	0.4454	4014.0	0. 300 0	Brecto ,		4101.0	
0,6205	5 0.4045	0.5656	0.5154	0.4754	0.4360	0.40 15	0.3/./	96.5		10,00	
0.5042		0.5465	0.505.0	0.4645	0.4202	0.3965	0. 3602	0.3448	0.3235	* FQE . 0	
10/2/0		0.5245	0.4912	0.4539	16.14.0	0.3876	01.01.0	0,1397	0.31.91	0.100.	
	٠.	0.5115	0.4778	0.4434	0.4111	0.3827	0.3572	0.3347	0.3146	0.2968	
		0.4755	0.4650	0.4332	0.4031	0.1750	4157.0	3621.0	0.3102	0.2920	
		0.4002	0.4526	0.4232	0.1950	0.16.90	0.1450	0.3246	, 30°0¢,	. 0.29415	
		44.6	0.4406	0.4134	0.3869	1 2 91 . 0	V 46.6.0 .	0.3196	0. 101 J	6.2046	•
0.4413			1004.0	0.4019	0.1790	0.1556	1 * (F * 0	0.1146	0.2969	0.2408	
0.4740		•		100.00	0.3713	0.1440	0.3203	C. 3096	0.2475	0.2769	
0.4595	-	•		3 1 1	0.1640	0.1425	0.1220	6.3047	0.2051	0.2129	
0.445	1 0.4401	•	0.4013	200000	1881	0 - 1 - 161	0.3172	1 6.52.0	0.2937	0.26#9	
0.4314	4 0.4269	0	0.3970	10.0		7007	0.3117	0.2948	0.2791	0.2650	
0.4185	15 - 0.4144	0,4032	0.3870	2006.0			1000	0007.0	0.2149	0.2610	~
0 . 4 06 2	2 0 4025	•	0.3/73	0.3599	0.1415	0.1634	7005.0	1,11,0	0.2706	0.2571	
0.1946	6 0.3912	۰	0.1640	0.3517	0.1144	0.116	1005.0	. 046	0.2663	0.2532	
0. Ju 1	10.3804	•	0.1590	0.14.10	0.1275	2111.0		0-2206	0.2620	0.2492	
0.3729	1376.0 95	0, 3621	0.1503	0 • 3 16 0	0, 3207	1501.0	20.3.0	20,210	0.5011	0,2453	
0,3627	1 0.1602	0.1528	0, 14 10	0.1285	0, 1140	21.22		0.2661	0.25.14	0,2415	
0.3510	0.3506	0.3438	0.1136	0.3211	9 10 14	0.571		3615	0.2442	0.2376	-
HALLO /	17 0.3415	0.3352	0. 1256	0.11.0	0 1010	0.2076		2000	0.2470	0.2137	
0	17 0.3327	0.3260	0.3179	0.306.9	0.2.147	6182.0	7402.0		0.2408	6,72.0	
0.3261	61 0.3248	0.3187	0.3104	0.3000	0,240	0.2763	2 502 0		7 7 7 7 0	0.2201	
0.10 0.3178	0.1100	0.3104	0. 10 31	6142.0	0,2824	0.2708	0.6572		4136	10000	
	٠	[f o f · 0	0762.0	0.2869	0.2761	0.2654	0.2542	6.2432	0.6363	90 11.	•
V 101.40		0.2460	0.2491	0.21104	0.2705	4.26.01	6567.0	0.2300	6.22.45	6017.0	
9 . 2 . 9			0.2823	0.2742	0.26411	0.2548	0.2450	0.2344	0.274	0.10.0	
1.86.0			0.2750	0.2640	0.2571	9642.0	0117.0	0.2 500	0.22.04		
0.2800			0.2654	0.2620	01.25.16	0.2445	101210	0.2254	0.2164	6,02.0	
2015			0.2631	0.2562	0.2481	0.2.575	0.2304	0.2213	0.2124	0.2030	
			0.2570	0.2504	0,2420	0 , 2.145	0.2250	0.21/1	0.2024	5.2000	
0.10			0.2510	0.2448	0.2375	0.22.16	. 0.2213	C+2129.	0.2015	0.1.063	•
0.2600	00		:	,	•		•	•			

		٠.			,	•	.•				<u>.</u>	- - •	, i								· .·		,					-,4			, . ,	٠, ٠٠		,				<u>.</u> .,			44 11:	-,					ماست.	
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				,*				,									•	_	٠.				5	-	٠.	_		=			Ė	_	3				٠.	_	<u>.</u>		,						··.	.,.
		. •		•		.:	٠		0.1927	201.0	0.1855	t, 1020	10.110	0.1749	0.1/14	0.1679	0.1645	0.1811	0.1576	0.1543	0.1509	0.117	0.1442	0.1400	0.1376	0.1345	1111.0	0.7210	0.1246	0.1214	2981.0	0.1151	611170	0.104#	1401.0	0.0445	0.0764	0.0951	0.0701	0.0872	0.0ut;	0.0012	. 0.0702	71.200	0.0722	0.007	[99Ó*O	`
	•						, '		0.2000	0.1.168	0.1729	0.1451	0.1454	0.1816	0.111.0	0.1142	0.1700	0.1009	0.1611	0,1598	9.1562	1701.0	0.1442	1451.0	0.1124	0.1 100	0.1154	0.11.0	1871.0	8 621.0	0.1210	/n i 1 · 0	0.1154	0.1171	201.0	0.1325	0.00.01	0.0161	0.010.0	0.0398	0.0df. /	0.08.35	0.0104	\$//O'O	6.0743	0.0/12	0,0002	
							•	•	C. 2001	0.2046	0.2005	0.1964	1761 0	6.1004	9 1 1 1 4 5	5081.0	0.1767	0.117.0	0.1690	5.161.0	0.1015	0.151.0	0.1541.	0.1504	0.1460	0.1432	jet 1.0	C . 1 Jb.1	0.1126	0.1291	0.1257	2.221.3	0.1148	0,1154,	12110	4:01:0	0.1021	0.09110	0.0555	0.0923	0.00.0	950000	0.00.0	0.0704	0.0162	0.0731	6,00.0	
. .	•								0.2144	0.2124	0065.0	0.23.0	0.1373	0 - 1221	. 14.1.0	0.1860	1701.0	0.1704	0.1/1.0	0.1/04	0.1666	0.10.7	. vectio	uret.0	1 151 .0	0.14/2	. 01110	1001.0	0.1 to 1	3,1324	3.121.0	0.1250	1.777.0	0.1104	7	0.1002	0.101/	1101.0	0.60.0	0.0716		0.000.0	1.00.0	0.0414	10/0.0	ù.0/e.v	0.0/10	
	, , , , , , , , , , , , , , , , , , ,		,		,	•			. 0.55.0	0.2200	0,215.1	1017.0	. 1907.0	01.2016	1761.0	0.1921	0.1004	1101.0	66/110	14/11.0	91/110	. 1/01/0	0.16.14		4554.0	0.1515	0.1476	01110			0.1325	0.1248	•	<u> </u>			2201.0	71.01.0	, 7001.0	0.0768	1	* ******) sáporo	0,0832	, 8010.0	0.0705	0.0712	
				•					121210					0.2071	0.20 0	0.1781	0.1937	0.11072	0.1444	, ,0111.0	9.1761	0.1/10	0.1010	0 16 16 0	0 1561.0	0.1552 0	0:1515 0	0 7/11/0	0 71 117 0	0	0 . 5561.0		0 . 1.7.1.0		0.1204 0		0 1661.0		0.10/2	0.0747 0	0.0752 0	0 /1/.0.0	0 711110 0	0 01110	0.0014 0	0.0740	0 01400	
																,						0 042	_	•	•	_		-		_		_				,			,									
									0.2391	. •		Ī	0.2182	0.2111	6.2082	0.2011	0.1985	0.1938	0.1491	0.1040	10001	٠	0.1/11.	0,1669,	0.1626	0.1504	0.1542	0.1501	0.1461	0.1420	0.1341	0.131	7 OF 1 * O	0.1264	0.1226	0.1150	0.1111	0.1076	0.101.0	0.100	\$1960°0	0.0912	. 0.0497	0.0002	0.0027	0.0172	0.0757	
								•	0.2452	5567.0	0.2119	0.2244	0.22.10	0.2177	0.2126	0.7075	0.2025	0.1976	0.1928	0.1840	0+1834	0.1788	0.1742	0.1650	0.1654	0.1010	0.1564	0,1525	0.1464	0.1442	0.1402	0.1362	0.1322	0.1202	0.1265	0.1167	0.1129	0.1091	0.1054	1101.0	0.0701	0.0944	6040.0	0, (07)	0.00 17	7000*0	0.0767	
									0.245.0	0.2738	0.2300	0.2121	0.2267	0.2212	0.2157	U.2101	0.2055	0.2005	0.1755	0.1.00	0,1857	0.1411	0.1765	0.171.9	0.1074	0.1610	0.1587	0.1541	0.1501	0,1457	B 4 0	0.1111	9661.0	0.1296	3671.0	0.1179	0.1140	0.1162	5901.0	0.1027	0,00,0	0.0954	0.0117	0.0481	0.0845	0,0809	0.0174	
•								•	0.75.26	0.5465	0.7466	. 0.6347	0.110	0.2234	0.110	0.116	0.2074	0.1023	0.1572	0.71923	0.1874	0.1026	0.1117	0.1133	0.1667	0,1642	8331.0	0.1555	0.4512	0.1469	0.1427	0.1306	0.1345	0.1305	0.1223	0.1186	0.1147	6011.0	0.1071	0,1033	0.1556	6.550.0	0.0922	C.(etc	0,((50	0.CH14	0.6770	
									0.25.10	6.247.9	0.2414	0.2356	0.22.0	0.2242	0.2107	0.2111	0.2000	0.2024	B14.1.0	9.1524	0.1879	118110	0,1704	0.1717	0.1692	0.1047	0.1002	0.1550	9161.0	0.1473	0.1411	0 . 1 39.3	0 • 1 3 • 0	0.1307	1021.0	0.1149.	0.1150	0.1111	0.1071	95 01 10	0.0398	0.0961	0.0924	0.0888	2400:0	0.0416	0.0700	
								•	07.01	01 - 10	00.0	06.4	3. 10	5.70	00.0	5.50	5.40	5. 30	5.20	5.10	. 5.00	05.4	4.60	*. 73	4.60	000.4		4.30	4.20	4.10	٠٠٠	00	J. 40	. 2	90.1	1.40	1.33	1.70	. 3+10	1.00	7.90	7.40	2.10	4.60	4.50	5.40	o50	
	,		•																							•					-													•				
		•								-6	-		•		•															•									٠									

0.00.13	0.000	0,05/25	0,0546	0.0514	6.040.0	0,0450	6240.0	00 00 0	0.0372	0.0343	*110.0	0.0205	0.0251	0.0228	4610.0	0.0171	0.0142	0.0114	0.0005	0,0057	0.0020	•
0.0651	1790.0	. 1650.0		0.0531	1050.0		14.40.0	0.0411	0,0382	2510.0	0.0122	0.0291	0.0264	0.0214	0.0205	0.0175	0.0140	0.0117	0.0008	0.0058	0,0029	· •
0.0660	0.061/	9070.0	. 6160.0	0.0144	0.0413	0.0463	0.0452	C.0422	0.0391	0,0364	0.0310	0 00 0 0 0	0.0270	0,20,0	0.0210	0,0110	0.0150	0.110.0	0.00.0	. 0900*3	0.00.0	
*0.00.0	3.00.0	0.00.0	0.020	17.000	6750*0	0.00.0	3.040.0	15.0.0	0.040.0	6. of D . O	0.0110	0,0101	0.0270	0.00	40.00	,.014+	4410.0	7710.0	2.00.0	1 000 0	1100.0	
6630.0	0.3000	1100.0	1020.0	1105000	0.05 Jr	0.0.0	0,0412	0.040	0.0400	0,0377	3470.0	11100	2 H 2 O 1 O	. 0470-0	4120.0	9910.0	9610.0	0.0125	******	0.0062	1100.0	
0.0712	17.00.0	400.0	21.00.0	. 77.00.0	9440	6150.0	10.00	11440	\$1.40°0		11100	10000	2150.0	0.02.15	0.0233	5770.0			20000	******	2000	
	0.0163	7 .000.0	0.000	0.0521	000000	5 5 5 5	1350.0		0.040.0	0.0462	,nrn o'	0.0356	0.0324	0.0291	0.0298	0,0220	4610.0	0.0161	0.0127	1600.0	*200.0	0.00.0
	0.0732	0.0690	0.0663	0.0629	0.0550	1950.0	0.0527	0.00	0.0460	0.0427	0.0104	0.6360	0.0327	0.0254	0.0261	0.0229	0.0156	0.0163	01 10	0.00%	.000.0	0.0039
	0.079	0.010	0.0000	0.00.15	0000.	0,000,0	0.0512	0.0494	0.0464	0.04.10	. 150.0	(910.0	0,00.0	1620'0	0.0204	0.0231	0.0158	0.0165	0.0132	0.0000	0.0066	0.0015
	0.0743	0.0708	0.0613	0.0630	0.0003	0.0509	0.0035	1050.0	0.0467	0.6433	9510.0	0.0365	0.0112	0.0248	0.0265	0.0232	0,010,0	0,0165	0,6132	0.0000	0,0046	0.003
-	0.0744	0.010.0	0.06/4	0.0639	0.0604	0.0570	0.0536	0.0501	0.044.7	0.6433	00.000	0.0300	2110.0	6.020.0	0,6205	0,0232	6610.0	0,0166	0.0132	6.00.0	0.0006	0.0013
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THE BOUNDARY DISTRIBUTION ON SPHERICAL PORTION

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10.08	0.3827	1.0002
10-11	0.4540	1.0003
10.15	0.3225	1.0003
10-19	0.5878	1.0004
10.24	10-6494	1.0004
10-29		1.0004
10.35	0.7604	1.0004
10.41	0.8090	1.00,04
10.48	0.8525	1.0004
<u> </u>	0.8910	1.00.03
10.55		1.0003
10.62	0.9239	
10.69	0.9511	1.0004
10.77	0.9724	1.0005
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POLENTIAL DISTRIBUTION ALUNG THE SMICHICAL PANT UF THE BAMBARY

APPENDIX 3

This table contains utilization factors (U-F) and values of maximum field (Fmax) for different Gap-Length/point -radius ratios (G/R).

· <u>G/R</u>	U-F	Fmax	G/R	U-F	Fmax .
0.1	0.95845	10.43353	21.0	0.06363	0.74838 ·
0.2	0.89633	5 . 57827	22.0	0.06112	0.74365
0.3	0.83866	3.97462	23.0	0.05882	0.73923
0.4	0.78732	3.17532	24.0	0.05668	0.73507
0.5	0.74158	2.69693	. 25.0	0.05471	0.73115
0.6	0.70061	2.37889	26.0	0.05287	0.72745
0.7	0.66371	2.15240	27.0	0.05116	0.72394
0.8	0.63035	1.98301	28.0	0.04956	0.72061
10.9	0.60009	1.85159	29.0	0.04806	0.71745
1.0	0. <i>5</i> 7253	1.74663	30.0	0.04666	0.71443
.2.0	0.39270	1.27322	31.0:	0.04534	0.71155
3.0	0.30046	1.10940	32.0	-0.04409	-0.70879
4.0	0.24448	1.02259	33.0	0.04291 •	0.70616
≈ 5.0	0.20678	0.96720	34.0	0.04180	0.70363
6.0	0.17960	0.92800	35.0	0.04075	0,70120
7.0	0.15902	-0.89837	36.0	0.03975	0,69887
8.0	0.14287	0.87492	37.0	- 0.03880	0.69662
9.0	0.12984	0.85575	38.0	0.03789	4.69445
10.0	0.11909	0.83967	39.0	0.03703	/0.69237
11.0	0,11007	0.82592	40.0	0.03621	0.69035
12.0	0.10238	0.81397	41.0	0.03543	0.68840
13.0	0.09574	0.80345	42.0	0.03468	0.68651
14.0	0.08995	0.79408	43.0	0.03397	0.68469
15.0	0.08485	0.78567	44.0	0.03328	0.68292
16.0	0.08033	0.77806	45.0	0.03262	. 0.68120
17.0	0.07628	0.77111	46.0	0.03199	0.67954
	•	0.76475		0.03138	ૂ.67792
		0.75887	48.0	0.03080	o.67635
20.0	0.06636	0.75344	49.0	0.03024	0.67483
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G/R	· U-F	Fmax	G/R	U-F	Fmax
50.0	0.02970	0.67334	86.0	0.01825	0.63687
51.0	00.02918	0.67189	87.0	0.01807	0.63616
52.0	0.02868	0.67048	88.0	0.01788	0.63546
53.0	0.02820	0.66911	39.0	0.01770	0.63476
54.0	0.02773	0.66777	90.0	0.01752	0.63408
55.0	0.02728	0.66646	91.0	0.01735	0.63341.
56.0	·0.0268 <i>5</i>	0.66519	92.0	0-01718	0.63275
57.00	0.02642	0.66394	93.0	0.01701	0.63209
` <i>5</i> 8.0	0.02602	0.66273	94.0	0.01685	0.63145
59.0	0.02562	0.66154	95.0	0.01669	0.63081
60.0	0.02524	0.66037	96.0	0.01653	0.63018
61.0	0.02487	0:65924	97.0	.0.01638	0.62956
62.0	0.02451	0.65812	98.0	0.01622	0.62895
63.0	0.02416	0.65703	99.0	0.01608	0.62835
64.0	0.02382	0.65596	100.0	0.015934	0.62775
65.0	0.02349	0.65492	101.0	0.01579	0.62716
66.0	0.02317	0.65389	102.0	0.01565	0.62658
67.0	0.02286	0.65289	103.0	0.01551	0.62601
68.0	0.02256	0.65191	104.0	0.01537	0.62544
69.0	0.02226	0.65094	105.0	0.01524	0.62488
70.0	0.02198	- 0.64999	106.0	0.01511	0.62433
71.0	0.02170	0.64906	107.0	0.01498	0.62378
72.0	0.02143	0.64815	108.0	0.01486	0.62324
73.0	0.02116	0.64725	109.0	0.01473	0.62271
74.0	0.02091	0.64637	110.0	0.01461	0.62218
75.0	G.02066	0.64550	111.0	0.01449	0.62166
76.0	0.02041	0.64465	112.0	0.01437	0.62115
77.0	0.02017	0.64382	113.0	0.01426	0.62064
78.0	0.01994	0.64299	114.0	0.01415	0.62013
79.0	0.01971	0.64219	115.0	0.01403	0.61963
80.0	0.01949	0.64139	116.0	0.01392	0.61914
81.0	0.01927	0.64061	117.0	0.01382	0.61865
82.0	0.01906	0.63984	118.0	0.01371	0.61817
83.0	0.01885	0.63908	119.0	0.01360	0.61770
84.0	0.01865	0.063833	120.0	0.01350	0.61722
85.0	0.01845	0.063760	121.0	0.01340	0.61676
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G/R	U-F	Fmax	G/R	U-F	Fmax
122.0	0.01330	0.61629	158.0	0.01051	0.60226
123.0	0.01320	0.61584	159.0	0.01045	0.60193
124.0	0.01310	0.61538	160.0	0.01039	0.60160
25.0 ليس	0.01301	0.61494	161.0	0.01033	0.60128
126.0	0.01292	0.61449	162.0	0.01027	0.60095
127.0	0.01282	0.61405	163.0	0.01021	0.60063
128.0	0.01273	0.61362	164.0	. 0.01016	, 0.60031
129.0	0.01264	0.61319	165.0	0.01010	.0.60000
130:0	0.01255	0.61276	166.0	0.01005	0.59968
131.0	0.01247	0.61234	167:0	0.00999	0,59937
132.0	0.01238	0.61192	168.0	0.00994	0.59906
133.0	0.01230	0.61151	169.0	0.00988	0.59876
134:0	0.01221	0.61110	170.0	0.00983	0.59845
135.0	0.01213	0.61069	171.0	0.00978	0.59815
136.0	0.01205	0.61029	172.0	0.00972	0.59785
137.0.	0.01197	0.60989	173.0`	0.00967	0.59755
138.0	0.01189	0.61949	174.0	0.00962	0.59726
139.0	0.01181	0.60910	175.0	0.009 <i>5</i> 7	o <u>.</u> 59696
140.0	0.01173	0.60871	176.0	0.00952.	0.59667
141.0	0.01166	- 0.60833	177.0	0.00947	0.59638
142.0.	0.01158	0.60794	178.0	0.00942	0.59609
143.0	0.01151	0.60757	179.0	.0.00938	0.59581
144.0	0.01144	0.60719	180.0	0.00933	0.59552
145.0	0.01137	`0.60682	181.0	0.009.28	0.59524
146.0	0.01129	0.60645	182.0	0.00924	0.59496
147.0	0.01122	0.60609	183.0	0.00919	0.59468
148.0	0.01115	0.60572	184.0	JO.00914	0.59441
149.0	0.01109	0.60537	185.0	0.00910	0.59413
150.0	0.01102	0.60501	186.0	0.00905	
151.0	0.01095	0.60466	187.0	0.00901	0.59359
132.0	0.01089	0.60431	. 188.0	0.00897	0.59332
153.0	0.01082	0.60396	189.0	0.00892	- 0 - 5930 5
154.0	0.01076	0.61361	190.0	0.00888	
155.0	0.01069	0.60327	191.0	0.00884	
156.0	0.01063		192.0		
157.0	0.01057	0.60260	193.0	0.00875	0.59200

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		-193-			Fmax
G/R	U-F	Fmax	<u>G/R</u>	0.00742	0.58319
194.0.	0.00871	0.59174	231.0	0.00739	0.58298
195.0	0.00867	0.59149	232.0	0.00736	0.58277
•	0.00863	0.59123	233.0	0.00734	0.58257-
•	0.00859	0.59098	234.0	0.00731	0.58236
198.0	0.00855	0.59073	235.0	0.00728	0.58216
199.0	0.00851	.0.59048	236.0	0.00725	0.58196
200.0	0.00847	0.59023	237.0		0.58176
201.0	0.00843		· 238.0	0.00722	0.58156
202.0	0.00839	0.58973	239.0	0.00719	0.58136
203.0	0.00836	0.58949	240.0	0.00717	0.58116
204.0	ò.00832	0.58925	241.0	0.00714	
205.0	0.00828	0.58900	242.0	0.00711	0.58096
206.0	0.00825	0.58876	243.0	0.00709	0.58077
207.0	0.00821	0.58852	244.0	0.00706	0.58057
208.0	0.00817	0.58829	245.0	.0.00703	0.58038
209.0	0.00814	0.58805	\246.0	0.00701	0.58018
210.0	0.00810	0.58782	577.0	0.00698	0.57999
211.0	0.00807	0.58758	248.0	0.00695	0.57980
212.0	0.00803	0.58735	\$49.0	0.00693	0.57961
213.0	0.00800	0.58712	250.0	0.00690	0.57942
214.0	0.00796	0.58689	251.0	0.00688	0.57923
215.0	0.00793	0.58666	252.0	0.00685	0.57905
216.0	. 0.00789	0.58644	253.0	0-00683	0.57886
217.0	0.00786	0.58621	254.0	0.00680	0.57867
218.0	. 0.00783	0.58599	255.0	0.00678	0.57849
. 219.0	0.00780	0.58577	256.0	0.00675	0.57830
220.0	0.00776	0.58555	257.0	0.00673	0.57812
221.0	0.00773	0.58532	258.0		0.57794
222.0	0.00770	0.58511	259.0	0.00668	0.37776
223.0		0.58489	260.0	0.00666	0.57758
224.0	0.00764	0.58467	261.0	0.00664	0.57749
225.0		0.58446	262.0	0.00661	0.57722
226.0		-9.58424	263.0	o ∻ 00659	0.57704
227.0		0.58403	264.0	0.00657	0.57686
228.0		0.58382	265.0	0.00654	0.57669
229.0	- 1 0	0.58361	266.0	0.00652	0.5765
230.0			267.0	0.00650	0.5763
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<u>G/R :</u>	<u> </u>	<u>Fmax</u>	<u>G/R</u> 304.0~	0.00577	0.57038
268.0	• · - · ·		305.0	0.00575	0.57023
. 269.0	0.00645		-	0.00573	0.57008
270.0	0.00643	0.57582	307.0	0.00572	0.56993
271.0	0.00641	0.57565	308.0	0.00570	q.56979
272.0	0.00639	0.57548	309.0	0.00568	0.56964
273.0	0.00637	0.57531	310.0	0.00566	0.56949
274.0	0.00635	0.57514 0.57497	311.0	0.00565	0.56935
275.0	0.00632	the state of the s	312.0	0.00563	0.56920
276.0	0.00630	0.57480 0.57483	313.0	0.00561	0.56906
277.0	0.00628	0.57447	314.0	0.00560	0.56892
278.0	0.00626	0.57430	315.0	0.00558	0.56877
279.0	0.00624	0.57414	316.0	0.00557	0.56863
280.0	0.00622	0.57397	317.0	0.00555	0.56849
281.0	0,00620		318.0	0.00553	0.56835
282.0	0.00618	0.57381	319.0	0.00552	0.56821
283.0	0.00616	0.57364	320.0	0.00550	0,56807
284.0	0.00614	0.57348	321.0	0.00549	0.56793
285.0	0.00612	0.57332	322.0	0.00547	0.56779
286.0	,	0.57316	323.0	0.00545	0.56765
287.0		0.57300 0.57284	324.0	0.00544	0.56751
288.0	:	0.57268	325.0	0.00542	0.56737
289.0	/ - 0	0.57252	326.0	0.00541	0.56724
290.0		0.57237	327.0	0.00539	0.56710
291.0		0.57221	328.0	0.00538	0.56696
292.0		0.57205	329.0	0.00536	0.56683
293.		0.57190	330.0	0.00535	0.56669
294.		واجمع مصم	331.0	0.00533	0.56656
295.			332.0	0.00532	0.56642
296.			333.0		0.56629
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				- 47,5			
. .				-	G/R	U∸F	Fmax
	•	G/R	U-F	Fmax 0.56537	376.0	0.00474	0.56096
•		J. 4		.56524		0:00473	0.56084
		•		5.56511	378.0		0.56073
	,	_	,	0.56498	379.0	_	0.56061
•				0.56485	380.0	0.00470	o.56050
•	•	•		0.56472	381.0	0.00468	0.56039
				0.56459	382.0	0.00467	0.56027
	•	•		0.56447	383.0	0.00466	0.56016
	ſ			0.56434	384.0	0.00465	0.56005.
	,		0.00509	0.56421	385.0	0.00464	0.55994
			0.00508	0.56409	386.0	0.00463	0.55982
			0.00507	0.56396	387.0	0.00462	0.55971
		JJ	0.00505	0.56384	388.0	0.00461	0.55960
		JJ	0.00405	0.56371	389.0	0.00459	0.55949
			0.00503	0.56359	390.0	0.00458	0.55938
		354.0	0.00501	0.56347	391.0	0.00457	0.55927
	*	355.0	0.00500	0.56334	392.0	0.00456	0.55916
,	•	356.0	0.00499	0.56322	393.0	0.00455	0.55905
	•	357.0	0.00497	0.56310	394.0	0.00454	0.55894
	•	358.0	0.00496	0.56297	395.0	0.00453	0.55883
		359.0	0.00495	0.56285	396.0	0.00452	0.55872
		360.0	0.00494	0.56273	397.0	0.00451	0.55862
;	•	361.0	0.00492	0.56261	398.0	0.00450	0.55851
	/	362.0	0.00491	0.56249	399.0	0.00449	0.55840
		363.0	0.00490	0.56237	400.0	0.00478	0.55829
-		364.0	0.00489	a: 56225	*	0.00447	0.55819
٠		365.0	0.00487	0.56213	-	0.00446	0.55808
		366.0	0.00486	0.56201		0.00445	0.55797
		367.0	0.00485	0.56189		0.00444	0.55787
		368.0	0.00484	0.56178		0.00443	0.55776
		369.0	0.00482	0.56166		1.1.0	0.55766
		370.0	0.00481	0.56154		1.1.4	0.55755
		371.0	0.00480	0.5614		و با نام و ا	0.55745
		372.0	0.00479	0.5613	•	1: 00	1 '
		373.0				1-00	
		374.0		_			
		375.0	0.00475	0.5010	,		
•		•		•			
		•		•			

			•		3
G/R_	<u>U-F</u>	<u>Fmax</u>	<u>G/R</u>	U-F	Fmax .
412.0	0.00436	0.55703	448.0	0.00403	0.55349
413.0	0.00435	0.55693	749.0	0.00402	0.55340
414.0	0.00434	0.55682	450.0	0.00402	0.55331
415.0	0.00433	0.55672	451.0	0.00401	0.55321
416.0	0.00432	0.55662	452.0	0.00400	0.55312
417.0	0.00431	0.55652	453.0	0,00399	0.55303
418.0	0.00430	0.55642	454.0	0.00398	0.55294
419.0	0.00429	0.55631	455.0	0.00398	0.55284
420.0	0.00428	0,55621	456.0	0.003977.	0.55275
. 421.0	0.00427	0.55611	457.0	0.00396	0.55266
422.0	0.00426	0.55601	458.0	0.00395	0.55257
423.0	0.00425	0.55591	459.0	0.00394	0.55248
424.0	0.00424 .	q. 55581	460.0	0:00394	0.55239
425.0	0.00423	-0 55571	461.0	0.00393	0.55230
426.0	0.00422	0 55561	462.0	0.00392	0.55221
427.0	0.00422	55551	463.0	0.00391	0.55212
428.0	0.00421	0\55541 ·	464.0	0.00390.	.0.55203
429.0	0,00420	0.\55532	465.0	0.00390	0.55194
430.0	0.00419	0.35522	466.0	0.00389	0.55185
. 431.0	0.00418	0.55512	467.0	0.00388	0.55176
432.0	0.00417	0.55502	468.0	0.00387	0.55167
433.0	0.00416	0.55492	469.0	0.00387	0.55158
434.0	0.00415	0.55483	470.0	0.00386	0.55149
435.0	0.00414	0.55473	471.0	0.00385	0.55140
436.0	0.00414	0.55463	472.0 /	0.00384	0.55132
437.0	0.00413	0.55454	473,8	0.00384	0.55123
438.0	0.00412	0.55444	474.0	0.00383	0.55114
439.0	0.00411	0.55434	475.0	0.00382	0.55105
740.0	0.00410	0.55425	476.0	0.00381	0.55097
441.0	0.00409	0.55415	477.0	0.00381	0.55088
442.0	0.00408	0.55406	478.0	0.00380	0.55079
443.0	0.00407	0.55396	479.0	0.00379	0.55071
ليلبك.0	0.00407	0.55387	480.0	0.00378	0.55062
445.0	0.00406	0.55377	481.0	0.00378	0.55053
446.0	0.00405	0.55368	482.0	0.00377	0.55045
447.0	0.00404	0.55359	483.0	0.00376	0.55036
					-

G/R	U-F	Fmax_
484.0	0.00375	0.55028
485.0	0.00375	0.55019
486.0	0.00374	0.55011
487.0	0.00373	0.55002
·488.0	0.00373	0.54994
489.0	0.0037,2	0.54985
490.0	0.00371	0.54977
491.0	0.00371	0.54969
492.0	0.00370	0.54960
493.0.	0.00369	0.54952
494.0	0.00368	0.54944
495.0	0.00368	0.54935
496.0	0.00367	0.34.927
497.0	0.00366	0.54919
498.0	0.00366	0.54910
499.0	0.00365	0.54902
500.0	0.00364	0.54894
501.0	0.00364	0.54886

Note: This table is derived using the conventional charge. simulation technique for one set of charge positions (r_1', z_1') . For better accuracy, the values of U-F and Fmax for G/R \langle 1.0, should be calculated individually using the optimized charge simulation technique.

APPENDIX 4

ANALYSIS OF THE PHOTOMULTIPLIER RESULTS

The photomultiplier (PM) results were initially interpreted on the basis of similar traces obtained in temporal growth measurements of pre-breakdown coronas (16). However, the absence of a current pulse corresponding to the last PM pulse (Figure 5.13) and Dale's (84) suggestion of saturation of the PM tube, led to a further analysis of the PM traces.

In pre-breakdown measurements, the space charge travels to the electrode of the opposite polarity under the force of the applied field, and recombination will generate a relatively broad pulse after a time depending on the distance of the space charge from the electrode and the diffusion velocity of the Under the present conditions, at the time charge carriers. of the first PM peak the impulse voltage collapses to zero and the electrostatic forces acting on the charge carriers are mainly of two types. First, electrostatic forces acting in the volume of the gas and second, forces acting on the image charges on the surface of the grounded electrodes and surrounding walls. Drift forces produced by electric wind will also be present Apart from these but their effect is not clearly understood. directional forces, the gas molecules in the neighborhood of the discharge are forced into random motion with kinetic energies related to the temperature of the spark channel and the thermal conductivity of the gas.

The recombination will therefore take place in the

volume of the gas, as well as on the grounded electrode and walls of the chamber. There are two major types of recombination

- (1) Electron Ion recombination.
- (2) Ion -Ion recombination.

In an inert gas like nitrogen the recombination processes are mainly of type (1). In electronegative gases such as SF_6 or SF_6/N_2 mixtures, both types are expected to be present.

In the gas volume, recombination between ions of opposite charge has been found to be more efficient than that of an electron with a positive ion. The electrons due to their low mass move faster than the ions and this reduces the probability of their capture. The negative and positive ions have approximately the same mass and charge, and move with relatively low diffusion speeds. This increases the interaction time and the probability of the electron exchange between the two is quite high.

At the surface of the electrodes, the efficiency of the electron-ion recombination is probably the highest, due to the two dimensional diffusion of the ions and the high energy absorption of the solid surface. However, diffusion of ions to the electrodes is governed by the ambipolar diffusion in the volume of the gas. This depends on the number and position of the positive and negative ions with respect to each other and the electrode surfaces. Assuming that the two different charge carriers are uniformly distributed and have equal numbers, the recombination processes are principally of the ion - ion type and follow an exponential decay (30). In the presence of a space charge with uneven distribution and number of opposite polarity carriers, the type and rate of recombination becomes unpredictable.

Furthermore, the monitoring of the light emitted from the gap region will not give a true picture of the recombination rate since some reactions do not involve photon emission.

Therefore, on the basis of the limited information provided by the PM traces one had little alternative but to identify the last pulse as light emitted from the recombination process, which was thought to occur at the surface of the elec-Dale however, in a discussion with the author, pointed trodes. out that he had obtained similar photomultiplier results from breakdown of rod-plane gaps in air. In his experiments Dale used a streak camera simultaneously with the photomultiplier and compared the results. The time of streak t with respect to the PM output is shown in Figure D.1 (c). the PM current dropped sharply within the time ts, while the streak photographs showed a constant light intensity. led Dale to believe that the photomultiplier was saturating in some way, and that the final broad pulse was also a saturation He explained the sharp drop of the first peak by assuming that the high illumination of the PM cathode creates a space charge above the cathode, which choke's further electron emission to the dynodes and reduces the PM signal. Not being able to explain the origin of the so called recombination pulse he tried to eliminate it by inserting neutral filters in front The reduction of the light did not result of the PM cathode. in a disappearence of the peak as one would have expected, but rather in a shift to shorter times of appearance.

A number of tests were also conducted by the author to test the present PM system for saturation. A light emitting

diode was placed close to the PM cathode and a square wave signal of variable frequency was applied across it. The input voltage to the diode and the output current of the photomultiplier are shown in Figure D.1 (a) and D.1 (b) respectively. At low light intensities the input and output signals were

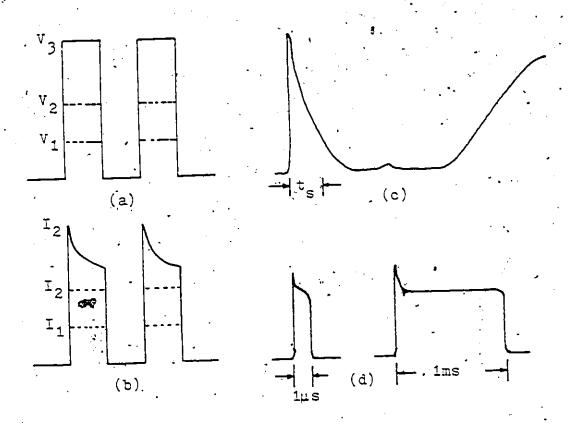


Figure D.1. (a) Voltage input to the light emitting diode (LED), $V_3 V_2 V_1$. (b) Photomultiplier current corresponding to different illumination intensities of the LED. (c) Photomultiplier trace and relative streak photograph duration. (d) Photomultiplier current for single light pulses (note that no secondary peaks are observed).

identical. As the intensity of the LED increased further, the PM output current did not respond accordingly, thus showing signs of saturation; and, for both repetitive and single pulses of light (Figure D.1 (d)), no secondary pulse similar to that of

Figure D.1 (c) was observed. In another test, the pin-hole regulating the light received by the photomultiplier cathode was made smaller. In reducing the diameter from 100 to 50 microns the magnitude of both peaks decreased considerably and the second pulse appeared at shorter intervals. In reducing the appearance ture to 10 microns the PM signal became compatible to noise in the system and while the second peak disappeared, the initial peak associated with the leader and main stroke resembled transient noise.

In conclusion, it is believed that the last broad pulse is in fact due to some type of photomultiplier saturation. It seems that the level of the PM signal at saturation free conditions is of the same order as the noise picked up by the anode of the photomultiplier and the signal cable. Hence, observation of any actual post breakdown activity under these conditions is extremely difficult.

The photomultiplier results were helpful in suggesting that the ionization mechanism operative in mixtures with a small trace of SF_6 was different from that of pure N_2 or pure SF_6 . As shown in Figure 5.14(b) the luminosity of the coronas increased with the addition of 0.05% of SF_6 , and at the pressure range where the voltage maximum occured (around 2 bar) the luminosity of the spark channel also increased. Photographic evidence in agreement with this, showed that corona streamers not only increased in luminosity, but they also appeared to surround the cylindrical part of the electrode. Similarly, the higher luminosity at the point of breakdown was the result

of the longer spark due to the creep phenomenon of the discharge. In addition, the photomultiplier traces provided an accurate measurement of the time lag between the corona pulse and spark onset.

VITA AUCTORIS

Born January 1951 in Athens Greece.

Completed primary education in Athens. Moved to Sydney
Australia in 1963 and attended the Bondi Junction High School
(forms 1 to 4). Returned to Greece in 1967 and in 1968 graduated from Officers Hill High School - Athens. In 1969 moved back to Melbourne Australia and in 1973 graduated from the Royal Melbourne Institute of Technology with a B.Sc. in Applied
Physics:

Joined Medtron Electronics Inc. as a project engineer in January 74 until May 1974 when moved to Windsor - Canada.

Graduated from the University of Windsor with a M.Sc degree in Physics in June 1975.

Joined the high voltage group of the Electrical Engineering Department in June 1975, candidate for a Ph.D degree in January 1978.